

# TLIN1431-Q1 Automotive LIN SBC with Integrated High-Side Switch and Watchdog

## 1 Features

- AEC-Q100 (Grade 1): Qualified for automotive applications
- [Functional safety-capable](#)
  - [Documentation available to aid functional safety system design](#)
- Local interconnect network (LIN) physical layer specification LIN 2.2A, ISO 17987–4:2016 and SAE J2602:2021 compliant
- Integrated watchdog supervisor configurable by pin or serial peripheral interface, SPI
- Enhanced features supporting 12-V applications
  - $\pm 58$  V LIN bus fault protection
  - 3.3 V (TLIN14313-Q1) or 5 V (TLIN14315-Q1) LDO output supporting 125 mA from 12 V supply
  - High-side switch with open load and short circuit detection controlled by 10-bit PWM or timer
  - LIMP pin configurable as a high-side switch
  - Configurable WAKE pin supporting different input thresholds or methods
  - Sleep mode: ultra-low current consumption allows wake up event from:
    - LIN bus
    - Local wake up through WAKE
      - Cyclic and static sensing
- Protection Features:
  - ESD protection
  - Under voltage protection on  $V_{SUP}$  and  $V_{CC}$
  - TXD dominant time out (DTO) protection
  - Thermal shutdown protection
- Integrated battery voltage monitor
- Available in leadless QFN (20) package with improved automated optical inspection (AOI) capability

## 2 Applications

- [Body electronics and lighting](#)
- [Hybrid, electric and powertrain systems](#)
- [Infotainment and cluster](#)
- [Appliances](#)

## 3 Description

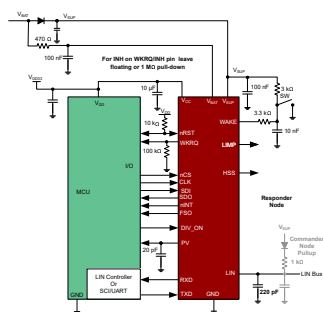
The TLIN1431x-Q1 is a local interconnect network (LIN) system basis chip (SBC) that integrates a watchdog, high-side switch, limp home capability and highly configurable WAKE input pin. The device self-determines the control method, pin or serial peripheral interface (SPI), at power up. The watchdog defaults to a window watchdog for both control methods but for flexibility the device can be configured as a window or timeout watchdog with greater than 20 different time windows when SPI control is used.

The LIN transceiver provides a 200 kbps fast mode for end of line programming. A high-side switch with diagnostic capability is provided for on board LED. The highly configurable WAKE pin can be used with the high-side switch for cyclic sensing, thus, reducing the ECU sleep current. The WKQR/INH pin can be configured for a digital wake output (WKQR) or a VSUP based inhibit (INH) enable pin for an external supply.

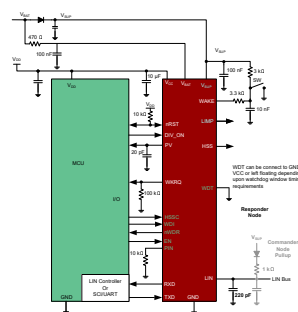
### Device Information

| PART NUMBER  | PACKAGE <sup>(1)</sup> | BODY SIZE (NOM)   |
|--------------|------------------------|-------------------|
| TLIN1431x-Q1 | VQFN (RGY)(20)         | 4.50 mm x 3.50 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Simplified Schematics, SPI Control



Simplified Schematics, Pin Control



## Table of Contents

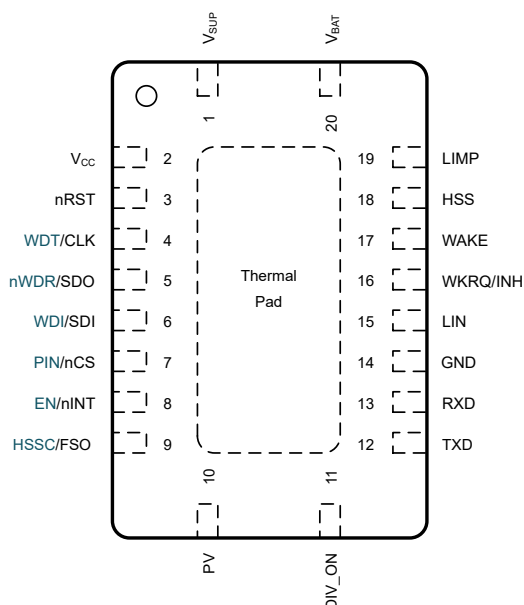
|                                                  |           |                                                                  |            |
|--------------------------------------------------|-----------|------------------------------------------------------------------|------------|
| <b>1 Features</b> .....                          | <b>1</b>  | 8.2 Functional Block Diagram.....                                | <b>23</b>  |
| <b>2 Applications</b> .....                      | <b>1</b>  | 8.3 Feature Description.....                                     | <b>24</b>  |
| <b>3 Description</b> .....                       | <b>1</b>  | 8.4 Device Functional Modes.....                                 | <b>49</b>  |
| <b>4 Revision History</b> .....                  | <b>2</b>  | 8.5 Programming.....                                             | <b>65</b>  |
| <b>5 Pin Configuration and Functions</b> .....   | <b>3</b>  | 8.6 Registers.....                                               | <b>69</b>  |
| <b>6 Specifications</b> .....                    | <b>4</b>  | <b>9 Application and Implementation</b> .....                    | <b>90</b>  |
| 6.1 Absolute Maximum Ratings.....                | <b>4</b>  | 9.1 Application Information.....                                 | <b>90</b>  |
| 6.2 ESD Ratings.....                             | <b>4</b>  | 9.2 Typical Application.....                                     | <b>91</b>  |
| 6.3 ESD Ratings, IEC Specification.....          | <b>4</b>  | 9.3 Power Supply Recommendations.....                            | <b>96</b>  |
| 6.4 Recommended Operating Conditions.....        | <b>5</b>  | 9.4 Layout.....                                                  | <b>97</b>  |
| 6.5 Thermal Information.....                     | <b>5</b>  | <b>10 Device and Documentation Support</b> .....                 | <b>99</b>  |
| 6.6 Power Supply Characteristics.....            | <b>5</b>  | 10.1 Documentation Support.....                                  | <b>99</b>  |
| 6.7 Electrical Characteristics.....              | <b>7</b>  | 10.2 Receiving Notification of Documentation Updates.....        | <b>99</b>  |
| 6.8 AC Switching Characteristics.....            | <b>11</b> | 10.3 Support Resources.....                                      | <b>99</b>  |
| 6.9 Typical Characteristics.....                 | <b>14</b> | 10.4 Trademarks.....                                             | <b>99</b>  |
| <b>7 Parameter Measurement Information</b> ..... | <b>15</b> | 10.5 Electrostatic Discharge Caution.....                        | <b>100</b> |
| 7.1 Test Circuit: Diagrams and Waveforms.....    | <b>15</b> | 10.6 Glossary.....                                               | <b>100</b> |
| <b>8 Detailed Description</b> .....              | <b>22</b> | <b>11 Mechanical, Packaging, and Orderable Information</b> ..... | <b>100</b> |
| 8.1 Overview.....                                | <b>22</b> |                                                                  |            |

## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision * (May 2022) to Revision A (December 2022)                         | Page     |
|------------------------------------------------------------------------------------------|----------|
| • Changed the data sheet from <i>Advanced Information</i> to <i>Production</i> data..... | <b>1</b> |

## 5 Pin Configuration and Functions



**Figure 5-1. RGY Package, 20-Pin QFN  
(Top View)**

**Table 5-1. Pin Functions**

| PIN              |     | TYPE | DESCRIPTION                                                                                                                                                       |
|------------------|-----|------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME             | NO. |      |                                                                                                                                                                   |
| V <sub>SUP</sub> | 1   | I    | Device supply voltage (connected to battery in series with external reverse blocking diode)                                                                       |
| V <sub>CC</sub>  | 2   | O    | Output voltage from integrated voltage regulator                                                                                                                  |
| nRST             | 3   | I/O  | Reset input/output (active low)                                                                                                                                   |
| WDT/CLK          | 4   | I    | Pin control: WDT - Programmable watchdog window set input (3 levels)<br>SPI control: CLK - SPI clock input                                                        |
| nWDR/SDO         | 5   | O    | Pin control: nWDR - Watchdog failure output trigger<br>SPI control: SDO - SPI serial data output                                                                  |
| WDI/SDI          | 6   | I    | Pin control: WDI - Watchdog timer trigger input active on both rising and falling edges (Must be driven at all times)<br>SPI control: SDI - SPI serial data input |
| PIN/nCS          | 7   | I    | Pin or SPI control selection pin at power up.<br>Pin control: does not change<br>SPI control: nCS - SPI chip select (active low)                                  |
| EN/nINT          | 8   | I/O  | Pin control: EN - Device mode change input pin<br>SPI control: nINT - Device interrupt output pin                                                                 |
| HSSC/FSO         | 9   | I/O  | Pin control: HSSC - High side switch control input pin<br>SPI control: FSO - Function output pin                                                                  |
| PV               | 10  | O    | Internal V <sub>BAT</sub> voltage divider output                                                                                                                  |
| DIV_ON           | 11  | I    | Input to turn on the internal V <sub>BAT</sub> voltage divider, active high                                                                                       |
| TXD              | 12  | I    | TXD input interface to control state of LIN output                                                                                                                |
| RXD              | 13  | O    | RXD output interface reporting state of LIN bus voltage                                                                                                           |
| GND, Pad         | 14  | —    | Ground                                                                                                                                                            |
| LIN              | 15  | I/O  | LIN bus single-wire transmitter and receiver                                                                                                                      |
| WKRQ/INH         | 16  | O    | Digital output for wake or high voltage inhibit output depending upon state of pin at power up                                                                    |
| WAKE             | 17  | I    | High voltage local wake up (LWU) pin                                                                                                                              |
| HSS              | 18  | O    | High side switch                                                                                                                                                  |
| LIMP             | 19  | O    | Used for LIMP home, watchdog event causes this pin to switch V <sub>SUP</sub>                                                                                     |
| V <sub>BAT</sub> | 20  | I    | Supply voltage divider sense input (connected to battery)                                                                                                         |

## 6 Specifications

### 6.1 Absolute Maximum Ratings

Over recommended operating range (unless otherwise noted)<sup>(1)</sup>

|                                |                                           | MIN  | MAX                             | UNIT |
|--------------------------------|-------------------------------------------|------|---------------------------------|------|
| $V_{SUP}$                      | Supply voltage range (ISO/DIS 17987)      | -0.3 | 42                              | V    |
| $V_{BAT}$                      | Battery sense input                       | -24  | 42                              | V    |
| $V_{LIN}$                      | LIN Bus input voltage (ISO/DIS 17987)     | -58  | 58                              | V    |
| $V_{CC50}$                     | Regulated 5 V Output Supply               | -0.3 | 6                               | V    |
| $V_{CC33}$                     | Regulated 3.3 V Output Supply             | -0.3 | 4.5                             | V    |
| $V_{WAKE}$                     | WAKE pin input voltage range              | -0.3 | 42                              | V    |
| $V_{HSS}$                      | High side switch pin output voltage range | -0.3 | 42 and $V_O \leq V_{SUP} + 0.3$ | V    |
| $V_{INH}$                      | Inhibit pin output voltage range          | -0.3 | 42 and $V_O \leq V_{SUP} + 0.3$ | V    |
| $V_{LIMP}$                     | LIMP pin output voltage range             | -0.3 | 42 and $V_O \leq V_{SUP} + 0.3$ | V    |
| $V_{nRST}$                     | Reset output voltage                      | -0.3 | $V_{CC} + 0.3$                  | V    |
| $V_{LOGIC\_INPUT}$             | Logic input voltage                       | -0.3 | 6                               | V    |
| $V_{LOGIC\_OUTPUT}$            | Logic output voltage                      | -0.3 | 6                               | V    |
| $I_O$                          | Digital pin output current                |      | 8                               | mA   |
| $I_{O(nRST)}$                  | Reset output current                      | -5   | 5                               | mA   |
| $T_J$                          | Junction temperature                      | -40  | 160                             | °C   |
| Storage temperature, $T_{stg}$ | Storage temperature range                 | -65  | 165                             | °C   |

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 6.2 ESD Ratings

|             |                         |                                                                                                              | VALUE  | UNIT |
|-------------|-------------------------|--------------------------------------------------------------------------------------------------------------|--------|------|
| $V_{(ESD)}$ | Electrostatic discharge | Human body model (HBM) classification level H2: $V_{BAT}$ , $V_{SUP}$ , LIN, and WAKE with respect to ground | ±10000 | V    |
|             |                         | Human body model (HBM) classification level 3A: all other pins, per AEC Q100-002 <sup>(1)</sup>              | ±4000  |      |
|             |                         | Charged device model (CDM) classification level C5, per AEC Q100-011                                         | ±750   |      |

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

### 6.3 ESD Ratings, IEC Specification

|             |                                                                                          |                                                       | VALUE  | UNIT |
|-------------|------------------------------------------------------------------------------------------|-------------------------------------------------------|--------|------|
| $V_{(ESD)}$ | Electrostatic discharge per IEC 62228-2 <sup>(1)</sup>                                   | Contact discharge ( $V_{SUP}$ , WAKE, HSS, LIMP, LIN) | ±8000  | V    |
|             |                                                                                          | Indirect ESD discharge (LIN)                          | ±14000 |      |
| $V_{(ESD)}$ | Powered electrostatic discharge SAE J2962-1 <sup>(3)</sup>                               | Contact discharge                                     | ±8000  | V    |
|             |                                                                                          | Air discharge                                         | ±25000 |      |
| Transient   | ISO 7637-2 and IEC 62215-3 Transients according to IBEE LIN EMC test spec <sup>(2)</sup> | Pulse 1                                               | -100   | V    |
|             |                                                                                          | Pulse 2a                                              | 75     |      |
|             |                                                                                          | Pulse 3a                                              | -150   |      |
|             |                                                                                          | Pulse 3b                                              | 100    |      |

### 6.3 ESD Ratings, IEC Specification (continued)

|           |                                                 |                                                                                           | VALUE | UNIT |
|-----------|-------------------------------------------------|-------------------------------------------------------------------------------------------|-------|------|
| Transient | ISO 7637-3 Slow Transients Pulse <sup>(4)</sup> | Direct coupling capacitor "slow transient pulse" with 100 nF coupling capacitor - powered | ±30   | V    |

- (1) IEC 62228-2 ESD testing performed at third party. Different system-level configurations may lead to different results.  
 (2) ISO 7637-2 according to IEC 62228-2 are system-level transient tests. Different system-level configurations may lead to different results.  
 (3) SAE J2962-1 Testing performed at 3rd party US3 approved EMC test facility.  
 (4) ISO 7637-3 is a system-level transient test. Different system-level configurations may lead to different results.

### 6.4 Recommended Operating Conditions

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

|                      |                                                                                          | MIN   | NOM | MAX   | UNIT |
|----------------------|------------------------------------------------------------------------------------------|-------|-----|-------|------|
| V <sub>SUP</sub>     | Supply voltage                                                                           | 5.5   |     | 28    | V    |
| V <sub>BAT</sub>     | Supply voltage                                                                           | 5.5   |     | 28    | V    |
| V <sub>LIN</sub>     | LIN bus input voltage                                                                    | 0     |     | 28    | V    |
| V <sub>LOGIC5</sub>  | Logic pin voltage                                                                        | 0     |     | 5.25  | V    |
| V <sub>LOGIC33</sub> | Logic pin voltage                                                                        | 0     |     | 3.465 | V    |
| I <sub>OH(DO)</sub>  | Digital terminal HIGH level output current                                               | -2    |     |       | mA   |
| I <sub>OL(DO)</sub>  | Digital terminal LOW level output current                                                |       |     | 2     | mA   |
| I <sub>O(LIMP)</sub> | LIMP output current when configured as LIMP                                              |       |     | 1     | mA   |
| I <sub>O(HSS)</sub>  | High side switch output current; LIMP output current when configured as high side switch |       |     | 100   | mA   |
| I <sub>O(INH)</sub>  | Inhibit output current                                                                   |       |     | 6     | mA   |
| C <sub>(VSUP)</sub>  | V <sub>SUP</sub> supply capacitance                                                      | 100   |     |       | nF   |
| C <sub>(VCC)</sub>   | V <sub>CC</sub> supply capacitance; no load to full load                                 | 10    |     |       | μF   |
| ESR <sub>CO</sub>    | Output ESR capacitance requirements                                                      | 0.001 |     | 2     | Ω    |
| Δt/ΔV                | Input transition rise and fall rate (WDI, WDT, WDR)                                      |       |     | 100   | ns/V |
| T <sub>J</sub>       | Operating junction temperature range                                                     | -40   |     | 150   | °C   |

### 6.5 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | TLIN1431x | UNIT |
|-------------------------------|----------------------------------------------|-----------|------|
|                               |                                              | RGY       |      |
|                               |                                              | 20 PINS   |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 37.8      | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 32.4      | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 15.7      | °C/W |
| Ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 0.6       | °C/W |
| Ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 15.7      | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | 4.3       | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

### 6.6 Power Supply Characteristics

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                         |                                    | TEST CONDITIONS                                | MIN | TYP | MAX | UNIT |
|-----------------------------------|------------------------------------|------------------------------------------------|-----|-----|-----|------|
| <b>Supply Voltage and Current</b> |                                    |                                                |     |     |     |      |
| V <sub>BAT</sub>                  | V <sub>BAT</sub> sense pin voltage | 470 Ω series resistor with 100nF cap to ground | 5.5 |     | 28  | V    |

## 6.6 Power Supply Characteristics (continued)

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                                          |                                                                       | TEST CONDITIONS                                                                                                                                                                                         | MIN  | TYP  | MAX | UNIT          |
|----------------------------------------------------|-----------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|-----|---------------|
| $I_{\text{BAT}}$                                   | $V_{\text{BAT}}$ sense pin current                                    | 470 $\Omega$ series resistor with 100nF cap to ground with DIV_ON high, $V_{\text{BAT}} = 5.5\text{ V}$ to 28 V                                                                                         |      |      | 220 | $\mu\text{A}$ |
| $I_{\text{BATREV}}$                                | $V_{\text{BAT}}$ sense pin reverse current                            | 470 $\Omega$ series resistor with 100nF cap to ground with DIV_ON high $V_{\text{BAT}} = -24\text{ V}$                                                                                                  | -1   |      |     | mA            |
| $V_{\text{SUP}}$                                   | Operational supply voltage (ISO/DIS 17987 Param 10)                   | Device is operational beyond the LIN defined nominal supply voltage range                                                                                                                               | 5.5  |      | 36  | V             |
| $V_{\text{SUP}}$                                   | Nominal supply voltage (ISO/DIS 17987 Param 10):                      | Normal <sup>(2)</sup> and Standby Modes                                                                                                                                                                 | 5.5  |      | 28  | V             |
|                                                    |                                                                       | Sleep Mode                                                                                                                                                                                              | 5.5  |      | 28  | V             |
| $UV_{\text{SUPR}}$                                 | Under voltage $V_{\text{SUP}}$ threshold                              | Ramp Up                                                                                                                                                                                                 | 4.7  |      | 5.3 | V             |
| $UV_{\text{SUPF}}$                                 | Under voltage $V_{\text{SUP}}$ threshold                              | Ramp Down                                                                                                                                                                                               | 4    |      | 4.6 | V             |
| $U_{\text{VHYS}}$                                  | Delta hysteresis voltage for $V_{\text{SUP}}$ under voltage threshold |                                                                                                                                                                                                         |      | 0.70 |     | V             |
| $V_{\text{nPORR}}$                                 | $V_{\text{SUP}}$ power on reset release rising threshold              | Ramp Up                                                                                                                                                                                                 | 3.5  |      | 4.2 | V             |
| $V_{\text{nPORF}}$                                 | $V_{\text{SUP}}$ power on reset falling threshold                     | Ramp down                                                                                                                                                                                               | 1.9  |      | 2.9 | V             |
| $I_{\text{SUP}}$                                   | Transceiver and LDO supply current                                    | Transceiver normal mode dominant plus LDO output; where LDO load current is 125 mA                                                                                                                      |      |      | 135 | mA            |
| $I_{\text{SUPTRXDOM}}$                             | Supply current                                                        | Normal Mode: EN = $V_{\text{CC}}$ (Pin control mode otherwise SPI enabled), bus dominant: total bus load where $R_{\text{LIN}} \geq 500\ \Omega$ and $C_{\text{LIN}} \leq 10\text{ nF}$ , LDO = no load |      | 2.3  | 5.2 | mA            |
|                                                    |                                                                       | Standby Mode: EN = 0 V (Pin control mode otherwise SPI disabled), bus dominant: total bus load where $R_{\text{LIN}} \geq 500\ \Omega$ and $C_{\text{LIN}} \leq 10\text{ nF}$ , LDO = no load           |      | 1    | 1.9 | mA            |
| $I_{\text{SUPTRXREC}}$                             | Normal mode recessive supply current                                  | Normal Mode: EN = $V_{\text{CC}}$ , Bus recessive: LIN = $V_{\text{SUP}}$ , LDO = no load                                                                                                               |      | 0.9  | 1.3 | mA            |
| $I_{\text{SUPTRXREC}}$                             | Standby mode recessive supply current                                 | Standby Mode: EN = 0 V (Pin control mode otherwise SPI disabled), LIN = recessive = $V_{\text{SUP}}$ , LDO = no load                                                                                    |      | 210  | 350 | $\mu\text{A}$ |
| $I_{\text{SUPTRXSLP}}$                             | Sleep mode supply current                                             | 5.5 V < $V_{\text{SUP}} \leq 14\text{ V}$ , LIN = $V_{\text{SUP}}$ , WAKE = GND, EN = 0 V (Pin control mode otherwise SPI disabled), TXD and RXD floating, LDO = no load                                |      | 20   | 32  | $\mu\text{A}$ |
|                                                    |                                                                       | 14 V < $V_{\text{SUP}} \leq 28\text{ V}$ , LIN = $V_{\text{SUP}}$ , WAKE = GND, EN = 0 V (Pin control mode otherwise SPI disabled), TXD and RXD floating, LDO = no load                                 |      | 25   | 36  | $\mu\text{A}$ |
| $I_{\text{SUPHSS}}$                                | High side switch current - no load                                    | Additional standby mode current from high side switch, no load.                                                                                                                                         |      |      | 110 | $\mu\text{A}$ |
| $I_{\text{SUPWKRQ\_INH}}$                          | WKRQ/INH current due to pull-down                                     | Additional standby mode current due to the pull-down resistor on the WKRQ/INH pin to determine pin function, 100 k $\Omega$ for WKRQ or 1 M $\Omega$ for INH.                                           |      |      | 95  | $\mu\text{A}$ |
| <b>Regulated Output <math>V_{\text{CC}}</math></b> |                                                                       |                                                                                                                                                                                                         |      |      |     |               |
| $V_{\text{CC}}$                                    | Regulated output                                                      | $V_{\text{SUP}} = 5.5\text{ to }28\text{ V}$ , $I_{\text{CC}} = 1\text{ to }125\text{ mA}$                                                                                                              | -2.5 |      | 2.5 | %             |
| $\Delta V_{\text{CC}}(\text{AVSUP})$               | Line regulation                                                       | $V_{\text{SUP}} = 5.5\text{ to }28\text{ V}$ , $\Delta V_{\text{CC}}$ , $I_{\text{CC}} = 10\text{ mA}$                                                                                                  |      |      | 50  | mV            |
| $\Delta V_{\text{CC}}(\text{AVSUPL})$              | Load regulation                                                       | $I_{\text{CC}} = 1\text{ to }125\text{ mA}$ , $V_{\text{SUP}} = 14\text{ V}$ , $\Delta V_{\text{CC}}$                                                                                                   |      |      | 50  | mV            |
| $V_{\text{DROP1}}$                                 | Dropout voltage (5 V LDO output)                                      | $V_{\text{SUP}} - V_{\text{CC}}$ , $I_{\text{CC}} = 15\text{ mA}$                                                                                                                                       |      | 100  | 150 | mV            |
| $V_{\text{DROP2}}$                                 | Dropout voltage (5 V LDO output)                                      | $V_{\text{SUP}} - V_{\text{CC}}$ , $I_{\text{CC}} = 125\text{ mA}$                                                                                                                                      |      | 550  | 650 | mV            |
| $V_{\text{SC}}$                                    | $V_{\text{CC}}$ short circuit threshold to enter sleep mode           | $V_{\text{SUP}} \geq V_{\text{POR}}$                                                                                                                                                                    |      | 2    | 2.5 | V             |
| $UV_{\text{CC5R}}$                                 | Under voltage 5 V $V_{\text{CC}}$ threshold                           | Ramp Up                                                                                                                                                                                                 |      | 4.7  | 4.9 | V             |
| $UV_{\text{CC5F}}$                                 | Under voltage 5 V $V_{\text{CC}}$ threshold                           | Ramp Down                                                                                                                                                                                               | 4.1  | 4.45 |     | V             |
| $UV_{\text{CC33R}}$                                | Under voltage 3.3 V $V_{\text{CC}}$ threshold                         | Ramp Up                                                                                                                                                                                                 |      | 2.9  | 3.1 | V             |
| $UV_{\text{CC33F}}$                                | Under voltage 3.3 V $V_{\text{CC}}$ threshold                         | Ramp Down                                                                                                                                                                                               | 2.5  | 2.75 |     | V             |

## 6.6 Power Supply Characteristics (continued)

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER           |                                                        | TEST CONDITIONS                                                                                                                                               | MIN  | TYP  | MAX  | UNIT               |
|---------------------|--------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|--------------------|
| OV <sub>CC5R</sub>  | Over voltage 5 V VCC threshold <sup>(1)</sup>          | Ramp Up                                                                                                                                                       |      | 5.6  | 6.0  | V                  |
| OV <sub>CC5F</sub>  | Over voltage 5 V VCC threshold <sup>(1)</sup>          | Ramp Down                                                                                                                                                     | 5.28 | 5.5  |      | V                  |
| OV <sub>CC33R</sub> | Over voltage 3.3 V VCC threshold <sup>(1)</sup>        | Ramp Up                                                                                                                                                       |      | 3.79 | 3.98 | V                  |
| OV <sub>CC33F</sub> | Over voltage 3.3 V VCC threshold <sup>(1)</sup>        | Ramp Down                                                                                                                                                     | 3.58 | 3.73 |      | V                  |
| I <sub>CCOUT</sub>  | Output current                                         | V <sub>CC</sub> in regulation with 14V V <sub>SUP</sub>                                                                                                       | 1    |      | 125  | mA                 |
| I <sub>CCOUTL</sub> | Output current limit                                   | V <sub>CC</sub> short to ground                                                                                                                               |      |      | 275  | mA                 |
| PSRR                | Power supply rejection ripple rejection <sup>(1)</sup> | V <sub>RIP</sub> = 0.5 V <sub>PP</sub> , Load = 10 mA, $f = 100$ Hz, CO = 10 $\mu$ F, V <sub>SUP</sub> = 12 V and ambient temperature = 27 $^{\circ}\text{C}$ |      | 60   |      | dB                 |
| T <sub>SDR</sub>    | Thermal shutdown temperature <sup>(1)</sup>            | Internal junction temperature; rising                                                                                                                         | 160  |      | 185  | $^{\circ}\text{C}$ |
| T <sub>SDF</sub>    | Thermal shutdown temperature <sup>(1)</sup>            | Internal junction temperature; falling                                                                                                                        | 150  |      | 170  | $^{\circ}\text{C}$ |
| T <sub>SDHYS</sub>  | Thermal shutdown hysteresis <sup>(1)</sup>             | V <sub>SUP</sub> = 12 V                                                                                                                                       |      | 15   |      | $^{\circ}\text{C}$ |

(1) Specified by design

(2) Normal Mode: Ramp VSUP while LIN signal is a 10 kHz square wave with 50 % duty cycle and 18 V swing.

## 6.7 Electrical Characteristics

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                                           |                                                                                  | TEST CONDITIONS                                                                                                                                     | MIN   | TYP | MAX   | UNIT             |
|-----------------------------------------------------|----------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------|-------|-----|-------|------------------|
| <b>RXD Output Terminal</b>                          |                                                                                  |                                                                                                                                                     |       |     |       |                  |
| V <sub>OH</sub>                                     | High level output voltage                                                        | I <sub>O</sub> = -2 mA, V <sub>CC</sub> = Active                                                                                                    | 0.8   |     |       | V <sub>CC</sub>  |
| V <sub>OL</sub>                                     | Low level output voltage                                                         | I <sub>O</sub> = 2 mA, V <sub>CC</sub> = Active                                                                                                     |       |     | 0.2   | V <sub>CC</sub>  |
| I <sub>LKG(OFF)</sub>                               | Unpowered leakage current                                                        | Outputs = 5.25/3.465 V, V <sub>CC</sub> = V <sub>SUP</sub> = 0 V                                                                                    | -1    |     | 1     | $\mu$ A          |
| <b>TXD Input Terminal</b>                           |                                                                                  |                                                                                                                                                     |       |     |       |                  |
| V <sub>IL</sub>                                     | Low level input voltage                                                          |                                                                                                                                                     | -0.3  |     | 0.8   | V                |
| V <sub>IH</sub>                                     | High level input voltage                                                         |                                                                                                                                                     | 2     |     | 5.5   | V                |
| I <sub>IH</sub>                                     | High level input leakage current                                                 | TXD = V <sub>IH</sub>                                                                                                                               | -5    | 0   | 5     | $\mu$ A          |
| R <sub>TXD</sub>                                    | Internal pull-up resistor value                                                  |                                                                                                                                                     | 125   | 350 | 800   | k $\Omega$       |
| <b>LIN Terminal (Referenced to V<sub>SUP</sub>)</b> |                                                                                  |                                                                                                                                                     |       |     |       |                  |
| V <sub>OH</sub>                                     | HIGH level output voltage <sup>(5)</sup>                                         | LIN recessive, TXD = high, I <sub>O</sub> = 0 mA, V <sub>SUP</sub> = 5.5 V to 28 V                                                                  | 0.85  |     |       | V <sub>SUP</sub> |
| V <sub>OL</sub>                                     | LOW level output voltage <sup>(5)</sup>                                          | LIN dominant, TXD = low, V <sub>SUP</sub> = 5.5 V to 28 V                                                                                           |       |     | 0.2   | V <sub>SUP</sub> |
| V <sub>SUP_NON_OP</sub>                             | V <sub>SUP</sub> where impact of recessive LIN bus < 5% (ISO/DIS 17987 Param 11) | TXD & RXD open V <sub>LIN</sub> = 5.5 V to 45 V                                                                                                     | -0.3  |     | 45    | V                |
| I <sub>BUS_LIM</sub>                                | Limiting current (ISO/DIS 17987 Param 12)                                        | TXD = 0 V, V <sub>LIN</sub> = 28 V, R <sub>MEAS</sub> = 440 $\Omega$ , V <sub>SUP</sub> = 28 V, V <sub>BUSdom</sub> $\leq$ 0.251 * V <sub>SUP</sub> | 40    | 90  | 200   | mA               |
| I <sub>BUS_PAS_dom</sub>                            | Receiver leakage current, dominant (ISO/DIS 17987 Param 13)                      | V <sub>LIN</sub> = 0 V, V <sub>SUP</sub> = 12 V Driver off/recessive                                                                                | -1    |     |       | mA               |
| I <sub>BUS_PAS_rec1</sub>                           | Receiver leakage current, recessive (ISO/DIS 17987 Param 14)                     | V <sub>LIN</sub> $\geq$ V <sub>SUP</sub> , 5.5 V $\leq$ V <sub>SUP</sub> $\leq$ 28 V Driver off                                                     |       |     | 20    | $\mu$ A          |
| I <sub>BUS_PAS_rec2</sub>                           | Receiver leakage current, recessive (ISO/DIS 17987 Param 14)                     | V <sub>LIN</sub> = V <sub>SUP</sub> , Driver off                                                                                                    | -5    |     | 5     | $\mu$ A          |
| I <sub>BUS_NO_GND</sub>                             | Leakage current, loss of ground (ISO/DIS 17987 Param 15)                         | GND = V <sub>SUP</sub> , V <sub>SUP</sub> = 12 V, 0 V $\leq$ V <sub>LIN</sub> $\leq$ 28 V                                                           | -1    |     | 1     | mA               |
| I <sub>BUS_NO_BAT</sub>                             | Leakage current, loss of supply (ISO/DIS 17987 Param 16)                         | 0 V $\leq$ V <sub>LIN</sub> $\leq$ 28 V, V <sub>SUP</sub> = GND                                                                                     |       |     | 10    | $\mu$ A          |
| V <sub>BUSdom</sub>                                 | Low level input voltage (ISO/DIS 17987 Param 17)                                 | LIN dominant (including LIN dominant for wake up); <a href="#">Figure 7-2</a>                                                                       |       |     | 0.4   | V <sub>SUP</sub> |
| V <sub>BUSrec</sub>                                 | High level input voltage (ISO/DIS 17987 Param 18)                                | LIN recessive; <a href="#">Figure 7-2</a>                                                                                                           | 0.6   |     |       | V <sub>SUP</sub> |
| V <sub>BUS_CNT</sub>                                | Receiver center threshold (ISO/DIS 17987 Param 19)                               | V <sub>BUS_CNT</sub> = (V <sub>IL</sub> + V <sub>IH</sub> )/2; <a href="#">Figure 7-2</a>                                                           | 0.475 | 0.5 | 0.525 | V <sub>SUP</sub> |

## 6.7 Electrical Characteristics (continued)

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                                                    |                                                                                                                | TEST CONDITIONS                                                                                                | MIN  | TYP  | MAX   | UNIT             |
|--------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------|------|------|-------|------------------|
| $V_{HYS}$                                                    | Hysteresis voltage (ISO/DIS 17987 Param 20) <sup>(6)</sup><br>(7)                                              | $V_{HYS} = (V_{IL} - V_{IH})$ ; <a href="#">Figure 7-2</a>                                                     |      |      | 0.175 | $V_{SUP}$        |
| $V_{SERIAL\_DIODE}$                                          | Serial diode LIN term pull-up path (ISO/DIS 17987 Param 21)                                                    | By design and characterization                                                                                 | 0.4  | 0.7  | 1.0   | V                |
| $R_{LIN}$                                                    | Internal pull-up resistor to $V_{SUP}$ on LIN (ISO/DIS 17987 Param 26)                                         | Normal and Standby modes                                                                                       | 20   | 45   | 60    | k $\Omega$       |
| $I_{RSLEEP}$                                                 | Pull-up current source to $V_{SUP}$                                                                            | Sleep mode, $V_{SUP} = 12\text{ V}$ , LIN = GND                                                                | -20  |      | -2    | $\mu\text{A}$    |
| $C_{LIN,PIN}$                                                | Capacitance of the LIN pin                                                                                     | By design and characterization                                                                                 |      |      | 25    | pF               |
| <b>EN Input Terminal</b>                                     |                                                                                                                |                                                                                                                |      |      |       |                  |
| $V_{IH}$                                                     | High level input voltage                                                                                       |                                                                                                                | 2    |      | 5.5   | V                |
| $V_{IL}$                                                     | Low level input voltage                                                                                        |                                                                                                                |      |      | 0.8   | V                |
| $V_{HYS}$                                                    | Hysteresis voltage                                                                                             | By design and characterization                                                                                 | 30   |      | 500   | mV               |
| $I_{IL}$                                                     | Low level input current                                                                                        | EN = Low                                                                                                       | -8   |      | 8     | $\mu\text{A}$    |
| $R_{EN}$                                                     | Internal pull-down resistor                                                                                    |                                                                                                                | 125  | 350  | 800   | k $\Omega$       |
| <b>LIMP Output Terminal (High Voltage Open-drain Output)</b> |                                                                                                                |                                                                                                                |      |      |       |                  |
| $\Delta V_H$                                                 | Hi-level voltage drop for LIMP with respect to $V_{SUP}$                                                       | $I_{LIMP} = -60\text{ mA}$                                                                                     |      | 0.42 | 1.2   | V                |
| $R_{dson}$                                                   | LIMP output drain-to-source on resistance                                                                      | $I_O = -60\text{ mA}$                                                                                          |      | 7    | 20    | $\Omega$         |
| $I_{LKG(LIMP)}$                                              | Leakage current                                                                                                | LIMP = 0 V, Sleep Mode                                                                                         | -1   |      | 1     | $\mu\text{A}$    |
| <b>HSS, INH high voltage open drain output pin</b>           |                                                                                                                |                                                                                                                |      |      |       |                  |
| $V_{DET\_INH}$                                               | Voltage on INH/WKRQ pin during $t_{DET\_INH}$ time                                                             | $V_{SUP} = 14\text{ V}$                                                                                        |      |      | 1.5   | V                |
| $\Delta V_{HINH}$                                            | Hi-level voltage drop for INH with respect to $V_{SUP}$                                                        | $I_{INH} = -6\text{ mA}$                                                                                       |      | 0.5  | 1     | V                |
| $\Delta V_{HHSS}$                                            | Hi-level voltage drop for HSS with respect to $V_{SUP}$                                                        | $I_{HSS} = -60\text{ mA}$                                                                                      |      | 0.42 | 1.2   | V                |
| $R_{dson}$                                                   | HSS output drain-to-source on resistance                                                                       | $I_O = -60\text{ mA}$                                                                                          |      | 7    | 17    | $\Omega$         |
| $I_{O(HSS)}$                                                 | Output current support                                                                                         | $V_{SUP} = 14\text{ V}$ ,                                                                                      |      | 60   | 100   | mA               |
| $I_{OC(HSS)}$                                                | HSS overcurrent limit                                                                                          | $V_{SUP} = 14\text{ V}$                                                                                        | 150  |      | 300   | mA               |
| $I_{OL(HSS)}$                                                | HSS open load current                                                                                          | $V_{SUP} = 14\text{ V}$                                                                                        | -2.5 |      |       | mA               |
| $I_{OLHYS(HSS)}$                                             | HSS open load current hysteresis                                                                               | $V_{SUP} = 14\text{ V}$                                                                                        | 0.05 | 0.45 | 1     | mA               |
| $I_{lkg}$                                                    | Leakage current                                                                                                | INH, HSS = 0 V, Sleep Mode                                                                                     | -1   |      | 1     | $\mu\text{A}$    |
| $t_{R/F}$                                                    | Output rise and fall times (HSS)                                                                               | $5.5\text{ V} \leq V_{SUP} \leq 28\text{ V}$ , $I_{LOAD} = 60\text{ mA}$ , $R_L = 220\text{ }\Omega$ , 80%/20% | 0.6  |      | 2.5   | V/ $\mu\text{s}$ |
| $t_{HSS\_on}$                                                | Switching on delay (HSS) from SPI command to on                                                                | $V_{SUP} = 14\text{ V}$ , $I_{LOAD} = 60\text{ mA}$ , $V_{OUT} = 80\%$ of $V_{SUP}$                            |      |      | 60    | $\mu\text{s}$    |
| $t_{HSS\_off}$                                               | Switching off delay (HSS) from SPI command to off                                                              | $V_{SUP} = 14\text{ V}$ , $I_{LOAD} = 60\text{ mA}$ , $V_{OUT} = 20\%$ of $V_{SUP}$                            |      |      | 140   | $\mu\text{s}$    |
| $t_{OCFLTR}$                                                 | HSS overcurrent filter time <sup>(2)</sup>                                                                     | $V_{SUP} = 14\text{ V}$                                                                                        |      | 16   |       | $\mu\text{s}$    |
| $t_{OLFLTR}$                                                 | HSS open load filter time <sup>(2)</sup>                                                                       | $V_{SUP} = 14\text{ V}$                                                                                        |      | 64   |       | $\mu\text{s}$    |
| $t_{OCOFF}$                                                  | HSS overcurrent shut off time                                                                                  | $I_{O(HSS)} > I_{OC(HSS)}$                                                                                     | 200  |      | 300   | $\mu\text{s}$    |
| <b>WAKE Input Terminal</b>                                   |                                                                                                                |                                                                                                                |      |      |       |                  |
| $V_{IH}$                                                     | High-level input voltage                                                                                       | Sleep or Standby Mode, WAKE pin enabled                                                                        | 4    |      |       | V                |
| $V_{IL}$                                                     | Low-level input voltage                                                                                        | Sleep or Standby Mode, WAKE pin enabled                                                                        |      |      | 2     | V                |
| $I_{IL}$                                                     | Low-level input leakage current                                                                                | WAKE = 1 V                                                                                                     |      | 15   | 25    | $\mu\text{A}$    |
| $t_{WAKE}$                                                   | Wake up hold time from a wake edge on WAKE in standby or sleep mode for static sensing..                       | See <a href="#">Figure 8-44</a> and <a href="#">Figure 8-45</a>                                                | 140  |      |       | $\mu\text{s}$    |
| $t_{WAKE\_INVALID}$                                          | WAKE pin pulses shorter than this will be filtered out in standby or sleep mode for static and cyclic sensing. | See <a href="#">Figure 8-44</a> and <a href="#">Figure 8-45</a>                                                |      |      | 10    | $\mu\text{s}$    |
| <b>WDI, SDI, CLK, nCS Input Terminal</b>                     |                                                                                                                |                                                                                                                |      |      |       |                  |
| $V_{IH}$                                                     | High-level input voltage                                                                                       |                                                                                                                | 2.19 |      |       | V                |
| $V_{IL}$                                                     | Low-level input voltage                                                                                        |                                                                                                                |      |      | 0.8   | V                |
| $I_{IH}$                                                     | High-level input leakage current                                                                               | Inputs = $V_{CC}$                                                                                              | -1   |      | 1     | $\mu\text{A}$    |
| $I_{IL}$                                                     | Low-level input leakage current                                                                                | Inputs = 0 V, $V_{CC}$ = Active                                                                                | -50  |      |       | $\mu\text{A}$    |

## 6.7 Electrical Characteristics (continued)

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                                                                                                |                                                                      | TEST CONDITIONS                                                                                                                            | MIN   | TYP | MAX  | UNIT            |
|----------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------|-------|-----|------|-----------------|
| C <sub>IN</sub>                                                                                          | Input Capacitance                                                    | 4 MHz                                                                                                                                      |       | 10  | 15   | pF              |
| I <sub>LKG(OFF)</sub>                                                                                    | Unpowered leakage current                                            | Inputs = 5.25/3.465 V, V <sub>CC</sub> = V <sub>SUP</sub> = 0 V                                                                            | −1    |     | 1    | μA              |
| R <sub>WDI_SDIpu</sub>                                                                                   | Internal pull-up resistor on WDI/SDI pin                             |                                                                                                                                            | 100   | 240 | 400  | kΩ              |
| R <sub>CLKpu</sub>                                                                                       | Internal pull-up resistor on WDT/CLK pin                             | SPI control only for CLK                                                                                                                   | 100   | 240 | 400  | kΩ              |
| R <sub>nCSpu</sub>                                                                                       | Internal pull-up resistor on PIN/nCS pin                             | SPI control only for nCS                                                                                                                   | 100   | 240 | 400  | kΩ              |
| WDT Input Terminal                                                                                       |                                                                      |                                                                                                                                            |       |     |      |                 |
| V <sub>IH</sub>                                                                                          | High-level input voltage                                             | Inputs = V <sub>CC</sub>                                                                                                                   | 0.8   |     |      | V <sub>CC</sub> |
| V <sub>IL</sub>                                                                                          | Low-level input voltage                                              | Inputs = V <sub>CC</sub>                                                                                                                   |       |     | 0.2  | V <sub>CC</sub> |
| V <sub>IM(WDT)</sub>                                                                                     | WDT Mid-level input voltage <sup>(1)</sup>                           | Inputs = V <sub>CC</sub>                                                                                                                   | 0.4   | 0.5 | 0.6  | V <sub>CC</sub> |
| I <sub>IH</sub>                                                                                          | High-level input leakage current                                     | Inputs = V <sub>CC</sub>                                                                                                                   | 2.5   |     | 25   | μA              |
| I <sub>IL</sub>                                                                                          | Low-level input leakage current                                      | Inputs = 0 V, V <sub>CC</sub> = Active                                                                                                     | −25   |     | −2.5 | μA              |
| I <sub>LKG(OFF)</sub>                                                                                    | Unpowered leakage current                                            | Inputs = 5.25/3.465 V, V <sub>CC</sub> = V <sub>SUP</sub> = 0 V                                                                            | −3    |     | 3    | μA              |
| SDO Output Terminal                                                                                      |                                                                      |                                                                                                                                            |       |     |      |                 |
| V <sub>OH</sub>                                                                                          | High level output voltage                                            | I <sub>O</sub> = −2 mA, V <sub>CC</sub> = Active                                                                                           | 0.8   |     |      | V <sub>CC</sub> |
| V <sub>OL</sub>                                                                                          | Low level output voltage                                             | I <sub>O</sub> = 2 mA, V <sub>CC</sub> = Active                                                                                            |       |     | 0.2  | V <sub>CC</sub> |
| I <sub>LKG(OFF)</sub>                                                                                    | Unpowered leakage current                                            | Outputs = 5.25/3.465 V, V <sub>CC</sub> = V <sub>SUP</sub> = 0 V                                                                           | −1    |     | 1    | μA              |
| nRST Terminal; input/output reset (Open-drain)                                                           |                                                                      |                                                                                                                                            |       |     |      |                 |
| I <sub>LKG</sub>                                                                                         | Leakage current, high-level                                          | LIN = V <sub>SUP</sub> , nRST = V <sub>CC</sub>                                                                                            | −5    |     | 5    | μA              |
| V <sub>OL</sub>                                                                                          | Low-level output voltage                                             | Based upon external pull up to V <sub>CC</sub>                                                                                             |       |     | 0.2  | V <sub>CC</sub> |
| I <sub>OL</sub>                                                                                          | Low-level output current, open drain                                 | LIN = 0 V, nRST = 0.4 V                                                                                                                    | 1.5   |     |      | mA              |
| V <sub>th(sw)</sub>                                                                                      | Switching threshold voltage                                          |                                                                                                                                            | 0.25  |     | 0.75 | V <sub>CC</sub> |
| R <sub>PU</sub>                                                                                          | Pull-up resistance                                                   |                                                                                                                                            | 30    | 45  | 65   | kΩ              |
| nINT, nWDR, WKRQ Terminal                                                                                |                                                                      |                                                                                                                                            |       |     |      |                 |
| V <sub>OH</sub>                                                                                          | High level output voltage                                            | I <sub>O</sub> = −2 mA, V <sub>CC</sub> = Active                                                                                           | 0.8   |     |      | V <sub>CC</sub> |
| V <sub>OL</sub>                                                                                          | Low-level output voltage                                             | I <sub>O</sub> = 2 mA, V <sub>CC</sub> = Active                                                                                            |       |     | 0.2  | V <sub>CC</sub> |
| I <sub>LKG(OFF)</sub>                                                                                    | Unpowered leakage current (nINT and nWDR pins)                       | Outputs = 5.25/3.465 V, V <sub>CC</sub> = V <sub>SUP</sub> = 0 V                                                                           | −1    |     | 1    | μA              |
| HSSC                                                                                                     |                                                                      |                                                                                                                                            |       |     |      |                 |
| V <sub>IH</sub>                                                                                          | High-level input voltage                                             |                                                                                                                                            | 2     |     | 5.5  | V               |
| V <sub>IL</sub>                                                                                          | Low-level input voltage                                              |                                                                                                                                            |       |     | 0.8  | V               |
| I <sub>IL</sub>                                                                                          | Low-level input current                                              | V <sub>IN</sub> = 0 V                                                                                                                      | −1    |     | 1    | μA              |
| R <sub>HSSC</sub>                                                                                        | Pull-down resistor                                                   |                                                                                                                                            | 150   | 350 | 800  | kΩ              |
| f <sub>SW</sub>                                                                                          | Switching frequency                                                  | V <sub>HSS</sub> = 14 V, I <sub>O(HSS)</sub> = 60 mA                                                                                       |       |     | 400  | Hz              |
| WDI, WDT TIMING and SWITCHING CHARACTERISTIC (RL = 1 MΩ, CL = 50 pF and T <sub>J</sub> = −40°C to 150°C) |                                                                      |                                                                                                                                            |       |     |      |                 |
| t <sub>W</sub>                                                                                           | WDI pulse width; see <a href="#">Figure 7-8</a>                      | Filter time to avoid false input                                                                                                           | 30    |     |      | μs              |
| t <sub>WINDOW</sub>                                                                                      | Closed Window + Open Window; See <a href="#">Figure 7-8</a>          | WDT = GND                                                                                                                                  | 32    | 40  | 48   | ms              |
|                                                                                                          |                                                                      | WDT = V <sub>CC</sub>                                                                                                                      | 480   | 600 | 720  | ms              |
|                                                                                                          |                                                                      | WDT = Floating                                                                                                                             | 4.8   | 6   | 7.2  | s               |
| DIV_ON                                                                                                   |                                                                      |                                                                                                                                            |       |     |      |                 |
| V <sub>IH</sub>                                                                                          | High-level input voltage                                             |                                                                                                                                            | 2     |     | 5.5  | V               |
| V <sub>IL</sub>                                                                                          | Low-level input voltage                                              |                                                                                                                                            |       |     | 0.8  | V               |
| I <sub>IL</sub>                                                                                          | Low-level input current                                              | V <sub>DIV_ON</sub> = 0 V                                                                                                                  | −1    |     | 1    | μA              |
| R <sub>DIV_ON</sub>                                                                                      | Pull-down resistor                                                   |                                                                                                                                            | 150   | 370 | 800  | kΩ              |
| PV                                                                                                       |                                                                      |                                                                                                                                            |       |     |      |                 |
| Ratio                                                                                                    | Divider ratio 5 V VCC                                                | V <sub>BAT</sub> = 5.5 V to 28 V                                                                                                           |       | 1:7 |      |                 |
| Ratio                                                                                                    | Divider ratio 3.3 V VCC                                              | V <sub>BAT</sub> = 5.5 V to 20 V                                                                                                           |       | 1:9 |      |                 |
| ERR                                                                                                      | Divider ratio error                                                  | V <sub>BAT</sub> = 5.5 V to 28 V                                                                                                           | −2    |     | 2    | %               |
| V <sub>BATLIN5</sub>                                                                                     | Linear voltage range for V <sub>BAT</sub> for 5 V LDO <sup>(3)</sup> | R <sub>LOAD</sub> = 470 Ω ± 5% and C <sub>LOAD</sub> = 10 nF ± 10%; When capacitive load only 20 pF ± 20%, 5.5 V ≤ V <sub>BAT</sub> ≤ 28 V | 0.735 |     | 4.05 | V               |

## 6.7 Electrical Characteristics (continued)

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                         |                                                                                                           | TEST CONDITIONS                                                                                                                                                                                                                                                                                                                             | MIN   | TYP   | MAX  | UNIT          |
|-----------------------------------|-----------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|-------|------|---------------|
| $V_{\text{BATLIN3}}$              | Linear voltage range for $V_{\text{BAT}}$ for 3.3 V LDO and when I/O is 3.3 V with 5 V LDO <sup>(4)</sup> | $R_{\text{LOAD}} = 470\ \Omega \pm 5\%$ and $C_{\text{LOAD}} = 10\ \text{nF} \pm 10\%$ ; When capacitive load only $20\ \text{pF} \pm 20\%$ , $5.5\ \text{V} \leq V_{\text{BAT}} \leq 20\ \text{V}$                                                                                                                                         | 0.561 |       | 2.27 | V             |
| $V_{\text{MAX5V}}$                | Maximum $V_{\text{PVOU}}$                                                                                 | $28\ \text{V} < V_{\text{BAT}} \leq 42\ \text{V}$ , $470\ \Omega \pm 5\%$ and $C_{\text{LOAD}} = 10\ \text{nF} \pm 10\%$ ; When capacitive load only $20\ \text{pF} \pm 20\%$                                                                                                                                                               |       |       | 5.1  | V             |
| $V_{\text{MAX3.3V}}$              | Maximum $V_{\text{PVOU}}$ for 3.3 V LDO and when I/O is 3.3 V with 5 V LDO                                | $20\ \text{V} < V_{\text{BAT}} \leq 42\ \text{V}$ , $470\ \Omega \pm 5\%$ and $C_{\text{LOAD}} = 10\ \text{nF} \pm 10\%$ ; When capacitive load only $20\ \text{pF} \pm 20\%$                                                                                                                                                               |       |       | 3.36 | V             |
| $V_{\text{VCC5V\_VIO3V}}$         | Voltage when VCC = 5 V and I/O is at 3.3 V                                                                | $R_{\text{LOAD}} = 470\ \Omega \pm 5\%$ and $C_{\text{LOAD}} = 10\ \text{nF} \pm 10\%$ ; When capacitive load only $20\ \text{pF} \pm 20\%$ and I/O voltage is $\leq 3.6\ \text{V}$                                                                                                                                                         |       |       | 3.36 | V             |
| $C_{\text{PIN}}$                  | Pin capacitance                                                                                           |                                                                                                                                                                                                                                                                                                                                             |       | 12    |      | pF            |
| $t_{\text{SET}}$                  | Settling time of the buffer                                                                               | $470\ \Omega \pm 5\%$ and $C_{\text{LOAD}} = 10\ \text{nF} \pm 10\%$ ; When capacitive load only $20\ \text{pF} \pm 20\%$                                                                                                                                                                                                                   |       |       | 50   | $\mu\text{s}$ |
| <b>Duty Cycle Characteristics</b> |                                                                                                           |                                                                                                                                                                                                                                                                                                                                             |       |       |      |               |
| D1                                | Duty Cycle 1 (ISO/DIS 17987 Param 27 and J2602 Normal battery) <sup>(8) (9)</sup>                         | $\text{TH}_{\text{REC}}(\text{MAX}) = 0.744 \times V_{\text{SUP}}$ ,<br>$\text{TH}_{\text{DOM}}(\text{MAX}) = 0.581 \times V_{\text{SUP}}$ ,<br>$V_{\text{SUP}} = 7\ \text{V}$ to $18\ \text{V}$ , $t_{\text{BIT}} = 50/52\ \mu\text{s}$ ,<br>$D1 = t_{\text{BUS\_rec}}(\text{min})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4) | 0.396 |       |      |               |
| D2                                | Duty Cycle 2 (ISO/DIS 17987 Param 28 and J2602 Normal battery) <sup>(8) (9)</sup>                         | $\text{TH}_{\text{REC}}(\text{MIN}) = 0.422 \times V_{\text{SUP}}$ ,<br>$\text{TH}_{\text{DOM}}(\text{MIN}) = 0.284 \times V_{\text{SUP}}$ , $V_{\text{SUP}} = 7.6\ \text{V}$ to $18\ \text{V}$ ,<br>$t_{\text{BIT}} = 50/52\ \mu\text{s}$ , $D2 = t_{\text{BUS\_rec}}(\text{MAX})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4)  |       | 0.581 |      |               |
| D3                                | Duty Cycle 3 (ISO/DIS 17987 Param 29 and J2602 Normal battery) <sup>(8) (9)</sup>                         | $\text{TH}_{\text{REC}}(\text{MAX}) = 0.778 \times V_{\text{SUP}}$ , $\text{TH}_{\text{DOM}}(\text{MAX}) = 0.616 \times V_{\text{SUP}}$ , $V_{\text{SUP}} = 7.0\ \text{V}$ to $18\ \text{V}$ , $t_{\text{BIT}} = 96\ \mu\text{s}$ ,<br>$D3 = t_{\text{BUS\_rec}}(\text{min})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4)        | 0.417 |       |      |               |
| D4                                | Duty Cycle 4 (ISO/DIS 17987 Param 30 and J2602 Normal battery) <sup>(8) (9)</sup>                         | $\text{TH}_{\text{REC}}(\text{MIN}) = 0.389 \times V_{\text{SUP}}$ , $\text{TH}_{\text{DOM}}(\text{MIN}) = 0.251 \times V_{\text{SUP}}$ ,<br>$V_{\text{SUP}} = 7.6\ \text{V}$ to $18\ \text{V}$ , $t_{\text{BIT}} = 96\ \mu\text{s}$ ,<br>$D4 = t_{\text{BUS\_rec}}(\text{MAX})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4)     |       | 0.59  |      |               |
| D1 <sub>LB</sub>                  | Duty Cycle 1<br>J2602 Low battery <sup>(9) (10)</sup>                                                     | $\text{TH}_{\text{REC}}(\text{MAX}) = 0.665 \times V_{\text{SUP}}$ , $\text{TH}_{\text{DOM}}(\text{MAX}) = 0.499 \times V_{\text{SUP}}$ , $V_{\text{SUP}} = 5.5\ \text{V}$ to $7\ \text{V}$ , $t_{\text{BIT}} = 50/52\ \mu\text{s}$ ,<br>$D1 = t_{\text{BUS\_rec}}(\text{min})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4)      | 0.396 |       |      |               |
| D2 <sub>LB</sub>                  | Duty Cycle 2<br>J2602 Low battery <sup>(9) (10)</sup>                                                     | $\text{TH}_{\text{REC}}(\text{MIN}) = 0.496 \times V_{\text{SUP}}$ , $\text{TH}_{\text{DOM}}(\text{MIN}) = 0.361 \times V_{\text{SUP}}$ , $V_{\text{SUP}} = 6.1\ \text{V}$ to $7.6\ \text{V}$ , $t_{\text{BIT}} = 50/52\ \mu\text{s}$ ,<br>$D2 = t_{\text{BUS\_rec}}(\text{MAX})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4)    |       | 0.581 |      |               |
| D3 <sub>LB</sub>                  | Duty Cycle 3<br>J2602 Low battery <sup>(9) (10)</sup>                                                     | $\text{TH}_{\text{REC}}(\text{MAX}) = 0.665 \times V_{\text{SUP}}$ , $\text{TH}_{\text{DOM}}(\text{MAX}) = 0.499 \times V_{\text{SUP}}$ , $V_{\text{SUP}} = 5.5\ \text{V}$ to $7\ \text{V}$ , $t_{\text{BIT}} = 96\ \mu\text{s}$ ,<br>$D1 = t_{\text{BUS\_rec}}(\text{min})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4)         | 0.417 |       |      |               |
| D4 <sub>LB</sub>                  | Duty Cycle 4<br>J2602 Low battery <sup>(9) (10)</sup>                                                     | $\text{TH}_{\text{REC}}(\text{MIN}) = 0.496 \times V_{\text{SUP}}$ , $\text{TH}_{\text{DOM}}(\text{MIN}) = 0.361 \times V_{\text{SUP}}$ , $V_{\text{SUP}} = 6.1\ \text{V}$ to $7.6\ \text{V}$ , $t_{\text{BIT}} = 96\ \mu\text{s}$ ,<br>$D2 = t_{\text{BUS\_rec}}(\text{MAX})/(2 \times t_{\text{BIT}})$ (See Figure 7-3, Figure 7-4)       |       | 0.59  |      |               |

- (1) This is the measured voltage at the WDT pin when left floating. The WDT pin should be connected directly to  $V_{\text{CC}}$ , GND or left floating.
- (2) Specified by design
- (3)  $V_{\text{BATLIN5}} = [(1/7) \times V_{\text{BAT}}] \pm 50\ \text{mV}$  for the linear range of the PV buffer
- (4)  $V_{\text{BATLIN3}} = [(1/9) \times V_{\text{BAT}}] \pm 50\ \text{mV}$  for the linear range of the PV buffer
- (5) SAE J2602 loads include: commander node: 5.5 nF; 4 k $\Omega$  and for a responder node: 5.5 nF; 875  $\Omega$
- (6)  $V_{\text{HYS}}$  is defined for both ISO 17987 and SAE J2602-1.
- (7)  $V_{\text{HYS}} = (V_{\text{th\_rec}} - V_{\text{th\_dom}})$  where  $V_{\text{th\_rec}}$  and  $V_{\text{th\_dom}}$  are the actual voltage values from  $V_{\text{BUSrec}}$  and  $V_{\text{BUSdom}}$
- (8) ISO 17987 loads include 1 nF; 1 k $\Omega$ / 6.8nF; 660  $\Omega$ / 10 nF; 500  $\Omega$ ; with  $t_{\text{BIT}}$  values of 50  $\mu\text{s}$  and 96  $\mu\text{s}$
- (9) SAE J2602 loads include: commander node: 5.5 nF; 4 k $\Omega$ / 899 pF; 20 k $\Omega$  and for a responder node: 5.5 nF; 875  $\Omega$ / 899 pF; 900  $\Omega$ ; with  $t_{\text{BIT}}$  values of 52  $\mu\text{s}$  and 96  $\mu\text{s}$

- (10) ISO 17987 does not have a low battery specification. Using the ISO 17987 loads these low battery duty cycle parameters are covered for  $t_{BIT}$  values of 50  $\mu$ s and 96  $\mu$ s

## 6.8 AC Switching Characteristics

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                               |                                                                                                                                                     | TEST CONDITIONS                                                                                                                                                                                                   | MIN | TYP | MAX | UNIT    |
|-----------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|---------|
| <b>Device Switching Characteristics</b> |                                                                                                                                                     |                                                                                                                                                                                                                   |     |     |     |         |
| $t_{rx\_pdr}$<br>$t_{rx\_pdf}$          | Receiver rising/falling propagation delay time (ISO/DIS 17987 Param 31)                                                                             | $R_{RXD} = 2.4\text{ k}\Omega$ , $C_{RXD} = 20\text{ pF}$ (See <a href="#">Figure 7-3</a> , <a href="#">Figure 7-4</a> )                                                                                          |     |     | 6   | $\mu$ s |
| $t_{rs\_sym}$                           | Symmetry of receiver propagation delay time<br>Receiver rising propagation delay time (ISO/DIS 17987 Param 32)                                      | Rising edge with respect to falling edge, ( $t_{rx\_sym} = t_{rx\_pdf} - t_{rx\_pdr}$ ), $R_{RXD} = 2.4\text{ k}\Omega$ , $C_{RXD} = 20\text{ pF}$ (See <a href="#">Figure 7-3</a> , <a href="#">Figure 7-4</a> ) | -2  |     | 2   | $\mu$ s |
| $t_{LINBUS}$                            | LIN wakeup time (minimum dominant time on LIN bus for wakeup)                                                                                       | See <a href="#">Figure 7-6</a> , <a href="#">Figure 8-11</a> and <a href="#">Figure 8-12</a>                                                                                                                      | 25  | 100 | 150 | $\mu$ s |
| $t_{CLEAR}$                             | Time to clear false wakeup prevention logic if LIN bus had a bus stuck dominant fault (recessive time on LIN bus to clear bus stuck dominant fault) | See <a href="#">Figure 8-12</a>                                                                                                                                                                                   | 10  |     | 60  | $\mu$ s |
| $t_{TXD\_DTO}$                          | Dominant state time out                                                                                                                             |                                                                                                                                                                                                                   | 20  | 45  | 80  | ms      |
| $t_{EN}$                                | Enable pin deglitch time                                                                                                                            | Time enable pin state change before initiating mode change or sampling TXD pin                                                                                                                                    | 3   |     | 12  | $\mu$ s |
| $t_{MODE\_CHANGE}$                      | Mode change delay time                                                                                                                              | Time to change from normal mode to sleep mode through EN pin: See <a href="#">Figure 7-5</a>                                                                                                                      |     |     | 100 | $\mu$ s |
| $t_{DETECT}$                            | Time to detect Pin vs SPI and I/O voltage level at power up <sup>(1)</sup>                                                                          | Time from coming out of $UV_{CC}$ and device determines these states                                                                                                                                              |     |     | 2   | $\mu$ s |
| $t_{DET\_INH}$                          | Time to detect which output INH or WKQR at power up                                                                                                 | Time from coming out of $UV_{CC}$ and device determines these states                                                                                                                                              |     |     | 25  | $\mu$ s |
| $t_{NOMINIT}$                           | Normal mode initialization time                                                                                                                     | Time for normal mode to initialize and data on RXD pin to be valid, includes $t_{MODE\_CHANGE}$ for standby mode to normal mode See <a href="#">Figure 7-5</a>                                                    |     |     | 45  | $\mu$ s |
| $t_{RSTN\_act}$                         | Time required for $V_{CC} \geq UV_{CC}$ to leave Restart mode                                                                                       | $V_{CC} \geq UV_{CC}$                                                                                                                                                                                             | 1.5 | 2   | 2.5 | ms      |
| $t_{nRSTIN}$                            | Input pulse required on the nRST pin to recognize a device reset.                                                                                   |                                                                                                                                                                                                                   | 120 |     |     | $\mu$ s |
| $t_{NRST\_TOG}$                         | nRST pin output toggle high to low to high time                                                                                                     | reg 29h[5] = 0 (Default value in SPI control. Value in pin control except for watchdog failure.)                                                                                                                  | 1.5 | 2   | 2.5 | ms      |
|                                         |                                                                                                                                                     | reg 29h[5] = 1 (Value in pin control for watchdog failure.)                                                                                                                                                       | 10  | 15  | 20  | ms      |
| $t_{INITWD}$                            | Initial long watchdog window time required to trigger first watchdog input trigger when entering Standby mode or Normal mode                        | WDI input trigger or SPI write command                                                                                                                                                                            | 150 |     | 200 | ms      |
| $t_{INACT\_FS}$                         | Timer for inactivity coming out of sleep mode and when coming out of failsafe mode to determine if caused event has been cleared <sup>(1)</sup>     | Default values and can be programmed to different values in SPI control.                                                                                                                                          | 4   | 5   | 6   | min     |
| $t_{PWRUP}$                             | Time from $V_{SUP}$ exceeding $UV_{SUP}$ until INH active                                                                                           | $V_{CC} > UV_{CC}$ , $INH = V_{SUP}$ , $V_{CC}$ load of 50 mA @ 22 $\mu$ F capacitance                                                                                                                            |     |     | 3   | ms      |
|                                         | Time from $V_{SUP}$ exceeding $UV_{SUP}$ and $V_{CC}$ exceeding $UV_{CC}$ until WKQR active                                                         | $V_{CC} > UV_{CC}$ , $WKQR = V_{CC}$ , $V_{CC}$ load of 50 mA @ 22 $\mu$ F capacitance                                                                                                                            |     |     | 3   | ms      |
| $t_{TOGGLE}$                            | RXD pulse width when waking from sleep mode                                                                                                         | register 'h12[2] = 1                                                                                                                                                                                              | 5   |     | 15  | $\mu$ s |
| $t_{UVFLTR}$                            | Undervoltage detection delay time for $V_{CC}$                                                                                                      |                                                                                                                                                                                                                   | 3   |     | 4   | ms      |
| $t_{VSC}$                               | Short to ground on VCC detection delay time                                                                                                         |                                                                                                                                                                                                                   | 75  | 100 | 130 | $\mu$ s |
| $t_{LDOON}$                             | Time LDO is on to determine if a short circuit event is present after a previous uncleared detection                                                |                                                                                                                                                                                                                   | 2   |     | 3   | ms      |
| $t_{MODE\_STBY\_NOM}$                   | Standby to normal mode change time based upon SPI write                                                                                             |                                                                                                                                                                                                                   |     |     | 70  | $\mu$ s |
| $t_{MODE\_NOM\_SLP}$                    | SPI write to go to sleep from normal                                                                                                                | Time from SPI sleep command where LIN transceiver is off and RXD doesn't reflect the LIN bus                                                                                                                      |     |     | 200 | $\mu$ s |

## 6.8 AC Switching Characteristics (continued)

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER                                  |                                                                                                 | TEST CONDITIONS                                                                                                    | MIN  | TYP | MAX  | UNIT |
|--------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------|------|-----|------|------|
| t <sub>MODE_NOM_STBY</sub>                 | SPI write to go to standby from normal mode                                                     |                                                                                                                    |      |     | 70   | μs   |
| t <sub>WKRQ_SLP</sub>                      | Time WKRQ turns on after a wake event when device is in sleep mode                              | Dependent upon LDO turning on and ramp time. Time provided is based upon 1 μs ramp and LDO being at 2 V.           | 450  |     |      | μs   |
| t <sub>INH_SLP</sub>                       | Time INH turns on after a wake event when device is in sleep mode                               |                                                                                                                    |      |     | 210  | μs   |
| t <sub>INH_NOM_SLP</sub>                   | SPI write to go to sleep from normal mode and INH turns off                                     |                                                                                                                    |      |     | 70   | μs   |
| t <sub>WK_WIDTH_MIN</sub>                  | Minimum WAKE pin pulse width (SPI mode only) <sup>(2) (3) (4)</sup>                             | Minimum WAKE Pin pulse width Register 8'h11[3:2] = 00b; See <a href="#">Figure 8-46</a>                            | 10   |     |      | ms   |
|                                            |                                                                                                 | Minimum WAKE Pin pulse width Register 8'h11[3:2] = 01b; See <a href="#">Figure 8-46</a>                            | 20   |     |      | ms   |
|                                            |                                                                                                 | Minimum WAKE Pin pulse width Register 8'h11[3:2] = 10b; See <a href="#">Figure 8-46</a>                            | 40   |     |      | ms   |
|                                            |                                                                                                 | Minimum WAKE Pin pulse width Register 8'h11[3:2] = 11b; See <a href="#">Figure 8-46</a>                            | 80   |     |      | ms   |
| t <sub>WK_WIDTH_INVALID</sub>              | Maximum Pulse width that is considered invalid (SPI mode only) <sup>(2) (3)</sup>               | Maximum WAKE Pin pulse width that is considered invalid Register 8'h11[3:2] = 00b; See <a href="#">Figure 8-46</a> |      |     | 5    | ms   |
|                                            |                                                                                                 | Maximum WAKE Pin pulse width that is considered invalid Register 8'h11[3:2] = 01b; See <a href="#">Figure 8-46</a> |      |     | 10   | ms   |
|                                            |                                                                                                 | Maximum WAKE Pin pulse width that is considered invalid Register 8'h11[3:2] = 10b; See <a href="#">Figure 8-46</a> |      |     | 20   | ms   |
|                                            |                                                                                                 | Maximum WAKE Pin pulse width that is considered invalid Register 8'h11[3:2] = 11b; See <a href="#">Figure 8-46</a> |      |     | 40   | ms   |
| t <sub>WK_WIDTH_MAX</sub>                  | Maximum WAKE pin pulse width to be considered valid (SPI mode only) <sup>(2)</sup>              | Maximum WAKE Pin pulse window Register 8'h11[1:0] = 00b; See <a href="#">Figure 8-46</a>                           | 750  |     | 950  | ms   |
|                                            |                                                                                                 | Maximum WAKE Pin pulse window Register 8'h11[1:0] = 01b; See <a href="#">Figure 8-46</a>                           | 1000 |     | 1250 | ms   |
|                                            |                                                                                                 | Maximum WAKE Pin pulse window Register 8'h11[1:0] = 10b; See <a href="#">Figure 8-46</a>                           | 1500 |     | 1875 | ms   |
|                                            |                                                                                                 | Maximum WAKE Pin pulse window Register 8'h11[1:0] = 11b; See <a href="#">Figure 8-46</a>                           | 2000 |     | 2500 | ms   |
| t <sub>WK_CYC</sub>                        | Sampling window for cyclic sensing wake; Standby or Sleep mode; see <a href="#">Figure 8-49</a> | Register 8'h12[5] = 0                                                                                              | 10   | 30  | 40   | μs   |
|                                            |                                                                                                 | Register 8'h12[5] = 1                                                                                              | 60   | 75  | 90   | μs   |
| Fast Mode                                  |                                                                                                 |                                                                                                                    |      |     |      |      |
| DR                                         | Data Rate                                                                                       | 5.5 V ≤ V <sub>SUP</sub> ≤ 18 V, R <sub>LIN</sub> = 500 Ω and C <sub>LIN(bus)</sub> = 600 pF                       |      |     | 200  | kbps |
| t <sub>rx_pdr</sub><br>t <sub>rx_pdf</sub> | Receiver rising/falling propagation delay time (ISO/DIS 17987 Param 31)                         | R <sub>RXD</sub> = 2.4 kΩ, C <sub>RXD</sub> = 20 pF (See <a href="#">Figure 7-3</a> , <a href="#">Figure 7-4</a> ) |      |     | 5    | μs   |
| t <sub>txrf</sub>                          | LIN transmitter rise and fall time                                                              | 5.5 V ≤ V <sub>SUP</sub> ≤ 18 V, R <sub>LIN</sub> = 500 Ω and C <sub>LIN(bus)</sub> = 600 pF, 80%/20%              |      |     | 1.5  | μs   |
| t <sub>FM_CHANGE</sub>                     | Fast mode determination time for entering or leaving                                            | Based upon EN and TXD voltage levels                                                                               | 70   | 90  | 110  | μs   |
| t <sub>FMTXD</sub>                         | TXD pin pulse width to enter fast mode                                                          | Pulse must start after t <sub>EN</sub> and finish before t <sub>FM_CHANGE</sub>                                    | 5    |     | 25   | μs   |
| SPI Switching Characteristics              |                                                                                                 |                                                                                                                    |      |     |      |      |
| f <sub>SCK</sub>                           | SCK, SPI clock frequency <sup>(1)</sup>                                                         |                                                                                                                    |      |     | 4    | MHz  |
| t <sub>SCK</sub>                           | SCK, SPI clock period <sup>(1)</sup>                                                            | See <a href="#">Figure 7-7</a>                                                                                     | 250  |     |      | ns   |
| t <sub>RSCK</sub>                          | SCK rise time <sup>(1)</sup>                                                                    | See <a href="#">Figure 7-7</a>                                                                                     |      |     | 40   | ns   |
| t <sub>FSCK</sub>                          | SCK fall time <sup>(1)</sup>                                                                    | See <a href="#">Figure 7-7</a>                                                                                     |      |     | 40   | ns   |
| t <sub>SCKH</sub>                          | SCK, SPI clock high <sup>(1)</sup>                                                              | See <a href="#">Figure 7-7</a>                                                                                     | 125  |     |      | ns   |

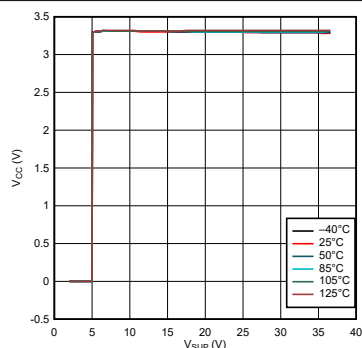
## 6.8 AC Switching Characteristics (continued)

parameters valid over  $-40^{\circ}\text{C} \leq T_J \leq 150^{\circ}\text{C}$  range (unless otherwise noted)

| PARAMETER         |                                                        | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------|--------------------------------------------------------|-----------------|-----|-----|-----|------|
| t <sub>SCKL</sub> | SCK, SPI clock low <sup>(1)</sup>                      | See Figure 7-7  | 125 |     |     | ns   |
| t <sub>ACC</sub>  | First read access time from chip select <sup>(1)</sup> | See Figure 7-7  | 50  |     |     | ns   |
| t <sub>CSS</sub>  | Chip select setup time <sup>(1)</sup>                  | See Figure 7-7  | 100 |     |     | ns   |
| t <sub>CSH</sub>  | Chip select hold time <sup>(1)</sup>                   | See Figure 7-7  | 100 |     |     | ns   |
| t <sub>CSD</sub>  | Chip select disable time <sup>(1)</sup>                | See Figure 7-7  | 50  |     |     | ns   |
| t <sub>SISU</sub> | Data in setup time <sup>(1)</sup>                      | See Figure 7-7  | 50  |     |     | ns   |
| t <sub>SIH</sub>  | Data in hold time <sup>(1)</sup>                       | See Figure 7-7  | 50  |     |     | ns   |
| t <sub>SOV</sub>  | Data out valid <sup>(1)</sup>                          | See Figure 7-7  |     |     | 80  | ns   |
| t <sub>RSO</sub>  | SO rise time <sup>(1)</sup>                            | See Figure 7-7  |     |     | 40  | ns   |
| t <sub>FSO</sub>  | SO fall time <sup>(1)</sup>                            | See Figure 7-7  |     |     | 40  | ns   |

- (1) Specified by design
- (2) This parameter is valid only when register 11h[7:6] = 11b
- (3) This is the minimum pulse width for a WAKE pin input that device will detect as a good pulse. Values between the min t<sub>WK\_WIDTH\_MIN</sub> and max t<sub>WK\_WIDTH\_INVALID</sub> is indeterminant and may or may not be considered valid.
- (4) This parameter is set based upon the programmed value for t<sub>WK\_WIDTH\_INVALID</sub> register 11h[3:2]

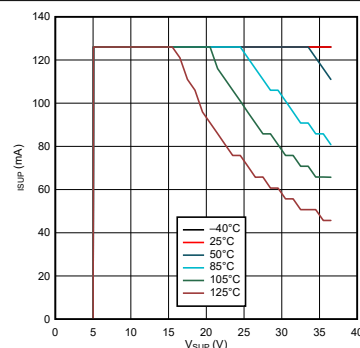
## 6.9 Typical Characteristics



$V_{CC} = 3.3\text{ V}$   $I_{CC} = 125\text{ mA load}$  Temperature = Ambient

Mode = Power up LIN = Recessive to Standby

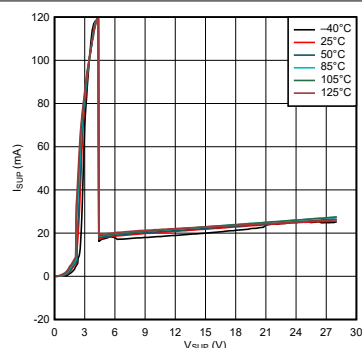
Figure 6-1. TLIN14313RGYQ1  $V_{CC}$  versus  $V_{SUP}$  Ramping Up



$V_{CC} = 3.3\text{ V}$   $I_{CC} = 125\text{ mA load}$  Temperature = Ambient

Mode = Power up LIN = Recessive to Standby

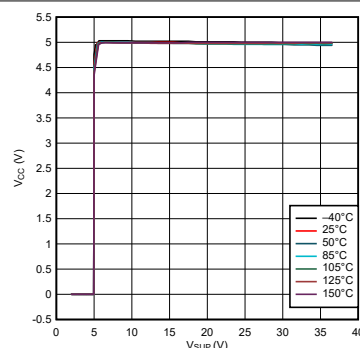
Figure 6-2. TLIN14313RGYQ1  $I_{SUP}$  versus  $V_{SUP}$  Ramping Up



$V_{CC} = \text{Off}$   $I_{CC} = \text{Off}$  Temperature = Ambient

Mode = Sleep LIN = Recessive

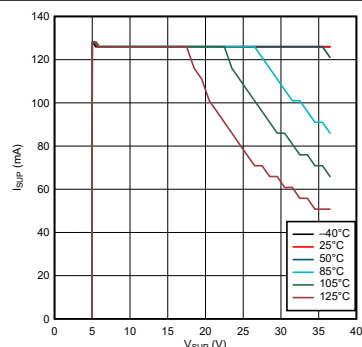
Figure 6-3. TLIN14313RGYQ1  $I_{SUP}$  versus  $V_{SUP}$  Ramping Down



$V_{CC} = 5\text{ V}$   $I_{CC} = 125\text{ mA load}$  Temperature = Ambient

Mode = Power up LIN = Recessive to Standby

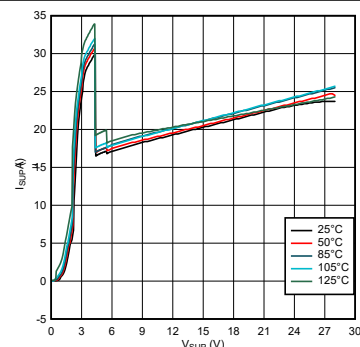
Figure 6-4. TLIN14315RGYQ1  $V_{CC}$  versus  $V_{SUP}$  Ramping Up



$V_{CC} = 5\text{ V}$   $I_{CC} = 125\text{ mA load}$  Temperature = Ambient

Mode = Power up LIN = Recessive to Standby

Figure 6-5. TLIN14315RGYQ1  $I_{SUP}$  versus  $V_{SUP}$  Ramping Up



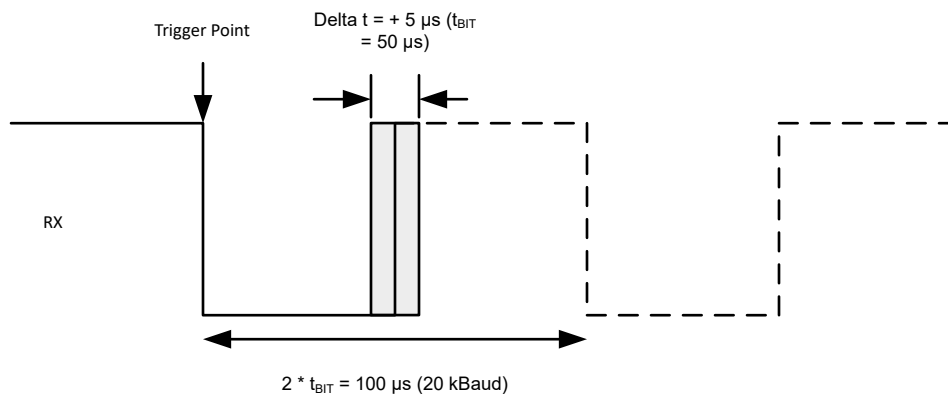
$V_{CC} = \text{Off}$   $I_{CC} = \text{Off}$  Temperature = Ambient

Mode = Sleep LIN = Recessive

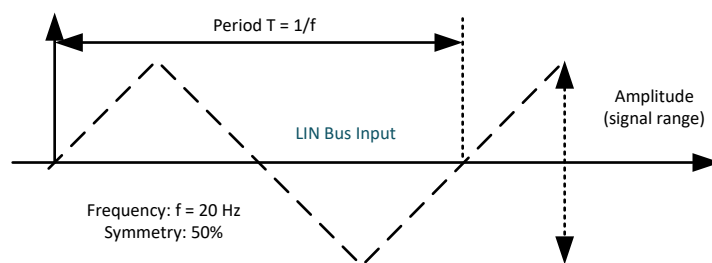
Figure 6-6. TLIN14315RGYQ1  $I_{SUP}$  versus  $V_{SUP}$  Ramping Down

## 7 Parameter Measurement Information

### 7.1 Test Circuit: Diagrams and Waveforms



**Figure 7-1. RX Response: Operating Voltage Range**



**Figure 7-2. LIN Bus Input Signal**

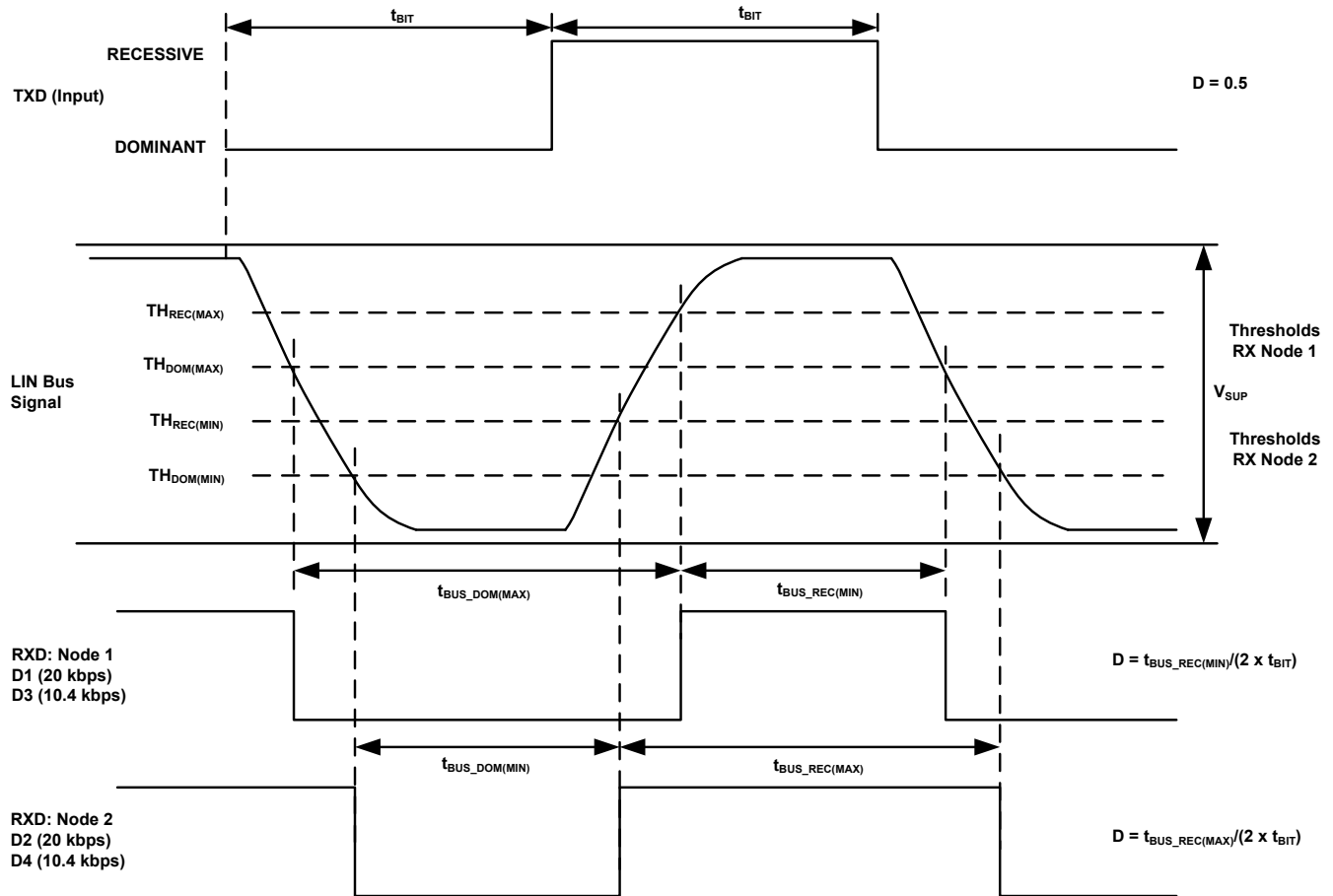


Figure 7-3. Definition of Bus Timing

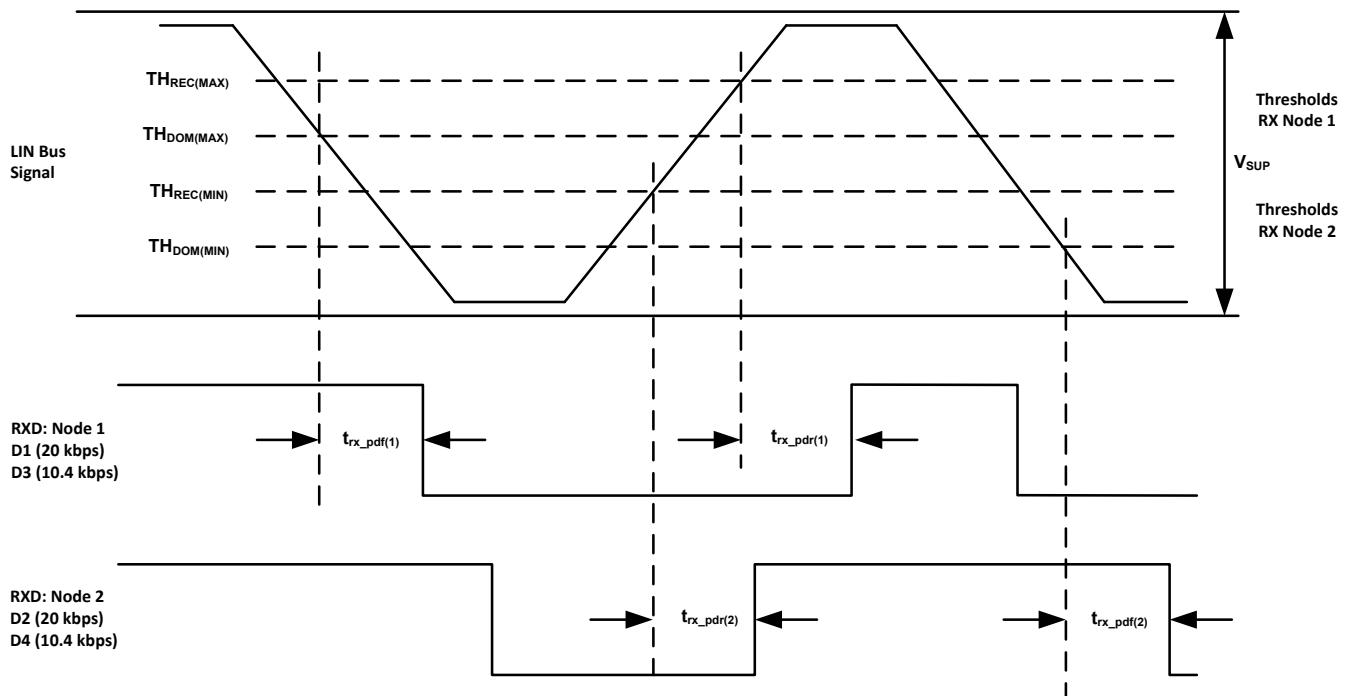
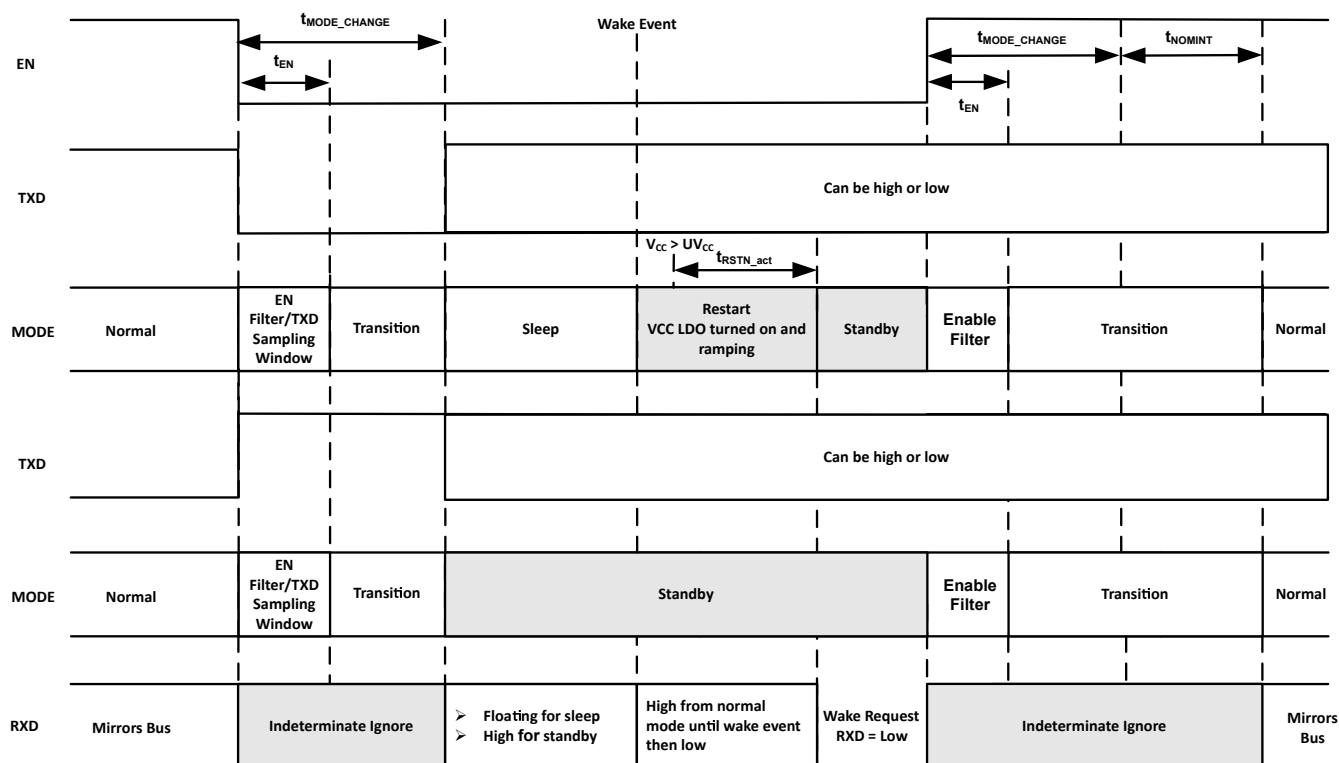


Figure 7-4. Propagation Delay



**Figure 7-5. Mode Transitions (Pin Control)**

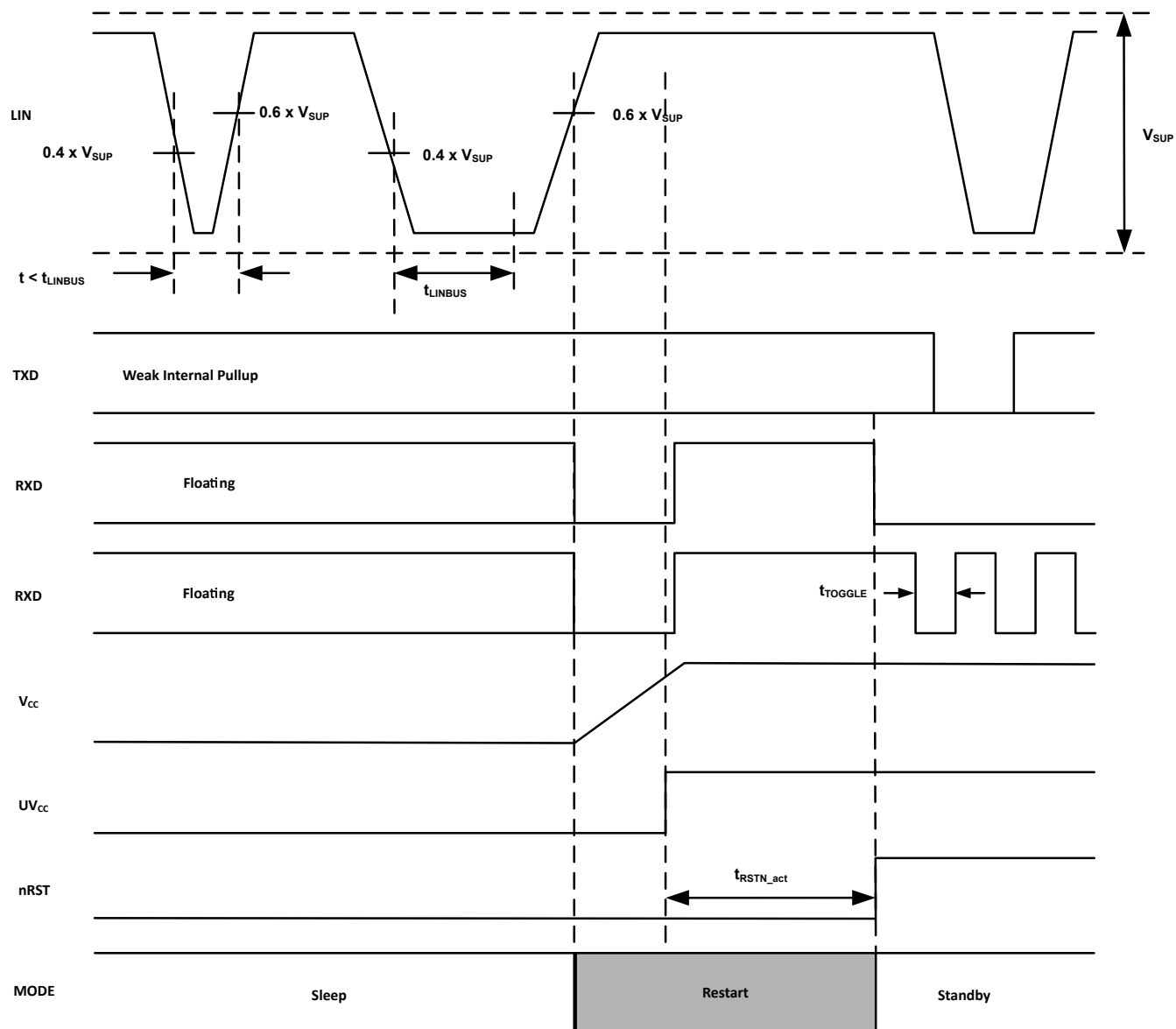
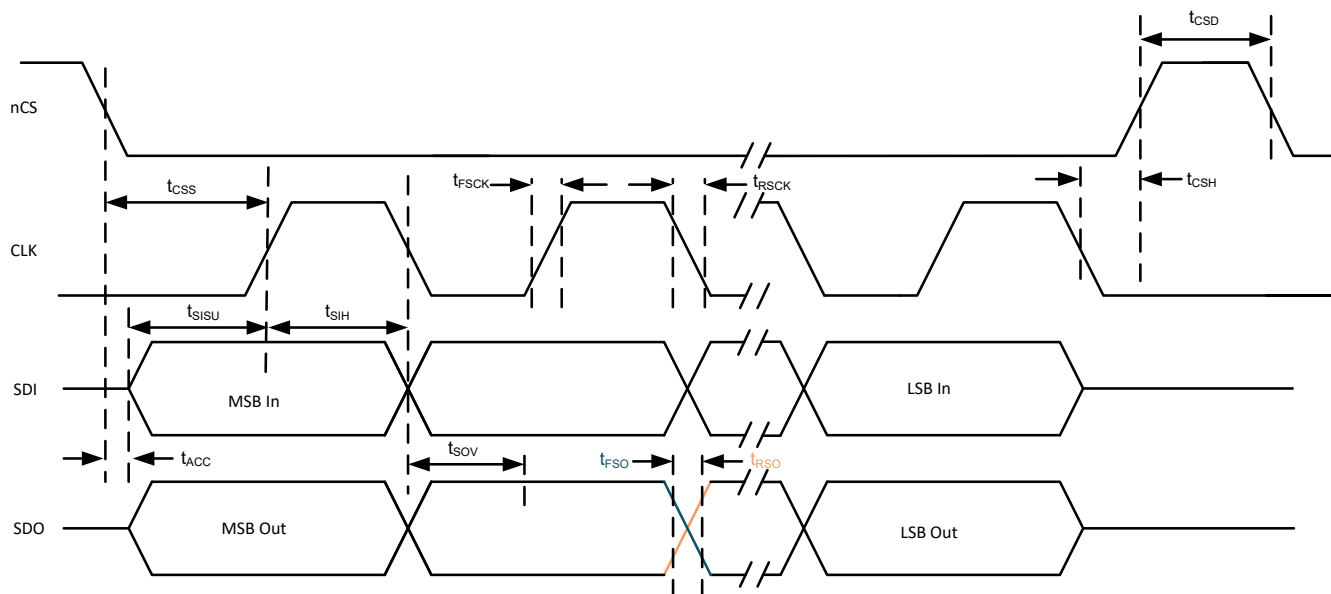
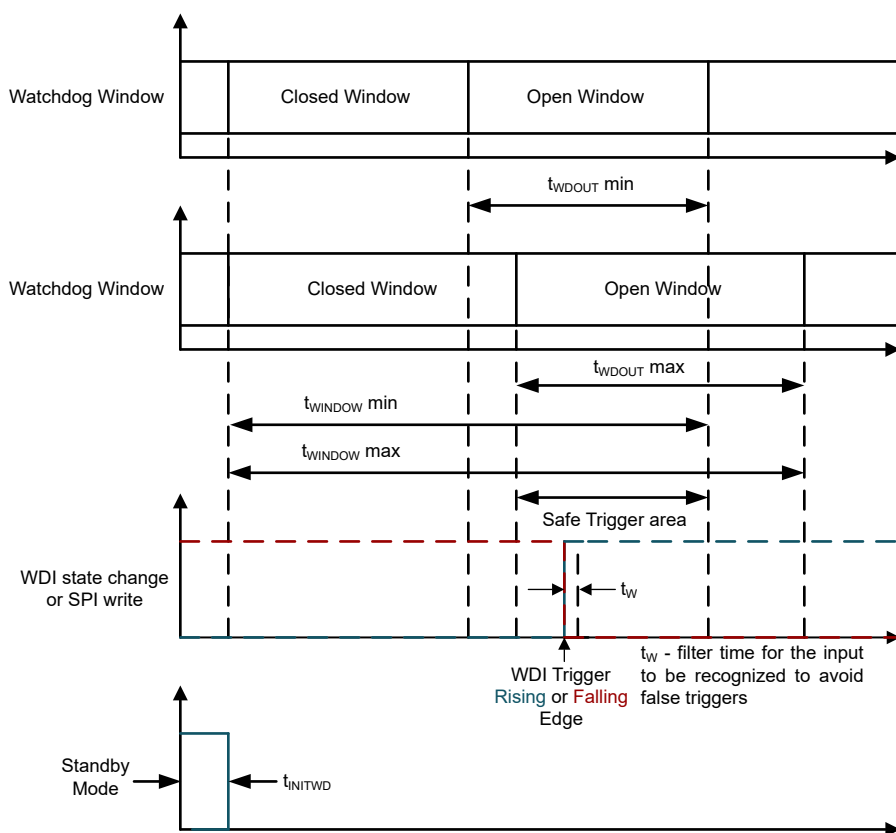


Figure 7-6. Wakeup through LIN



**Figure 7-7. SPI AC Characteristic for Read and Write**



**Figure 7-8. Watchdog Window Timing Diagram**

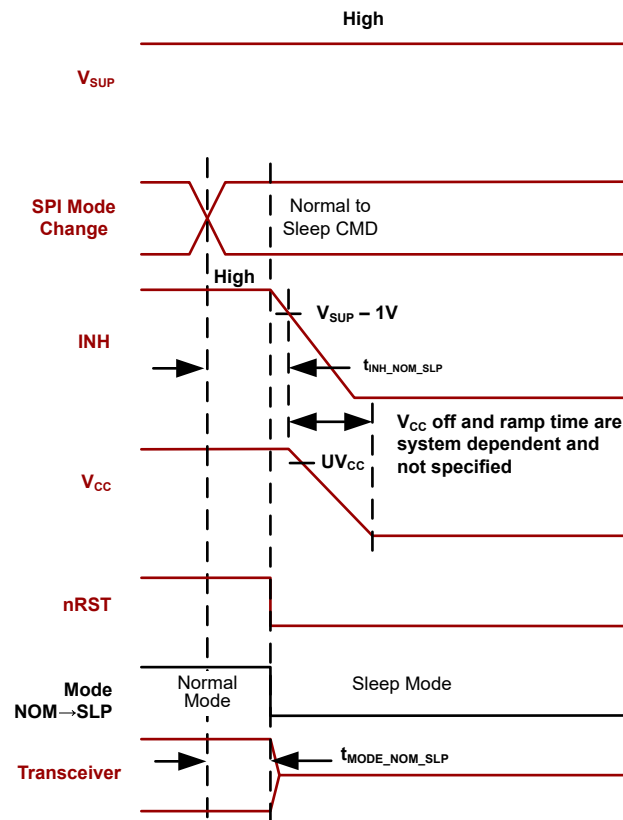


Figure 7-9. Normal to Sleep via SPI

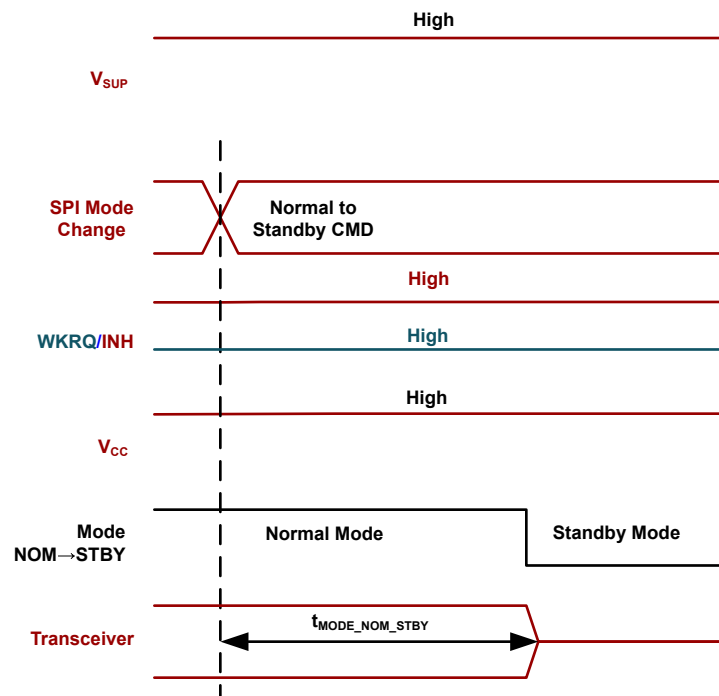
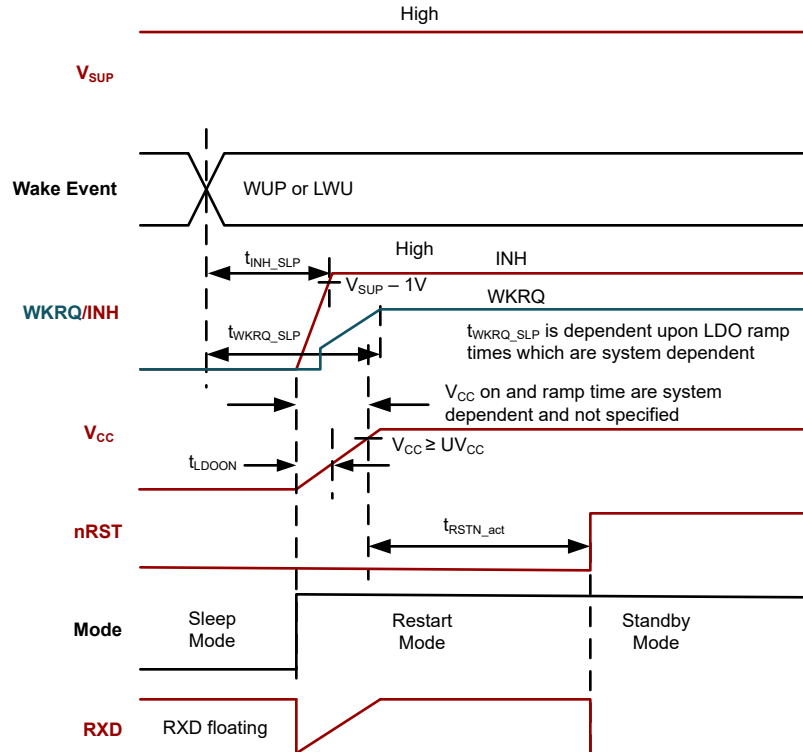


Figure 7-10. Normal to Standby via SPI



**Figure 7-11. Sleep to Restart to Standby Mode from Wake Event**

#### Note

Throughout the document timing diagrams may have three colors associated to them.

- Red are signals on device pins
- Teal represent the WKRQ pin when configured as WKRQ
- Black will represent either internal signals or an external signal that will impact device behavior

## 8 Detailed Description

### 8.1 Overview

The TLIN1431x-Q1 LIN transceiver is a Local Interconnect Network (LIN) physical layer transceiver, compliant to LIN 2.0, LIN 2.1, LIN 2.2, LIN 2.2A, ISO 17987–4:2016, and SAE J2602:2021 with integrated wake-up and protection features. The LIN bus is a single-wire, bi-directional bus that typically is used in low speed in-vehicle networks with data rates that range up to 20 kbps. The device LIN receiver works up to 100 kbps supporting in-line programming in normal mode. When the device is placed into fast mode, both the transmitter and receiver support up to 200 kbps. The device converts the LIN protocol data stream on the TXD input into a LIN bus signal using a current-limited wave-shaping driver which reduces electromagnetic emissions (EME). The receiver converts the data stream to logic level signals that are sent to the microprocessor through the RXD pin. The LIN bus has two states: dominant state (voltage near ground) and recessive state (voltage near battery). In the recessive state, the LIN bus is pulled high by the internal pull-up resistor (45 k $\Omega$ ) and a series diode.

Ultra-low current consumption is possible using the sleep mode. The TLIN1431x-Q1 provides three methods to wake up from sleep mode: EN pin, WAKE pin and LIN bus in pin control mode and two in SPI control mode, WAKE pin and LIN bus. The device integrates a low dropout voltage regulator with a wide input from  $V_{SUP}$  providing 5 V  $\pm 2.5\%$  or 3.3 V  $\pm 2.5\%$  with up to 125 mA of current depending upon system implementation.

The TLIN1431x-Q1 integrates a window-based watchdog supervisor which has a programmable delay and window ratio determined by pin strapping or SPI communication. The device watchdog is controlled by pin configuration or SPI depending upon the state of pin 7 at power up. During power up, if pin 7 is externally pulled to ground, the device is configured for pin control and all digital IO voltage levels will be dependent upon  $V_{CC}$ . If pin 7 is left floating or pulled up to  $V_{CC}$  the device is controlled by SPI communication and the pin becomes the nCS pin. For the 5 V  $V_{CC}$  version, the digital IO voltage levels are also determined during power up when the device is configured for SPI communication control. If pin 7 is left floating at power up, the internal pull up configures the device for 3.3 V SPI control. This means that all the digital IO for the device will be configured for 3.3 V electrical levels. If the processor needs 5 V IO, a 500 k $\Omega$  pull up resistor to the TLIN1431x-Q1  $V_{CC}$  pin will configure all digital IOs 5 V electrical levels. This allows the 5 V version of the device to work with both 3.3 V processors or 5 V processors. SPI communication is used for device configuration. This sets not only the SPI pins but also WKRQ, nRST, FSO, nINT, TXD and RXD pins. In pin configuration, nRST is asserted high when  $V_{CC}$  increases above  $UV_{CC}$  and stays high as long as  $V_{CC}$  is above this threshold and the device is not in restart mode.

When the watchdog is controlled by the device pins, the state of the WDT pin determines the window time. WDI is used as the watchdog input trigger which is expected in the open window. If a watchdog error event takes place, the nWDR pin goes low to reset the processors. When using SPI writing FFh to register 15h, WD\_INPUT\_TRIG, during the open window restarts the watchdog timer. The supervised processor must trigger the WDI pin or WD\_INPUT\_TRIG register within the defined window. When using SPI, the nRST pin can become the watchdog event output trigger for the processor if programmed this way, but the nRST function is lost. The watchdog timer has a long initial window when entering standby, normal and fast modes that a watchdog input trigger is expected.

## 8.2 Functional Block Diagram

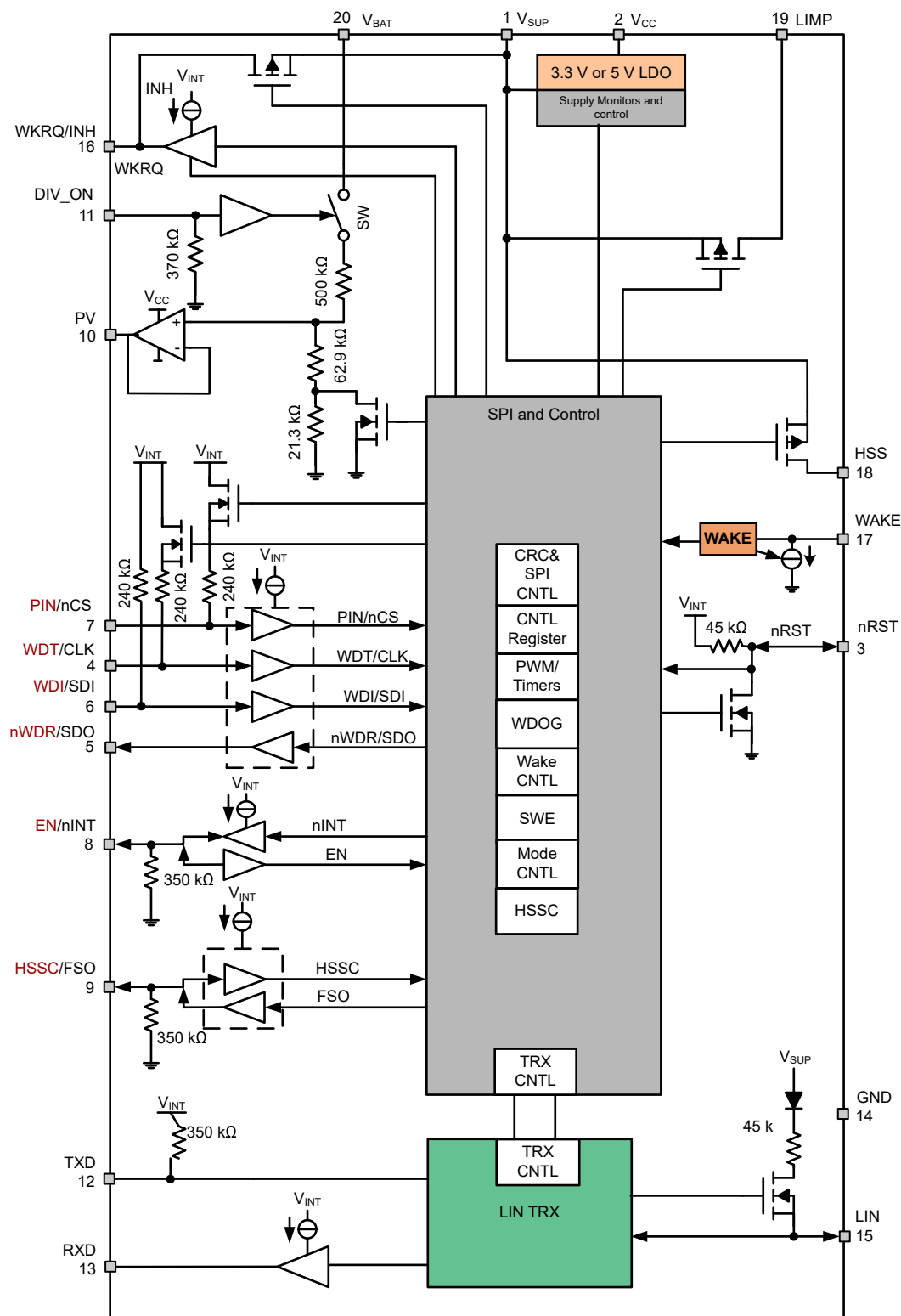


Figure 8-1. High Level Block Diagram

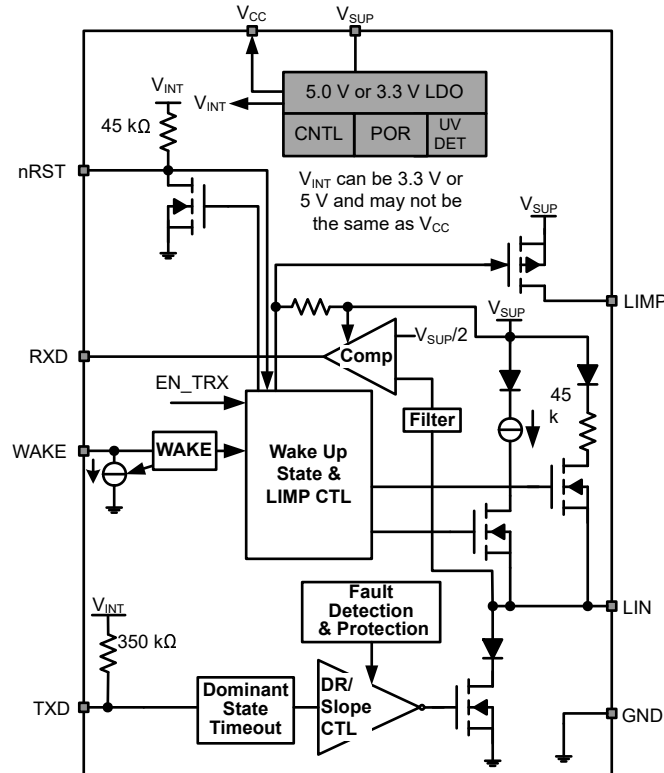


Figure 8-2. Transceiver plus VREG Functional Block Diagram

## 8.3 Feature Description

### 8.3.1 LIN (Local Interconnect Network) Bus

This high voltage input or output pin is a single wire LIN bus transmitter and receiver. The LIN pin can survive transient voltages up to 58 V. Reverse currents from the LIN to supply ( $V_{SUP}$ ) are minimized with blocking diodes, even in the event of a ground shift or loss of supply ( $V_{SUP}$ ).

#### 8.3.1.1 LIN Transmitter Characteristics

The transmitter meets thresholds and AC parameters according to the LIN specification. The transmitter is a low side transistor with internal current limitation and thermal shutdown. During a thermal shutdown condition, the transmitter is disabled to protect the device. There is an internal pull-up resistor with a serial diode structure to  $V_{SUP}$ , so no external pull-up components are required for the LIN responder node applications. An external pull-up resistor and series diode to  $V_{SUP}$  must be added when the device is used for a commander node application. In fast mode, the transmitter can support 200 kbps data rates.

#### 8.3.1.2 LIN Receiver Characteristics

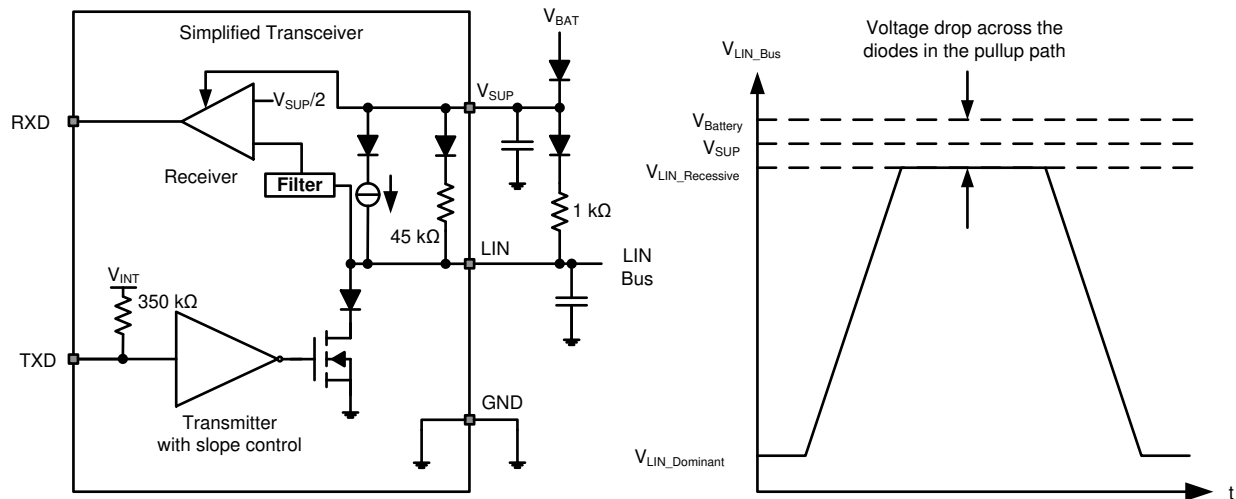
The receiver characteristic thresholds are ratiometric with the device supply pin according to the LIN specification.

The receiver is capable of receiving higher data rates (>100 kbps) than supported by LIN or SAEJ2602 specifications. This allows the TLIN1431x-Q1 to be used for high speed downloads at the end-of-line production or other applications. The actual data rate achievable depends on system time constants (bus capacitance and pull-up resistance) and driver characteristics used in the system. In fast mode the receiver can support 200 kbps.

##### 8.3.1.2.1 Termination

There is an internal pull-up resistor with a serial diode structure to  $V_{SUP}$ , so no external pull-up components are required for the LIN responder node applications. An external pull-up resistor (1 kΩ) and a series diode to  $V_{SUP}$  must be added when the device is used for commander node applications as per the LIN specification (ISO 17987-4).

Figure 8-3 shows a Commander Node configuration and how the voltage levels are defined.



**Figure 8-3. Commander Node Configuration with Voltage Levels**

### 8.3.2 TXD (Transmit Input and Output)

TXD is the interface to the node processor LIN protocol controller that is used to control the state of the LIN output. When TXD is low, the LIN output is dominant (near ground). When TXD is high, the LIN output is recessive (near  $V_{SUP}$ ). See Figure 8-3. The TXD input structure is compatible with processors with 3.3 V and 5 V logic I/O. TXD has an internal pull-up resistor to an internal voltage rail that either matches the processor I/O voltage rail or the LDO output rail,  $V_{CC}$  which is determined by the state of pin 7 at power up. The LIN bus is protected from being stuck dominant through a system failure driving TXD low through the dominant state timeout timer. The TXD pin is also used to help determine what mode to enter in pin control mode.

### 8.3.3 RXD (Receive Output)

RXD is the interface to the processors LIN protocol controller or SCI and UART, which reports the state of the LIN bus voltage. LIN recessive (near  $V_{SUP}$ ) is represented by a high level on the RXD and LIN dominant (near ground) is represented by a low level on the RXD pin. This device architecture allows the device to be used with 3.3 V and 5 V I/O processors. The RXD pin is a push-pull buffer and as such an external pull-up is not needed. In restart mode, the RXD pin is driven high. When  $V_{CC} > UV_{CC}$  for  $t_{RSTN\_act}$ , the device automatically transitions to standby mode causing RXD is then pulled low to indicate a wake-up request. The RXD pin can be programmed to toggle low or high to indicate a wake up request with a pulse width of  $t_{TOGGLE}$ , see Figure 7-6 as an example of this feature.

### 8.3.4 WAKE (High Voltage Local Wake Up Input)

WAKE pin is used for a high voltage device local wake up (LWU). This function is explained further in [Local Wake Up \(LWU\) via WAKE Terminal](#) section. The pin is both rising and falling edge trigger, meaning it recognizes a LWU on either edge of WAKE pin transition. The pin can be configured to accept a pulse, see Figure 8-46 for timing diagram of this behavior. WAKE pin is also used as part of the cyclic sensing wake, see [Cyclic Sense Wake](#). Registers [WAKE\\_PIN\\_CONFIG1 Register \(Address = 11h\) \[reset = 04h\]](#) and [WAKE\\_PIN\\_CONFIG2 Register \(Address = 12h\) \[reset = 2h\]](#) provide the various configurations for the WAKE pin.

### 8.3.5 WDT or CLK (Pin Programmable Watchdog Delay Input or SPI Clock)

When configured for pin control, the WDT or CLK pin becomes the pin programmable watchdog delay input, WDT. This pin sets the upper boundary of the window watchdog. It can be connected to  $V_{CC}$ , connected to GND, or left floating. When connected directly to  $V_{CC}$  or GND or left open, the window frame takes on one of three value ranges: GND – 32 ms to 48 ms,  $V_{CC}$  – 480 ms to 720 ms or left open – 4.8 s to 7.2 s. The closed versus open windows are based upon 50%/50%.

When configured for SPI control, the WDT/CLK pin becomes the SPI input clock, CLK. When configured as the CLK pin there is a 240 k $\Omega$  pull-up to  $V_{INT}$  enabled.

### 8.3.6 WDI or SDI (Watchdog Timer Input or SPI Serial Data In)

When configured for pin control, the WDI or SDI pin becomes the watchdog timer input trigger, WDI. This resets the timer with either a positive or negative transition from the processor. A filter time of  $t_W$  is used to avoid false triggers.

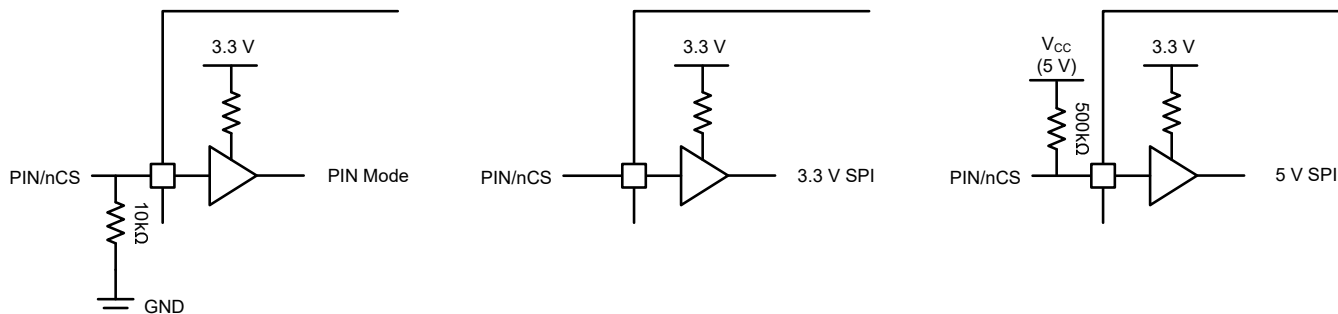
When configured for SPI control, the WDI/SDI pin becomes the SPI serial data input pin, SDI.

### 8.3.7 PIN or nCS (Pin Watchdog Select or SPI Chip Select)

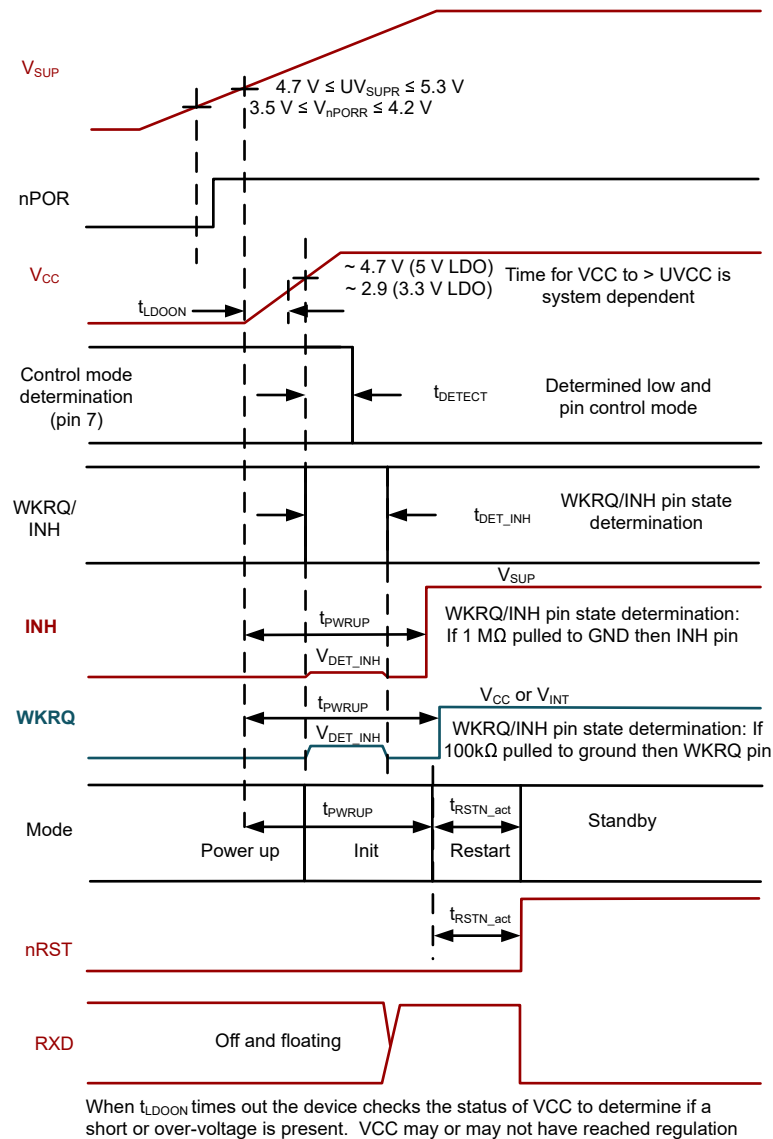
This pin determines if the TLIN1431x-Q1 watchdog and mode changes are controlled by pin or SPI. At power up, the device monitors this pin and determine which method is to be used. When tied to GND, the device is pin programmable, see Figure 8-5. When connected to a high-Z processor IO pin or pulled up, the device is set up to support SPI, see Figure 8-6. In SPI control mode, if the LDO is being used to power up circuitry other than the processor a mismatch can take place. An example of this is using the TLIN14315-Q1  $V_{CC}$  to power up a 5 V sensor and the processor supports 3.3 V IO electrical levels. This is accomplished by letting the PIN/nCS pin float at power up which configures the internal IO electrical levels to  $V_{INT}$  which is 3.3 V. For the IO to be 5 V, an external 500 k $\Omega$  resistor needs to be pulled up to the 5 V  $V_{CC}$  pin. This makes the IO 5 V. See Figure 8-4 to understand the three ways this pin can be connected for the 5 V LDO device.

#### Note

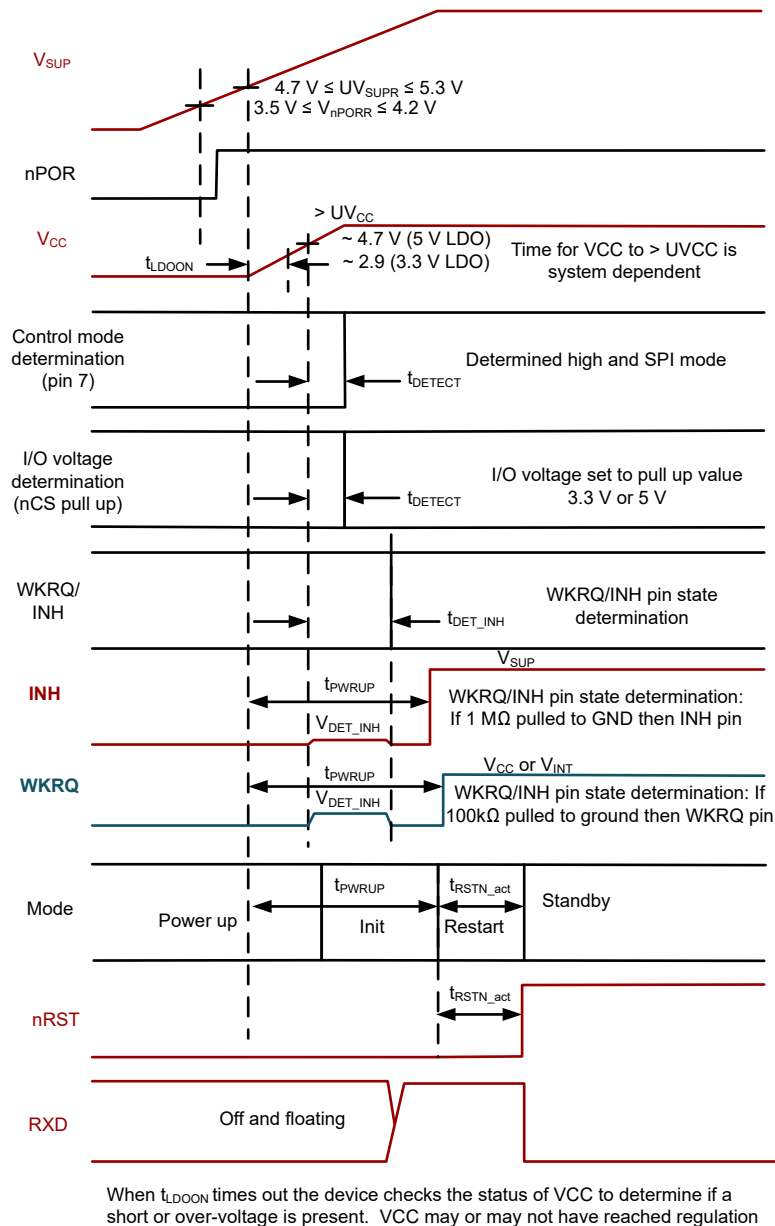
The behavior of the microprocessor used must be understood if connecting to this pin to control whether the device is to be pin controlled or SPI controlled. There is an internal pull-up that sets the device in SPI control mode. If the processor pin drives low during power up, the device is in pin control mode. To specify pin control mode place an external pull-down resistor to ground.



**Figure 8-4. PIN/nCS configuration**



**Figure 8-5. Power up timing diagram for pin 7 connected to ground**



**Figure 8-6. Power up timing diagram for pin 7 pulled high up**

### 8.3.8 LIMP (Limp Home Output – High Voltage Open Drain Output)

The default configuration for the LIMP pin is used for the limp home function. When in the LIMP configuration, the pin is connected to external circuitry for a limp home function due to various fault conditions explained in the device functional mode sections. The LIMP pin can be configured as other functions in SPI control mode, but only performs the limp home function in pin control mode.

#### 8.3.8.1 LIMP in Pin Control Mode

In pin control mode, LIMP is the only function the LIMP pin can perform. The LIMP pin turns on for all faults that cause the device to enter fail-safe mode to provide the limp home function. To exit fail-safe mode, a wake event must take place and the fault condition is cleared or the SWE timer times out. When any non-watchdog fault caused the device to enter fail-safe mode, the LIMP pin will turn off automatically after exiting fail-safe mode. When exiting fail-safe mode due to a watchdog fault, the LIMP pin is still on until the device transitions to standby mode and three correct watchdog input events take place thus turning off the LIMP pin. If this first event is missed, the device enters fail-safe.

### 8.3.8.2 LIMP in SPI Control Mode

In SPI control mode, the LIMP pin defaults to the limp home function. When fail-safe mode is enabled (default on) the pin behaves the same as stated in pin control mode with the exception of every watchdog error causing a reset. Programming register 8'h1A[3:2], LIMP\_SEL\_RESET, determines the condition for the LIMP pin to turn off. The three modes that the LIMP pin changes state is normal, fail-safe and standby mode. When in normal and standby mode the LIMP pin is off unless there is a watchdog failure event, which turns on the LIMP pin. When entering these two modes, there is an initial long window requiring a watchdog input trigger. This is treated as a WD failure and LIMP pin turns on if the window is missed. Any event that causes the device to enter fail-safe mode also turns on the LIMP pin. LIMP is turned off once the device enters standby mode from fail-safe mode except for a watchdog error as described previously. When fail-safe mode is disabled, a WD input failure causes the LIMP pin to turn on, and the device enters restart mode.

If the LIMP function is not needed, this pin can be configured to support either a high side switch in SPI mode by using register 8'h1B[7:6] = 01b or to the INH function by setting register 8'h1B[7:6] = 10b. When configured as a high side switch, the pin can support the same load as the HSS pin, but does not have the open load and over current detection features. When used as a high side switch, timing control is configurable using on/off, PWM or timer based. When using PWM, PWM1 or PWM2 can be assigned. When using the timer, timer1 or timer2 and be assigned.

### 8.3.9 nWDR/SDO (Watchdog Timeout Reset Output/SPI Serial Data Out)

When configured for pin control, the nWDR/SDO pin becomes the watchdog reset output pin, nWDR. When the watchdog times out, this pin goes low for time of 15 ms and then releases back to  $V_{CC}$ .

When configured for SPI control, the nWDR/SDO pin becomes the SPI serial data output pin, SDO.

### 8.3.10 HSS (High-side Switch)

This pin supports a high-side switch supporting up to a 100 mA load with 60 mA being typical with a 14 V  $V_{SUP}$ . In SPI mode, the HSS can be programmed to support a 200 Hz or 400 Hz 10-bit PWM. PWM1 or PWM2 can be assigned to the HSS. The HSS can be configured to use one of two timers that allows it to work with the WAKE pin. This supports cyclic sensing for sleep mode thus reducing sleep mode current. In pin mode this pin is controlled by the HSSC pin.

The switch supports open load detection and over current detection. When an over current is detected, there is a filter time,  $t_{OCFLTR}$ , to determine if over current is valid. If valid there is a shut off time,  $t_{OCOFF}$ , time for the HSS to shut off. When the HSS shuts off due to an over current event the HSS has to be re-enabled. This is accomplished differently depending upon whether the device is in pin control or SPI control. If in SPI control it will also depend upon how the HSS is configured.

#### Pin Control:

- HSS is controlled by the input signal on the HSSC pin.
- Once the over current fault is removed a high to low transition on the HSSC pin will re-enable the HSS output.

#### SPI Control and HSS\_EN; 8'h1E[7] = 1b (enabled):

- When HSS is configured as On or HSSC controlled, HSS\_CNTL 8'h1E[6:4] = 000b or 101b, the HSS will have to have the HSS\_EN; 8'h1E[7] set to 0b (disabled) and then reset to 1b (enabled) or will turn on when HSSC receives the signal described above in "Pin Control."
- When HSS is configured utilizing a PWM or Timer, HSS\_CNTL 8'h1E[6:4] = PWM1, PWM2, Timer1 or Timer2, the HSS will automatically turn on.

#### Note

- For resistive loads, an external capacitor to ground is not required.
- For inductive loads, an external 100 nF capacitor to ground is needed.
- When using the 10-bit PWM with the HSS or LIMP configured as a HSS, it is possible to select values that are unrealizable due to the on and off times of the switch. An example of this would be 00 0000 0001b

### 8.3.11 HSSC or FSO (High-side Switch Control or Function Output)

In pin control mode, this pin is the high-side switch control pin. When in SPI control mode, the pin becomes a function output pin that can be selected from register 8'h29[3:1]. In SPI mode this pin can be switched back to HSSC input by using register 8'h1E[6:4] = 101b.

### 8.3.12 WKRQ or INH (Wake Request or Inhibit)

Upon power up, the state of this pin determines if it is WKRQ or INH. When externally pulled low with a 100 kΩ resistor, the WKRQ function is enabled which is an active high, digital output supporting the internal voltage rail ( $V_{INT}$ ) or  $V_{CC}$  as described in [PIN or nCS \(Pin Watchdog Select or SPI Chip Select\)](#). When left floating or pulled low by a 1 MΩ resistor, this pin becomes the high voltage inhibit (INH) output which is used to support the enable pin of a power device. If a capacitor to ground is used off of this pin, it must be less than or equal to 50 pF. When WKRQ is selected, the pin behavior is based off of the LDO, so any event that causes the LDO to be turned off will turn off the WKRQ pin.

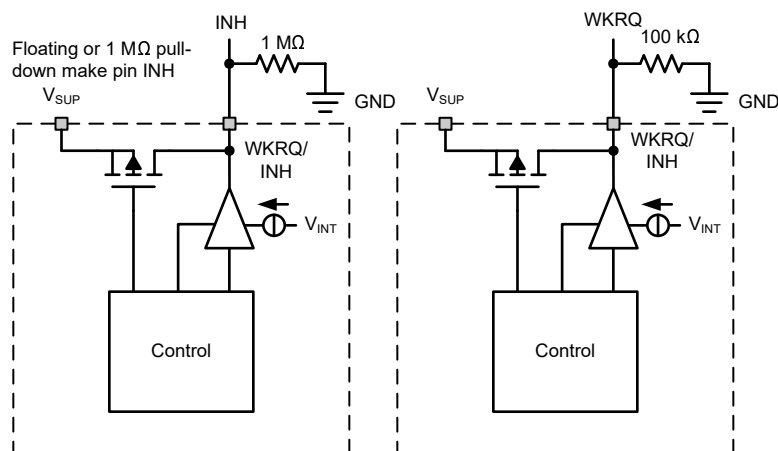


Figure 8-7. WKRQ or INH Pin Select

### 8.3.13 PV

This output pin is the divided down value from  $V_{BAT}$ . The output is buffered to keep the output from exceeding the specified values when  $V_{BAT}$  exceeds the recommended value. It is connected directly to the ADC of the microcontroller. It is connected by either an RC network or with just a capacitor to GND, see [Figure 8-8](#). It is switched on when a high is present on the DIV\_ON pin. When off, the PV pin is in a high-Z state.

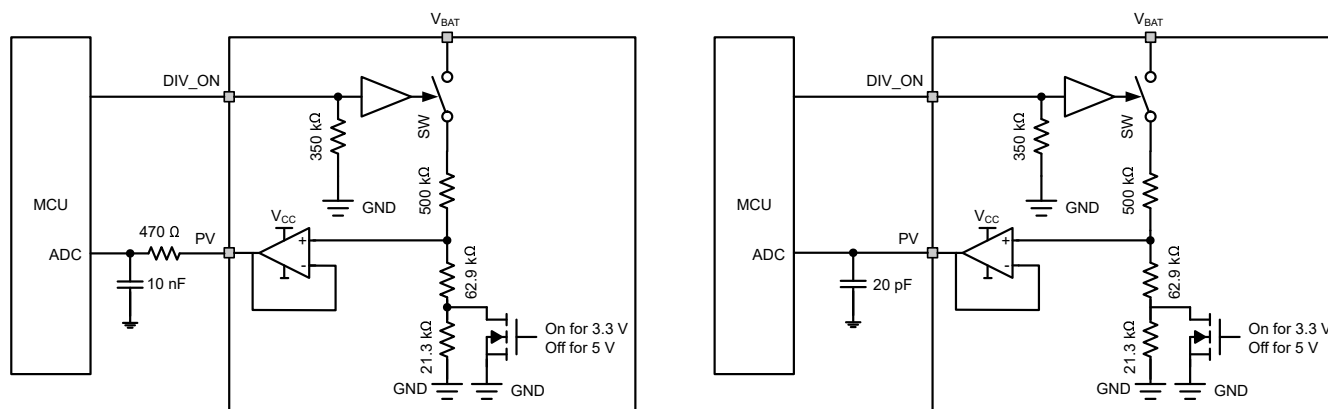


Figure 8-8. PV Connections to MCU

### 8.3.14 DIV\_ON

This is a logic input pin used to enable the voltage divider PV output. This is an active high pin and is disabled in certain modes of operation.

### 8.3.15 V<sub>BAT</sub> (Battery Voltage)

This pin is connected to the battery input prior to the reverse blocking diode. This pin is used in conjunction with the PV and DIV\_ON pins.

### 8.3.16 V<sub>SUP</sub> (Supply Voltage)

V<sub>SUP</sub> is the power supply pin. V<sub>SUP</sub> is connected to the battery through an external reverse battery-blocking diode (see [Figure 8-3](#)). The V<sub>SUP</sub> pin is a high-voltage-tolerant pin. Decoupling capacitors of 100 nF are recommended to be connected close to this pin to improve the transient performance. If there is a loss of power at the ECU level, the device has extremely low leakage from the LIN pin, which does not load the bus down. This is optimal for LIN systems in which some of the nodes are unpowered (ignition supplied) while the rest of the network remains powered (battery supplied). When V<sub>SUP</sub> drops low enough the regulated output drops out of regulation. The LIN bus works with a V<sub>SUP</sub> as low as 5.5 V, but at a lower voltage, the performance is indeterminate and not guaranteed. If V<sub>SUP</sub> voltage level drops enough, it triggers the UV<sub>SUP</sub>, and if it keeps dropping, at some point it passes the POR threshold.

### 8.3.17 GND (Ground)

GND is the device ground connection. The device can operate with a ground shift as long as the ground shift does not reduce the V<sub>SUP</sub> below the minimum operating voltage. If there is a loss of ground at the ECU level, the device has extremely low leakage from the LIN pin, which does not load the bus down. This is optimal for LIN systems in which some of the nodes are unpowered (ignition supplied) while the rest of the network remains powered (battery supplied).

### 8.3.18 EN or nINT (Enable Input or Interrupt Output)

When configured as pin control, this pin becomes the transceiver enable control, EN. EN controls the operational modes of the device. When EN is high, the device can enter normal or fast operating modes allowing a transmission path from TXD to LIN and from LIN to RXD. When EN is low, the device can enter standby or sleep mode depending upon the state of the TXD pin. The device can enter normal mode only after wake up. EN has an internal pull-down resistor to ensure the device remains in low power mode even if EN floats. EN should be held low until V<sub>SUP</sub> reaches the expected system voltage level.

When configured as SPI control, this pin becomes the processor interrupt pin. When the TLIN1431x-Q1 requires the attention of the processor, this pin is pulled low.

### 8.3.19 nRST (Reset Input and Reset Output)

The nRST pin is a bi-directional open-drain low side driver that serves three functions, a V<sub>CC</sub> monitor output for under-voltage events, restart mode indicator and a device input reset. The pin is nRST in Pin Control Mode and the defaulted function for SPI mode. This pin is internally pulled up to V<sub>INT</sub> by a 45 kΩ resistor. V<sub>INT</sub> represents the TLIN1431-Q1 IO voltage level and may or may not be V<sub>CC</sub>. It is recommended to use an external 10 kΩ pull-up to the processor IO voltage rail. The pin can determine when an input pulse of t<sub>nRSTIN</sub> is applied causing the device to enter restart mode. When an under-voltage event takes place, the nRST is latched low after a 30 μs filter and the device transitions to restart mode, fail-safe mode disabled, or fail-safe mode after the t<sub>UVFLTR</sub> has expired. When in restart and V<sub>CC</sub> exceeds the UV<sub>CCR</sub> threshold, the t<sub>RSTN\_act</sub> timer starts. After this timer times out, the device transitions to standby mode, and the nRST pin is released. If a thermal shutdown event takes place, the signal is pulled to ground. When the device is configured by SPI, the pin can be programmed to become the watchdog output trigger to reset the processor. When the watchdog times out, this signal is pulled low for time of t<sub>nRST\_TOG</sub> and then released back to V<sub>CC</sub>. If both are needed for SPI configuration it is recommended to add an external circuit off the LIMP pin to serve as the watchdog output trigger to reset the processor. Note the LIMP pin output is a high voltage output based upon V<sub>SUP</sub> and care must be taken when connecting to a lower voltage device.

### 8.3.20 V<sub>CC</sub> (Supply Output)

The V<sub>CC</sub> terminal is the regulated output based on the applicable voltage, 3.3 V or 5 V with up to 125 mA from 12 V supply voltage. This pin is used to power external devices and when using high-k boards and thermal management best practices full capability can be realized. The regulated voltage accuracy is ±2.5%.

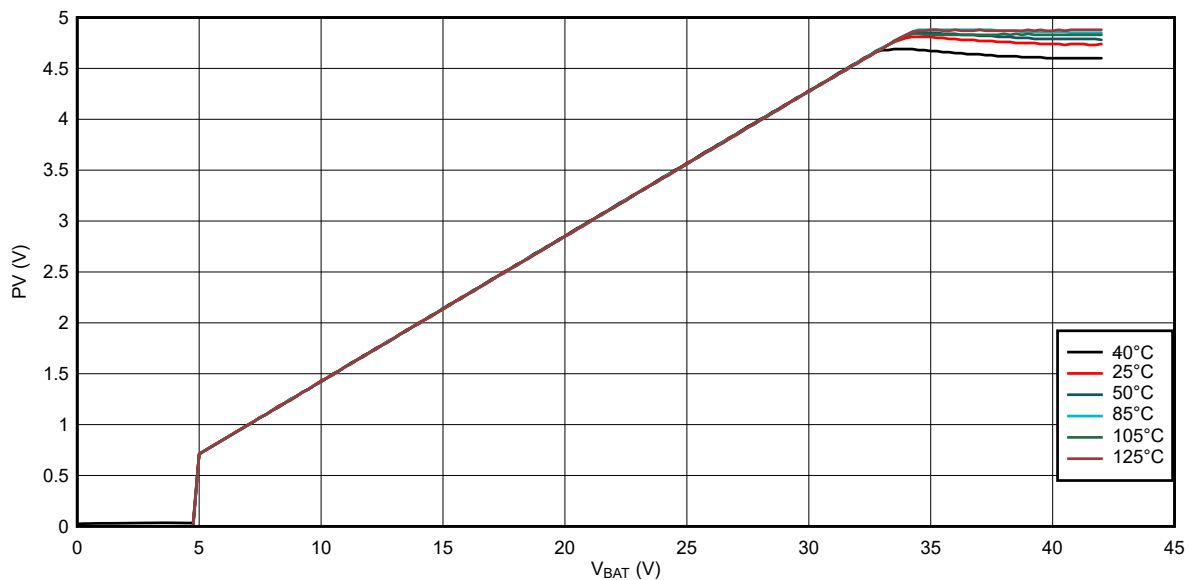
When powering up the TLIN1431x-Q1,  $V_{CC}$  must be above  $UV_{CC}$  and without any faults.  $V_{CC}$  is used to determine the state of several pins that establishes several device functions, such as pin control or SPI control. If a fault, such as  $V_{CCSC}$ , is present at power up the device cannot determine the state of these pins. Fault needs to be cleared and power up performed again.

### 8.3.21 $V_{BAT}$ Voltage Divider

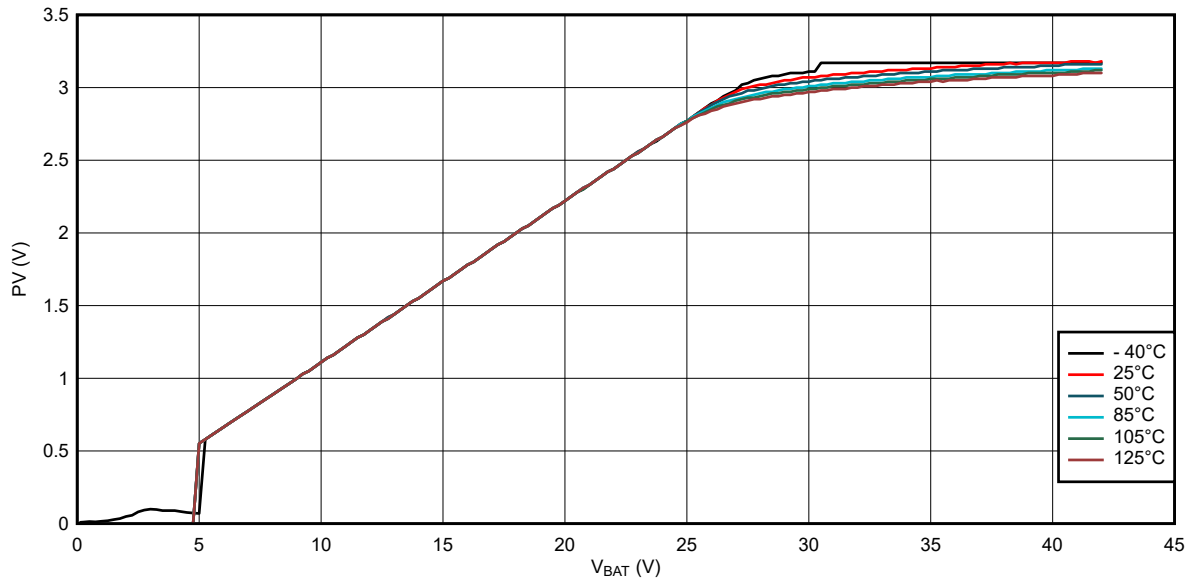
The voltage divider is a reverse polarity protected resistor divider connected to  $V_{BAT}$  with fast response times. The divider is based upon the LDO value. For 5 V  $V_{CC}$ , the ratio is 1:7. For 3.3 V  $V_{CC}$ , the ratio is 1:9. The voltage divider is activated by a high on the DIV\_ON pin. The divided output voltage is available on the PV pin for the microcontroller to read. See Table 8-1 for the modes that the DIV\_ON functionality is enabled and disabled. When  $V_{BAT}$  exceeds 28 V for the 5 V LDO and 20 V for the 3.3 V LDO the voltage is clamped to prevent damage to microcontroller. See Figure 8-9 and Figure 8-10 for the relationship between  $V_{BAT}$  and PV output voltage.

**Table 8-1. Voltage Divider Functionality Control by Mode**

| Mode of Operation               | DIV_ON | PV Output State |
|---------------------------------|--------|-----------------|
| Normal/Fail-Safe/Fast/ Standby  | Low    | Off             |
|                                 | High   | On              |
| Sleep/Pin Init/SPI Init/Restart | Low    | Off             |
|                                 | High   | Off             |



**Figure 8-9.  $V_{BAT}$  vs PV for TLIN14315RGYQ1 for Different Ambient Temperatures**



**Figure 8-10. V<sub>BAT</sub> vs PV for TLIN14315RGYQ1 for Different Ambient Temperatures**

### 8.3.22 Protection Features

The device has several protection features that are described as follows.

#### 8.3.22.1 Sleep Wake Error (SWE) Timer

The TLIN1431x-Q1 implements a sleep wake error timer,  $t_{INACT\_FS}$ . The purpose of the SWE timer is to keep the device and the node from being stuck in a high-power state. This timer is used to place the device into fail-safe or sleep mode due to fault conditions. In Pin mode, the SWE timer starts automatically when entering fail-safe and restart modes. A wake event causes the device to move from sleep mode to restart mode and if  $V_{CC}$  does not exceed  $UV_{CC}$  before the SWE timer times out the device re-enters sleep mode. This happens in either SPI or pin control modes.

In SPI mode, the SWE timer, when enabled, automatically starts when the device enters fail-safe, restart and standby modes. When the device leaves restart mode and enters standby mode, the processor must initiate a SPI transaction before the SWE timer times out or the device will enter fail-safe mode if enabled or sleep mode. This timer can be disabled at register 8'h1C[7] = 1. If the SWE timer duration is changed, this is accomplished register 8'h1C[6:3]. It can be changed from default of 5 min to between 30 sec to 10 min.

#### 8.3.22.2 Device Reset

The TLIN1431 device can be reset in various ways. In SPI mode, there are three methods to reset the device. Two are accomplished with SPI commands – soft reset and hard reset. Soft reset and hard reset are accomplished by writing 02h or 01h respectively to DEVICE\_RST (Address 19h) register. nRST pin can also be used to reset the device by pulling nRST low for  $t_{nRSTIN}$  and releasing the pin. nRST pin reset works for both SPI and PIN mode.

When performing a soft reset (SPI Mode), the following takes place:

- Device transitions to restart mode, nRST pin is pulled low for  $t_{NRST\_TOG}$  and then transitions to standby mode.
- All registers are reset to default values
- All pending interrupts are cleared (unless a fault persists). PWRON interrupt is not cleared by soft reset.
- $V_{CC}$  stays in the same state it was in
- INH stays ON

When performing a hard reset (SPI Mode), the following takes place:

- Similar behavior as power-up
- Device transitions to Init mode –  $V_{CC}$  is re-enabled, INH/WKRQ is re-sampled, SPI/PIN mode determination is made

- All registers are reset to default values
- PWRON flag is set with a hard reset (if previously cleared)

When pulling nRST pin low and releasing (SPI or PIN Mode), the following takes place:

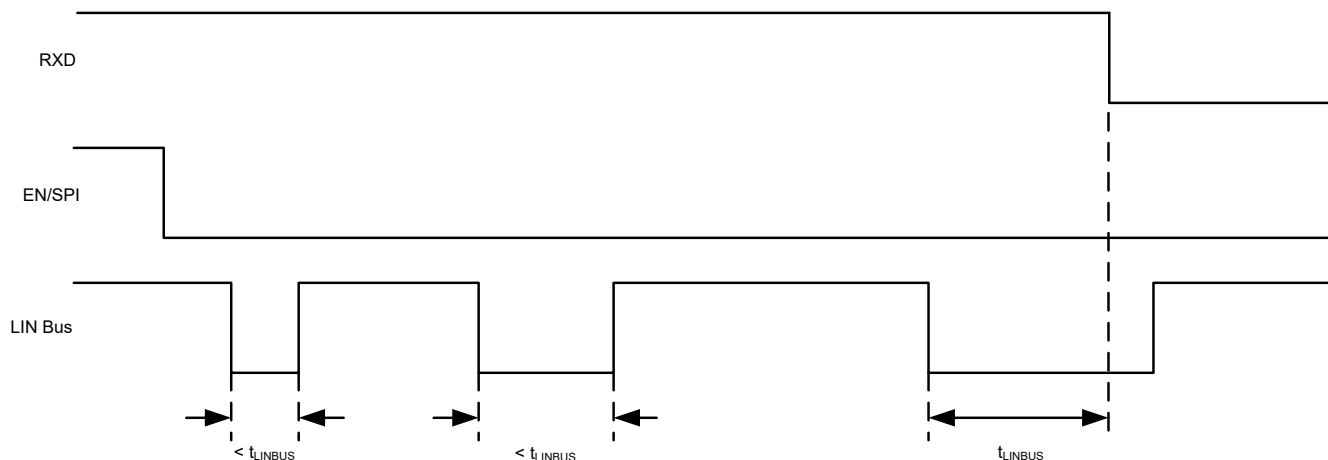
- Device transitions to restart mode, nRST pin is pulled low for  $t_{NRST\_TOG}$  and then transitions to standby mode.
- All registers retain the same value as before nRST reset
- $V_{CC}$  stays in the same state it was in
- All pending interrupts are retained
- INH stays ON

### 8.3.22.3 TXD Dominant Time Out (DTO)

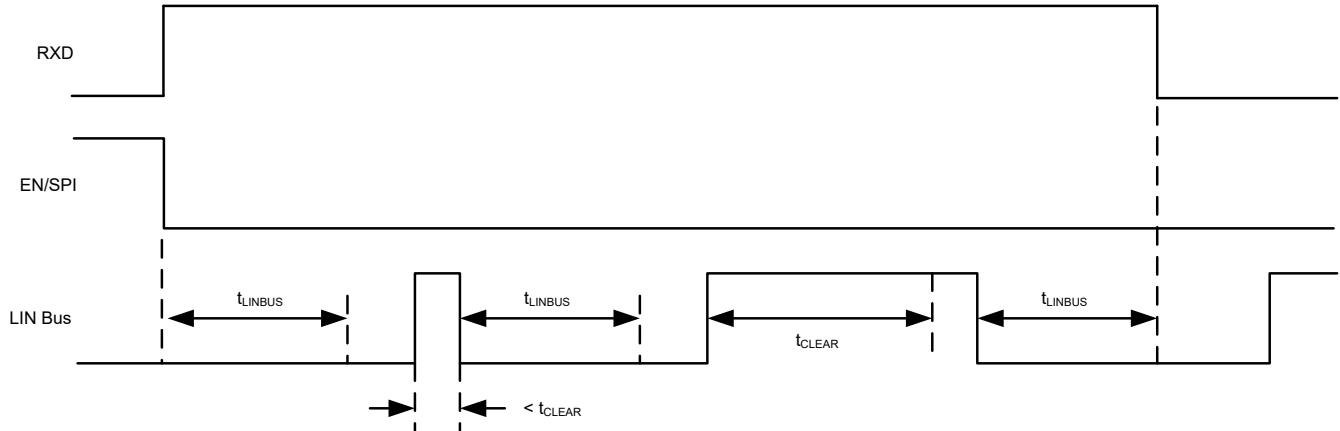
During normal mode, if TXD is inadvertently driven permanently low by a hardware or software application failure, the LIN bus is protected by the dominant state timeout timer. This timer is triggered by a falling edge on the TXD pin. If the low signal remains on TXD for longer than  $t_{TXD\_DTO}$ , the transmitter is disabled, thus allowing the LIN bus to return to recessive state and communication to resume on the bus. The protection is cleared and the  $t_{TXD\_DTO}$  timer is reset by a rising edge on TXD. The TXD pin has an internal pull-up to make sure the device fails to a known recessive state if TXD is disconnected. During this fault, the transceiver remains in normal mode (assuming no change of stated request on EN), the RXD pin reflects the LIN bus and the LIN bus pull-up termination remains on. The TLIN1431x-Q1 can turn off TXD dominant state timeout when in SPI mode by using register 8'h1D[5] = 1b.

### 8.3.22.4 Bus Stuck Dominant System Fault: False Wake Up Lockout

The device contains logic to detect bus stuck dominant system faults and prevents the device from waking up falsely during the system fault. Upon entering sleep mode, the device detects the state of the LIN bus. If the bus is dominant, the wake-up logic is locked out until a valid recessive on the bus “clears” the bus stuck dominant, preventing excessive current use. Figure 8-11 and Figure 8-12 show the behavior of this protection.



**Figure 8-11. No Bus Fault: Entering Sleep Mode with Bus Recessive Condition and Wake Up**



**Figure 8-12. Bus Fault: Entering Sleep Mode with Bus Stuck Dominant Fault, Clearing, and Wake Up**

### 8.3.22.5 Thermal Shutdown

The TLIN1431x-Q1 has multiple thermal sensors in the device to monitor the junction temperature of the die. The  $V_{CC}$  LDO, LIN transmitter, and high side switch/LIMP cells are monitored. Depending upon which cell's junction temperature are exceeded will determine the action taken by the device. Exceeding the maximum junction temperature for the LIN transmitter or LDO will cause the LIN transmitter into the recessive state and turns off the  $V_{CC}$  regulator. The nRST pin is pulled to ground during a LIN or  $V_{CC}$  LDO TSD event. Once the over temperature fault condition has been removed and the junction temperature has cooled beyond the hysteresis temperature, the transmitter can be re-enabled. Exceeding the max junction temperature of the high side switch or LIMP cells will cause the cells to be turned off.

In pin control mode, a TSD event on the LIN transceiver or  $V_{CC}$  LDO causes the device enters a fail-safe mode. Once the TSD fault has been removed and a wake event takes place, the device enters restart mode. If a wake event takes place and the TSD fault has not cleared, the device enters sleep mode immediately. Exceeding the max junction temperature for the high side switch and LIMP high side switch cause the switches to be turned off until junction temperature falls below  $T_{SDF}$ .

In SPI mode, there are two interrupts that can be set due to a thermal event. If the LIN transceiver or  $V_{CC}$  LDO junction temperature is exceeded, the TSD\_VCC\_LIN interrupt is set and the devices takes the action previously described. If the high side switch or LIMP high side switch max junction temperature is exceeded, the TSD\_HSS\_LIMP interrupt is set. The device takes the action previously described. In SPI mode, the device defaults to support fail-safe mode. The device enters fail-safe mode upon an TSD\_VCC\_LIN event and LIMP is turned on (see [Figure 8-25](#)). Exiting fail-safe mode is the same as when the device is pin controlled. When fail-safe mode is disabled, the device enters sleep mode upon a TSD\_VCC\_LIN event.

### 8.3.22.6 Under-voltage on $V_{SUP}$

The device monitors  $V_{SUP}$  for two low voltage thresholds,  $UV_{SUP}$  and  $V_{nPOR}$ . When  $V_{SUP}$  drops below  $UV_{SUP}$  and is above  $V_{nPORF}$ , the device is in an under-voltage power state. Once  $V_{SUP}$  ramps above  $UV_{SUPR}$ , the device enters restart mode and turns on the  $V_{CC}$  LDO, see [Restart Mode](#). When  $V_{SUP}$  drops below  $V_{nPORF}$ , the device goes into a power off state. Once  $V_{SUP}$  ramps above  $V_{nPORR}$ , the device prepares the digital core to wake up. The device waits for  $V_{SUP}$  to rise above  $UV_{SUPR}$  and then turns on the  $V_{CC}$  LDO. Once  $V_{SUP}$  and  $V_{CC}$  are above their under-voltage levels, the device enters Init mode, see [Init Mode](#). The described under-voltage events are also considered brown out events and more information can be found at [Device Brownout information](#).

### 8.3.22.7 Unpowered Device and LIN Bus

In automotive applications, some LIN nodes in a system can be unpowered (ignition supplied) while others in the network remains powered by the battery. The device has extremely low unpowered leakage current from the bus, so an unpowered node does not affect the network or load it down.

### 8.3.22.8 Floating Pins

There are internal pull ups and pull downs on critical terminals to place the device into known states if the terminal floats. See [Table 8-2](#) for details on terminal bias conditions.

**Table 8-2. Internal Pull-ups and Pull-downs on Device Pins**

| Pin      | Pull-up or Pull-down | Typical Value  | Comment                                     |
|----------|----------------------|----------------|---------------------------------------------|
| TXD      | Pull-up              | 350 k $\Omega$ |                                             |
| WDT/CLK  | Pull-up              | 240 k $\Omega$ | When device configured for SPI control, CLK |
| WDI/SDI  | Pull-up              | 240 k $\Omega$ |                                             |
| PIN/nCS  | Pull-up              | 240 k $\Omega$ | When device configure for SPI control, nCS  |
| DIV_ON   | Pull-down            | 370 k $\Omega$ |                                             |
| LIN      | Pull-up              | 45 k $\Omega$  |                                             |
| EN/nINT  | Pull-down            | 350 k $\Omega$ |                                             |
| HSSC/FSO | Pull-down            | 350 k $\Omega$ |                                             |
| nRST     | Pull-up              | 45 k $\Omega$  |                                             |

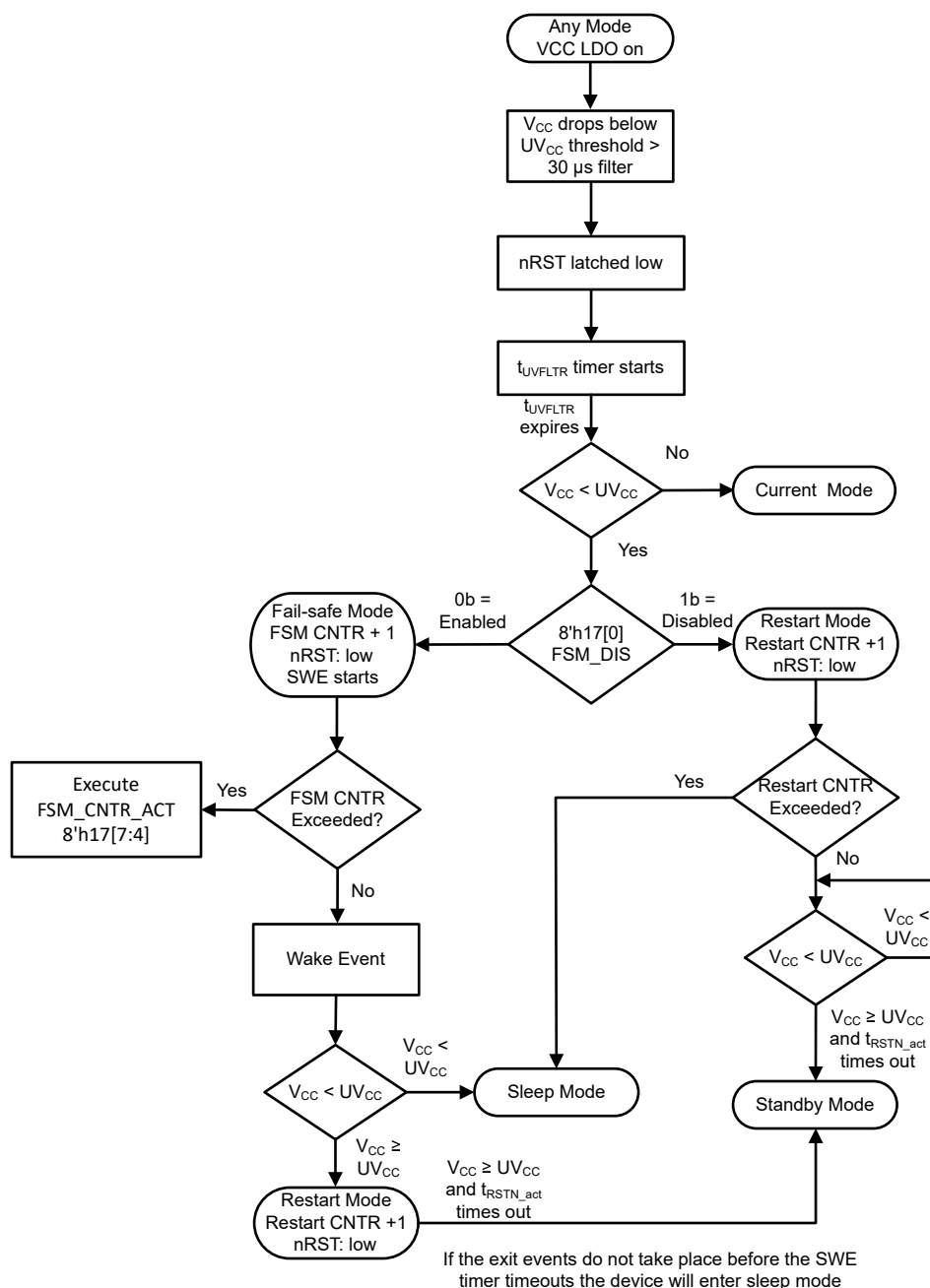
### 8.3.22.9 V<sub>CC</sub> Voltage Regulator

The device has an integrated high-voltage input LDO that operates over a 5.5 V to 28 V input voltage range for both 3.3 V and 5 V V<sub>CC</sub>. The device has an output current capability of 125 mA and support fixed output voltages of 3.3 V (TLIN14313-Q1) or 5 V (TLIN14315-Q1). It features thermal shutdown and short-circuit protection to prevent damage during over-temperature and over current conditions

#### 8.3.22.9.1 Under or Over Voltage and Short Circuit

The V<sub>CC</sub> pin is the current limited regulated output based supporting an accuracy of  $\pm 2.5\%$ . In the event that the regulator drops out of regulation, the output tracks the input minus a drop based on the load current. When the input voltage drops below the UV<sub>SUP</sub> threshold, the regulator turns off until the input voltage returns above the UV<sub>SUPR</sub> level. When 5 V LDO is used, the device uses the voltage regulator during Init mode to determine the WKRQ/INH function, and the IO voltage. The device monitors V<sub>CC</sub> for under-voltage, over-voltage, short to ground and thermal events. The device control method and whether fail-safe mode is enabled determine the behavior of the of the device for these events. Fail-safe mode is always active when the device is in pin control. In SPI control, the state diagram shows two paths: fail-safe mode enabled and fail-safe mode disabled. The path followed depends on whether fail-safe mode is enabled or disabled in 8'h17[0] FSM\_DIS.

For an under-voltage event, V<sub>CC</sub> is less than or equal to UV<sub>CCF</sub>. After a 30 $\mu$ s filter time, the device pulls nRST low and after the t<sub>UVFLTR</sub> time, the interrupt flag is set and device transitions to restart mode, if fail-safe disabled, or fail-safe mode. When entering either mode, the SWE timer t<sub>INACT\_FS</sub> starts, and, in SPI control, the mode counter increments and the appropriate interrupt flags are set. To exit fail-safe mode, the under-voltage has to clear and a wake event takes place prior to the SWE timer timing out. If the under-voltage event has not cleared when the wake event takes place or if the SWE timer times out, the device enters sleep mode. [Figure 8-13](#) shows how a UV<sub>CC</sub> event is handled..



**Figure 8-13. UVCC flow chart**

**Note**

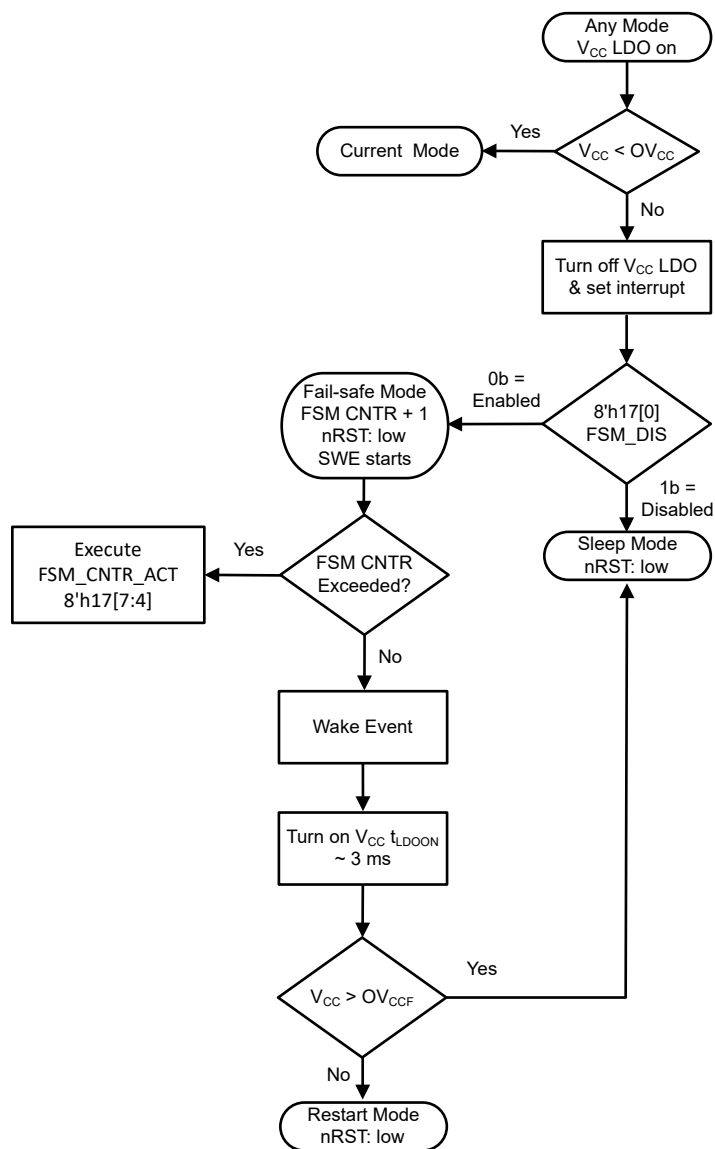
If an over-voltage or short circuit event takes place while the device is in fail-safe mode due to a under-voltage event on  $V_{CC}$ , the device will behave as shown in the  $OV_{CC}$  and  $VCC_{SC}$  flow charts.

For an over-voltage event,  $OV_{CC}$ , the device turns off the  $V_{CC}$  LDO, and transitions to either sleep mode, fail-safe mode disabled, or fail-safe mode. When a wake event takes place, the  $V_{CC}$  LDO is turned on for  $t_{LDOON}$  to determine if the over-voltage is still present. If cleared, the device enters restart mode from either sleep or fail-safe modes. When in fail-safe mode, if the over-voltage has not cleared when the wake event takes place the device transitions to sleep mode.

**Note**

If an over-voltage event takes place while the device is in Init mode the following will happen:

- The device will sample the pins and determine whether the device is Pin or SPI control
- The device will determine the input/output voltage level if the TLIN1431-Q1
- The device will determine if WKRQ/INH pin is WKRQ or INH
- The device will transition to fail-safe mode



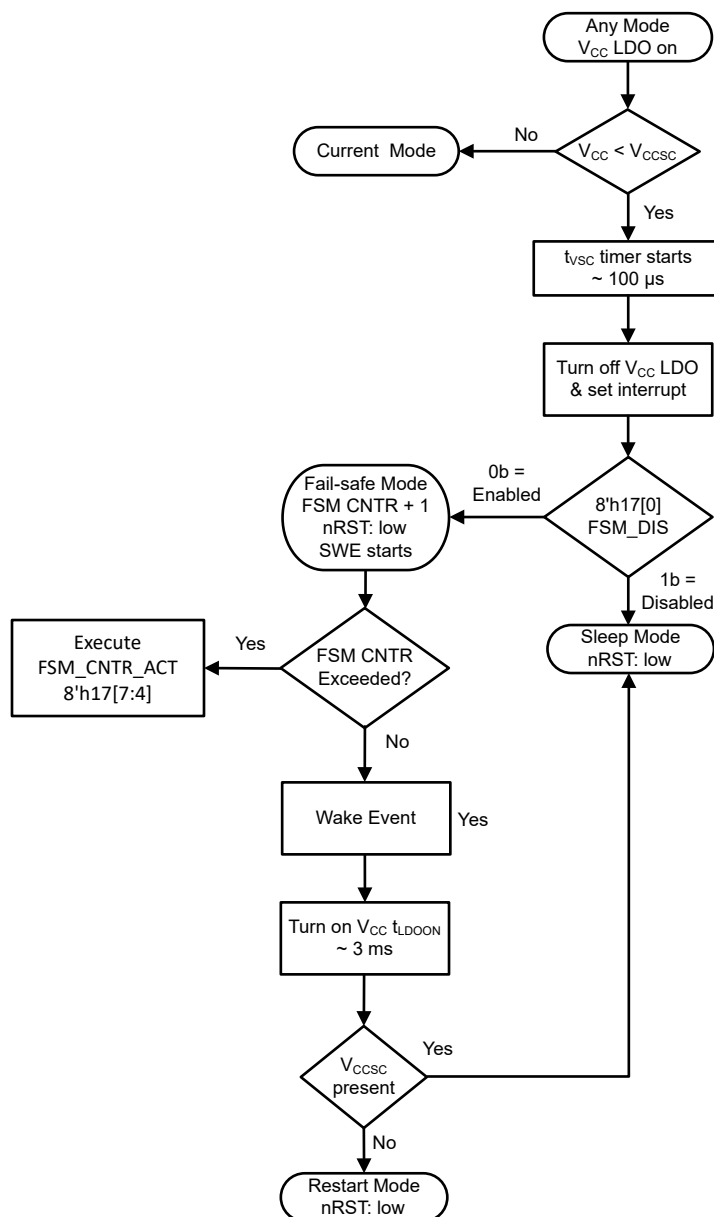
If the exit events do not take place before the SWE timer timeouts the device will enter sleep mode

**Figure 8-14. OV<sub>CC</sub> flow chart**

For a short to ground event,  $V_{CCSC}$ , the device turns off the  $V_{CC}$  LDO and transitions to either sleep mode, fail-safe mode disabled, or fail-safe mode. When a wake event takes place, the  $V_{CC}$  LDO is turned on for  $t_{LDOON}$  to determine if the short to ground is still present. If cleared, the device enters restart mode from either sleep or fail-safe modes. When in fail-safe mode, if the short to ground has not cleared when the wake event takes place the device will transition to sleep mode.

### Note

If a short circuit event is detected while the device is in Init mode the device will transition to sleep mode. The device will not have determined the state of the pins and default to Pin control and will need to be powered cycled if the default state is different than what is expected.



If the exit events do not take place before the SWE timer timeouts the device will enter sleep mode

**Figure 8-15. V<sub>CCSC</sub>, short to ground**

#### 8.3.22.9.2 Output Capacitance Selection

For stable operation over the full temperature range and with load currents up to 125 mA on V<sub>CC</sub>, a certain capacitance is expected, and depends upon the minimum load current. To support no load to full load, a value of 10 μF and ESR smaller than 2 Ω is needed. For 50 μA to full load, a smaller capacitance can be used but is system dependent and should be selected that will meet LIN to V<sub>CC</sub> cross talk compliance during DPI testing. The low ESR recommendation is to improve the load transient performance.

### 8.3.22.9.3 Low-Voltage Tracking

At low input voltages, the regulator drops out of regulation and the output voltage tracks input minus a voltage based on the load current (IL) and switch resistor. This tracking allows for a smaller input capacitance and can possibly eliminate the need for a boost converter during cold-crank conditions.

### 8.3.22.9.4 Power Supply Recommendation

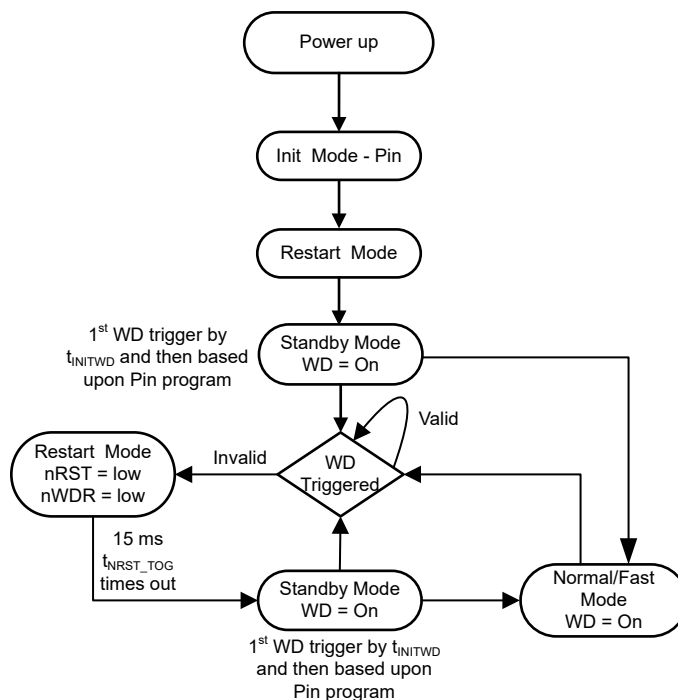
The device is designed to operate from an input-voltage supply range between 5.5 V and 28 V. This input supply must be well regulated, if the input supply is located more than a few inches from the device. The recommended minimum capacitance at the pin is 100 nF. The max voltage range is for the LIN functionality. Exceeding 24 V for the LDO reduces the effective current sourcing capability due to thermal considerations.

### 8.3.22.10 Watchdog

The TLIN1431x-Q1 has an integrated watchdog function. This can be programmed by pin control or SPI communication control based upon the state of the PIN or nCS pin at power up. The device defaults to windows based watchdog at power up. When entering normal and fast modes, the programmed watchdog timer starts based upon the pin configuration for pin mode or register configuration in SPI control mode. When entering standby mode from restart mode, there is a nRST transition from low to high. This transition starts the  $t_{INITWD}$  timer. A WD trigger input must take place prior to this initial long window times out. If WD is disabled in standby mode the same long window is implemented in normal mode. The LIMP pin provides a limp home capability when connected to external circuitry. When in sleep mode, the limp pin is off. When the error counter reaches the watchdog trigger event level, the LIMP pin turns on connecting  $V_{SUP}$  to the pin as described in the LIMP pin section and the device transitions to restart mode at which time the nRST pin will be pulled low.

#### 8.3.22.10.1 Watchdog in Pin Control Mode

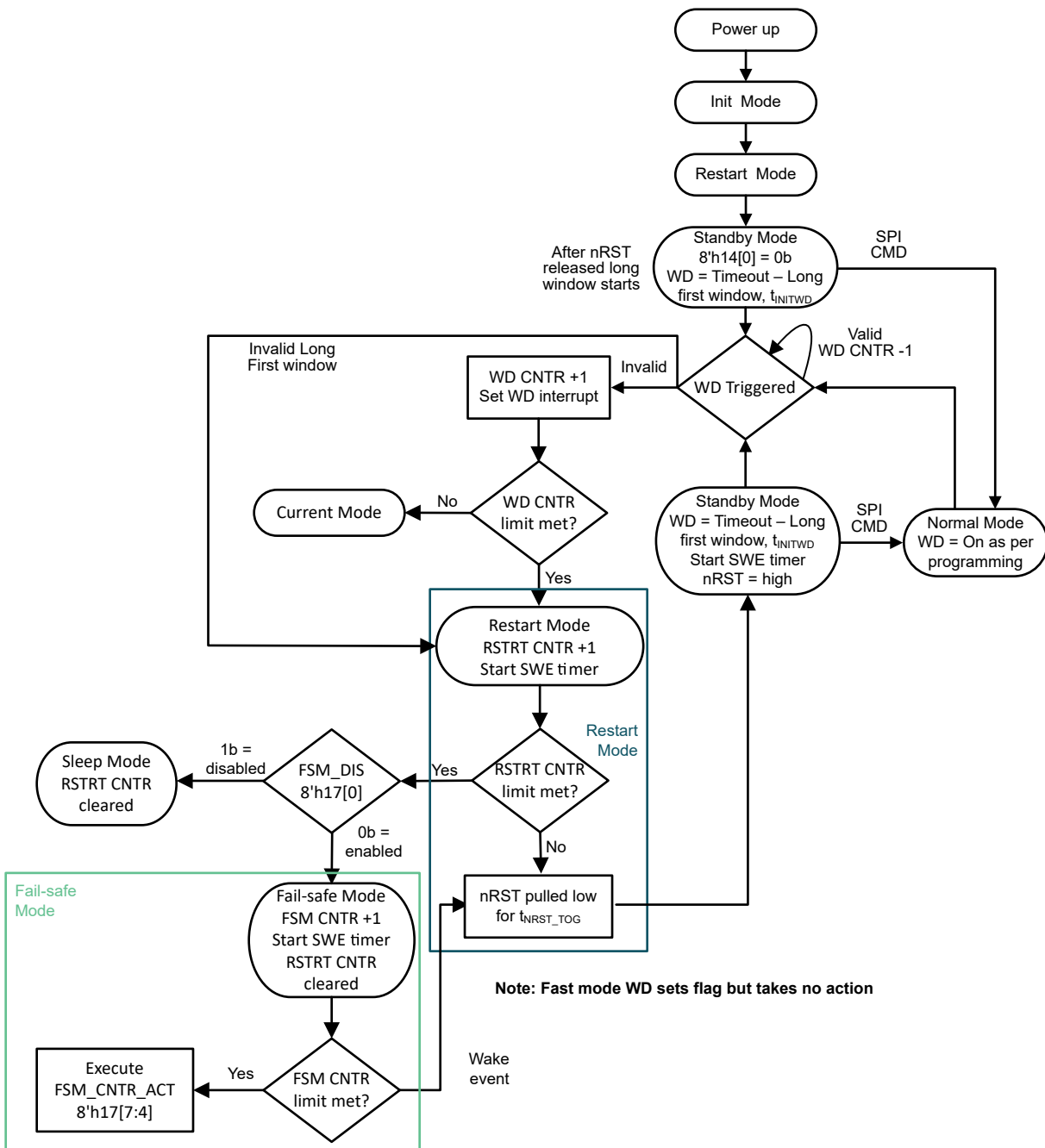
The state of the WDT pin determines the window watchdog timing for three different windows. Timeout watchdog is not available in pin control. The watchdog timer starts once the device has entered standby. The mode the device enters is based upon other pins, EN and TXD. Fast mode can be used as a software development mode as the WD is enabled but does not cause any action to take place. The watchdog feature cannot be disabled in pin control mode. See [Figure 8-16](#) for state diagrams on how the WD behaves.



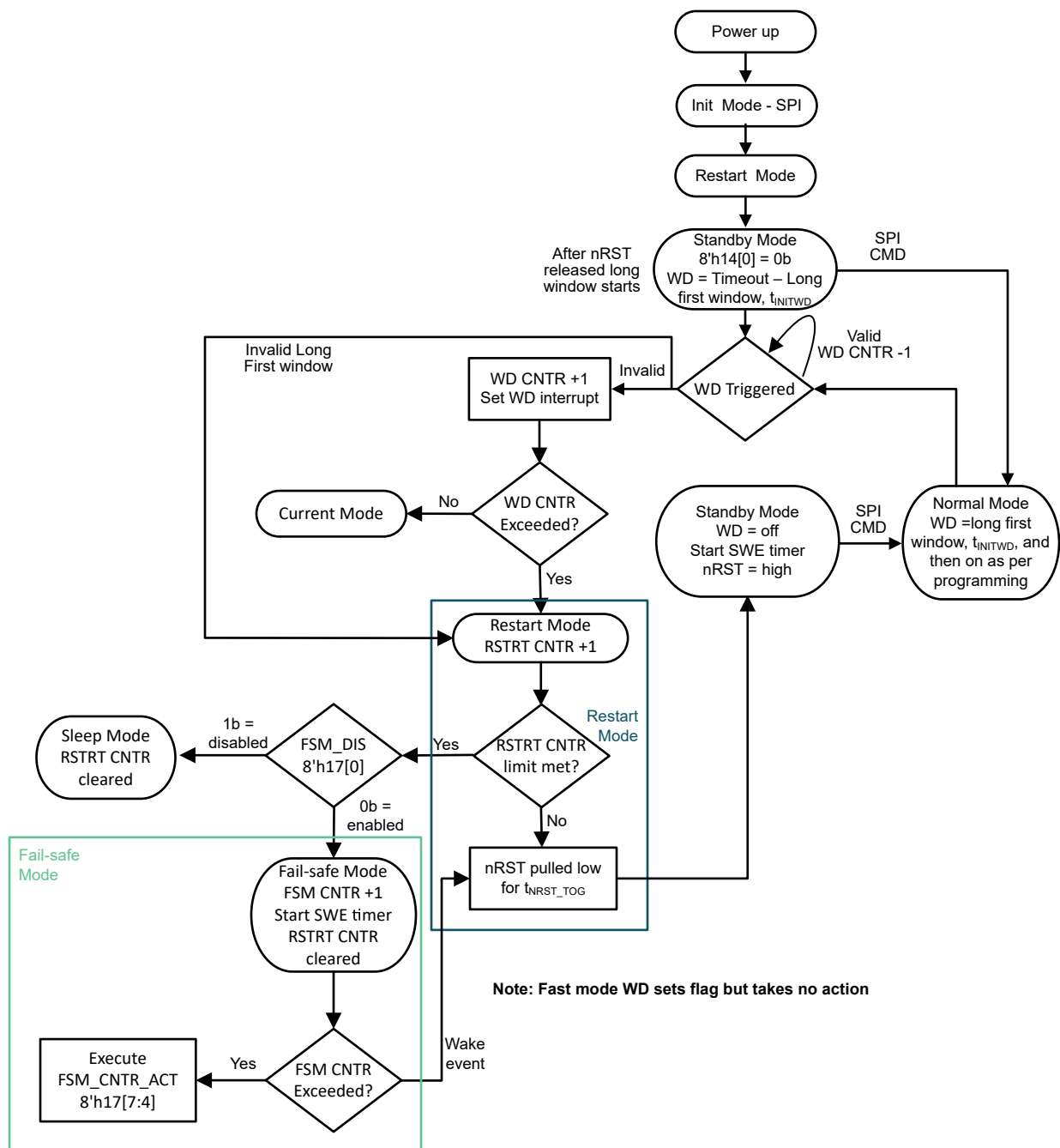
**Figure 8-16. Watchdog state diagram in pin mode**

### 8.3.22.10.2 Watchdog in SPI Control Mode

In SPI control, the window has extensive configurability including the ability to select the timeout watchdog. Watchdog is default enabled for standby mode, but can be disabled by setting register 8'h14[0] = 1b. Register 8'h13[7:6] can be set to 00b to disable the WD. There is a WD error counter available in SPI control mode, see [Watchdog Error Counter](#) for description of this counter. When a WD error occurs and if the WD error counter reaches programmed count, the device transitions to restart mode and pulls nRST low for  $t_{NRST\_TOG}$ . Once this time has been met, the device transitions to standby mode and sets nRST pin high. See [Figure 8-17](#) and [Figure 8-18](#) for state diagrams on how the WD behaves.



**Figure 8-17. Watchdog state diagram in SPI mode; Standby Mode Enabled**



**Figure 8-18. Watchdog state diagram in SPI mode; Standby Mode Disabled**

**Note**

- When the mode is changed while the timeout or window watchdog is running, it restarts once entering the new mode, fast, normal and standby.
- If the watchdog configuration is changed on-the-fly while the watchdog is running, it resets the error counter to 1 and resets the watchdog timers.

### 8.3.22.10.3 Watchdog Error Counter

The TLIN1431x-Q1 has a watchdog error counter used in SPI control mode. This counter is an up down counter that increments for every missed window or incorrect input watchdog trigger event. In SPI control, the error

counter is set at one by default. The counter decrements for every correct input trigger and increments on every incorrect input trigger, but it never drops below zero. When the programmed counter is reached, the device transitions to restart mode, error counter is reset back to one, and the nRST pin pulls low for  $t_{NRST\_TOG}$ . At the end of this time, the device transitions back to standby mode releasing the nRST pin to high. This counter can be changed to 1 (every error), 5, 9, or 15 using 8'h16[7:6]. The error counter can be read at register 8'h14[4:1]. In pin control, nWDR is pulled low for every watchdog error.

If the watchdog error count is set at one, the first input failure causes the device to transition to restart. This allows the system to check the counter after the first input trigger to see if a valid input was sent. Every incorrect watchdog input causes the interrupt to be set and nINT is pulled low.

#### 8.3.22.10.4 Pin Control Mode

When using pin control for programming the watchdog, the WDT pin is used for this function. WDT sets the total window size of the window watchdog. It can be connected to VCC, GND or left open. See [Section 8.3.5](#) or [Section 6.7](#) for details on window timings. The ratio between the upper (open window) and lower (closed window) is 50/50. WDI pin is used by the controller to trigger the watchdog input. The WDI input is an edge-triggered event and supports both rising and falling edges. A filter time of  $t_W$  is used to avoid noise or glitches causing a false trigger. A pulse would be treated as a two input trigger events and cause the nWDR and nRST pins to be pulled low. nWDR pin can connected to the controller reset pin and if a watchdog event happens this pin is pulled low. The nRST pin may also be used for this function but includes other possible errors, like under-voltage or entering restart mode.

#### 8.3.22.10.5 SPI Control Programming

In SPI control, registers 8'h13 through 8'h16 control the watchdog function. The device watchdog can be set as a timeout watchdog or window watchdog by setting 8'h13[7:6] to the method of choice. The timer is based upon register 8'h13[5:4] WD prescaler and register 8'h14[7:5] WD timer and is in ms. See [Table 8-3](#) for the achievable times.

#### 8.3.22.10.6 Watchdog Register Relationship

**Table 8-3. Watchdog Window and Timeout Timer Configuration (ms)**

| WD_TIMER<br>(ms)       | Register 8'h13[5:4] WD_PRE |       |      |      |
|------------------------|----------------------------|-------|------|------|
| Register<br>8'h14[7:5] | 00                         | 01    | 10   | 11   |
| 000                    | 4                          | 8     | 12   | 16   |
| 001                    | 32                         | 64    | 96   | 128  |
| 010                    | 128                        | 256   | 384  | 512  |
| 011                    | 256                        | 384   | 512  | 768  |
| 100                    | 512                        | 1024  | 1536 | 2048 |
| 101                    | 2048                       | 4096  | 6144 | 8192 |
| 110                    | 10240                      | 20240 | RSVD | RSVD |
| 1111                   | RSVD                       | RSVD  | RSVD | RSVD |

#### 8.3.22.10.7 Watchdog Timing

The TLIN1431x-Q1 provides two methods for setting up the watchdog when in SPI communication mode: window watchdog or timeout watchdog. If more frequent (i.e. <16 ms) input trigger events are desired it is suggested to use the timeout watchdog. When using timeout watchdog, the input trigger can occur anywhere before the timeout and is not tied to an open window.

When using the window watchdog, it is important to understand the closed and open window aspects. The device is set up with a 50%/50% open and closed window and is based on an internal oscillator with a  $\pm 10\%$  accuracy range. To determine when to provide the input trigger, this variance needs to be considered. For example, using the 64 ms nominal total window provides a closed and open window that are each 32 ms. Taking the  $\pm 10\%$  internal oscillator into account means the total window could range from 57.6 ms to 70.4 ms. The closed and open window could then range from 22.4 ms to 35.2 ms. From the 57.6 ms total window and 35.2 ms

closed window, the total open window is 22.4 ms. The trigger event needs to happen at  $46.4 \text{ ms} \pm 11.2 \text{ ms}$ . The same method is used for the other window values. [Figure 7-8](#) provides the above information graphically.

### 8.3.23 Channel Expansion

The TLIN1431x-Q1 has the ability to control an external LIN or CAN FD transceiver or a general purpose LIN or CAN FD SBC. The processor controls the mode of the external transceiver by using the FSO pin from the TLIN1431x-Q1 to the external transceiver. This is accomplished using the TLIN1431-Q1 SPI port, controlling the FSO pin as an EN/STB/nSTB/S output pin to the external transceiver. This capability allows the system designer to develop nodes with many different configurations, for example:

- Two LIN transceivers by using a simple eight pin LIN transceiver (see [Figure 8-19](#))
- Two LIN transceivers with two WAKE and INH capability by using an enhanced eight pin LIN transceiver (see [Figure 8-20](#))
- Two LIN transceivers with two LDO outputs by using an eight pin LIN SBC (see [Figure 8-21](#))
- One LIN and one CAN FD transceiver by using a simple eight pin CAN FD transceiver (see [Figure 8-22](#))
- One LIN and one CAN FD transceiver with two LDO outputs by using a CAN FD SBC (see [Figure 8-23](#))

#### 8.3.23.1 Channel Expansion for LIN

The TLIN1431x-Q1 has the ability to control an external LIN transceiver like the TLIN1039-Q1 or TLIN1021A-Q1 or a general purpose LIN SBC like the TLIN1028x-Q1. The FSO pin is configured as a general purpose output pin. The FSO output level can be changed to meet the needs of the transceiver. The supply voltage of this transceiver can be connected to  $V_{\text{SUP}}$  or controlled by the HSS pin from the TLIN1431x-Q1. To configure the device to support an external LIN device the following registers and bits need to be configured:

- Register 8'h29[3:1] = 110b sets the FSO pin to a general-purpose output pin.
- Register 8'h29[4] sets the voltage level of the FSO pin when configured as a general-purpose output pin and can be used to control the EN pin of an external LIN transceiver or SBC.
- To use the high-side switch (HSS) as the power to the external transceiver, turn on HSS. Note that when the device enters sleep mode, the HSS pin is turned off.

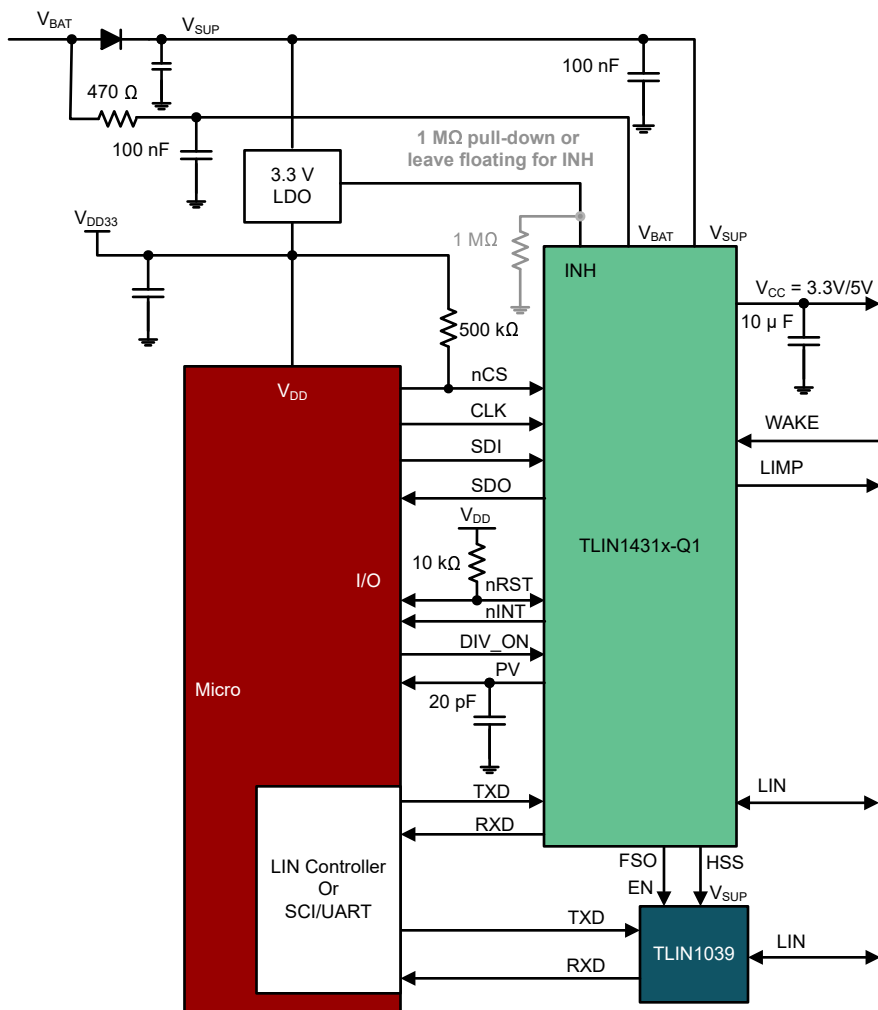


Figure 8-19. Channel Expansion: LIN Transceiver

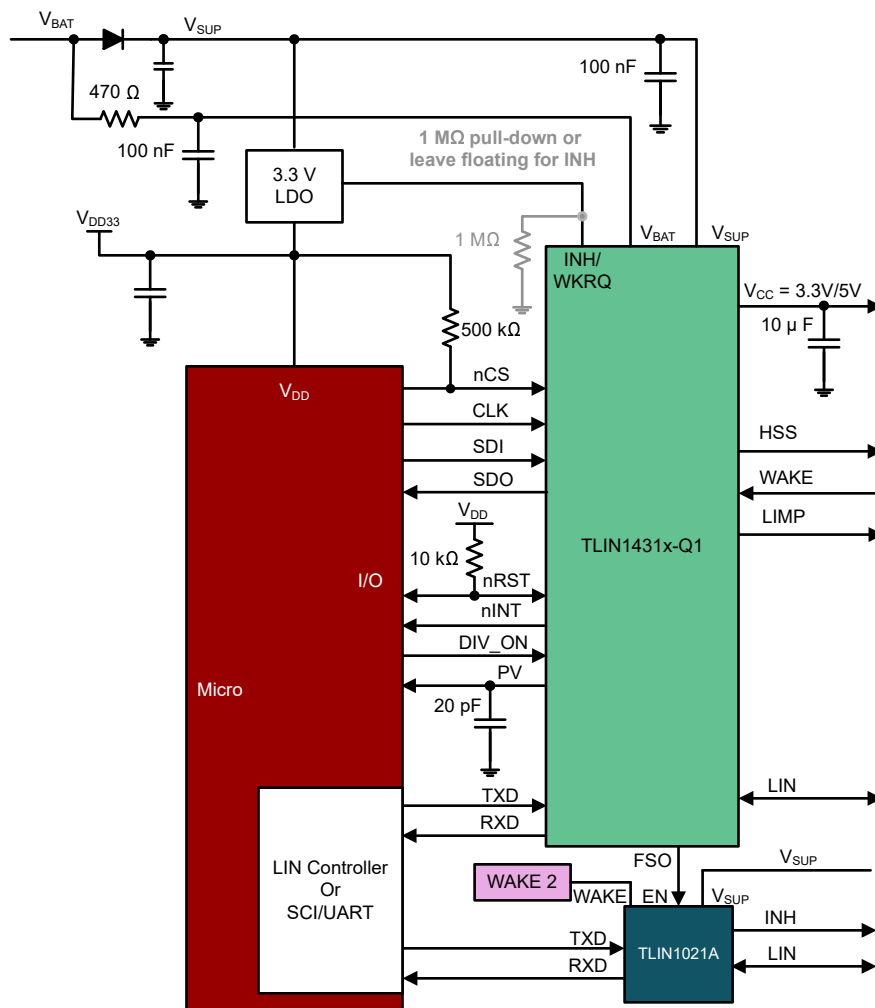


Figure 8-20. Channel Expansion: Enhanced LIN Transceiver

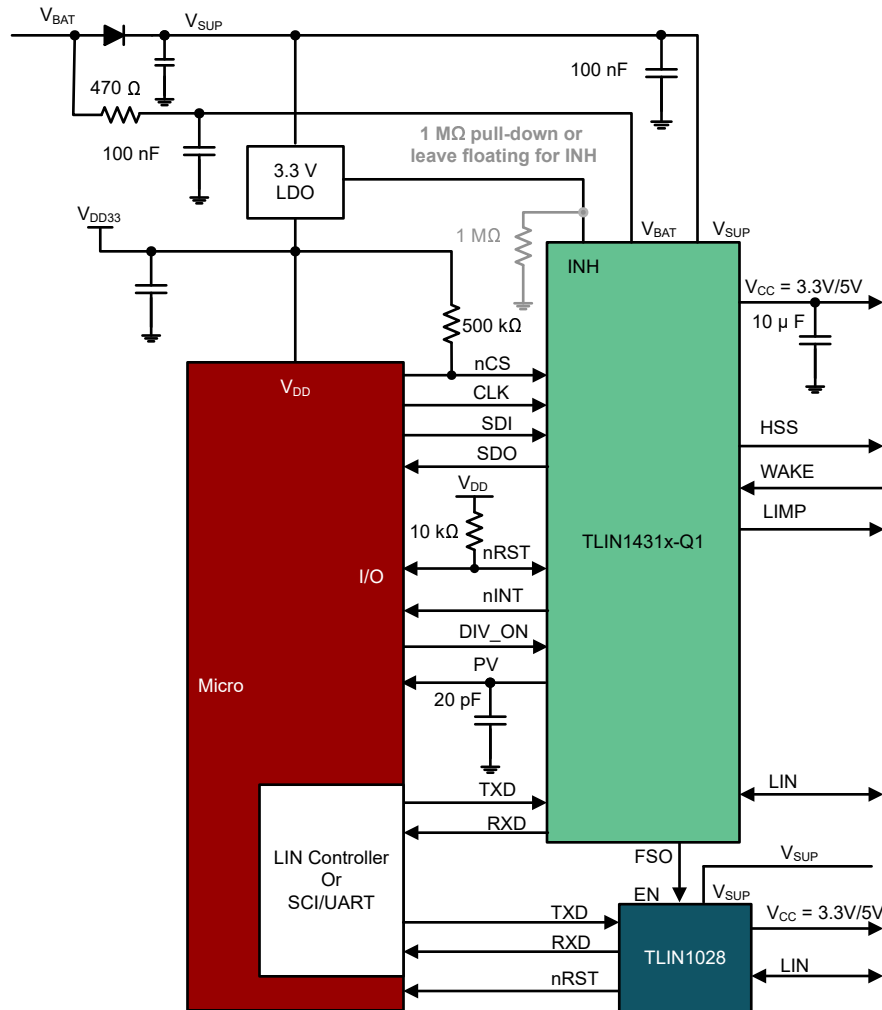


Figure 8-21. Channel Expansion: LIN SBC

### 8.3.23.2 Channel Expansion for CAN Transceiver

It is possible to add an external CAN transceiver or general purpose CAN SBC. For a simple CAN transceiver, the 5 V VCC from the TLIN14315-Q1 can power the external transceiver. When the TLIN14315-Q1 enters sleep mode the LDO is turned off which turns off the 5 V to the transceiver. There are other instances that this can take place depending upon various fault conditions like thermal shut down. Using the 3.3 V version of the device can power a 3.3 V CAN transceiver. If an external general purpose SBC is used, VCC can be used to power up other components as the SBC will also receive its input power from V<sub>SUP</sub>. The FSO pin when configured as a general-purpose output pin is used as the STB/nSTB/S control pin in order to control the mode of the external CAN transceiver or SBC.

- Register 8'h29[3:1] = 110b sets the FSO pin as a general-purpose output pin EN/STB/nSTB/S pin.
- Register 8'h29[4] sets the level of the FSO pin and can be connected to the external CAN transceiver or SBC STB/nSTB/S pin.

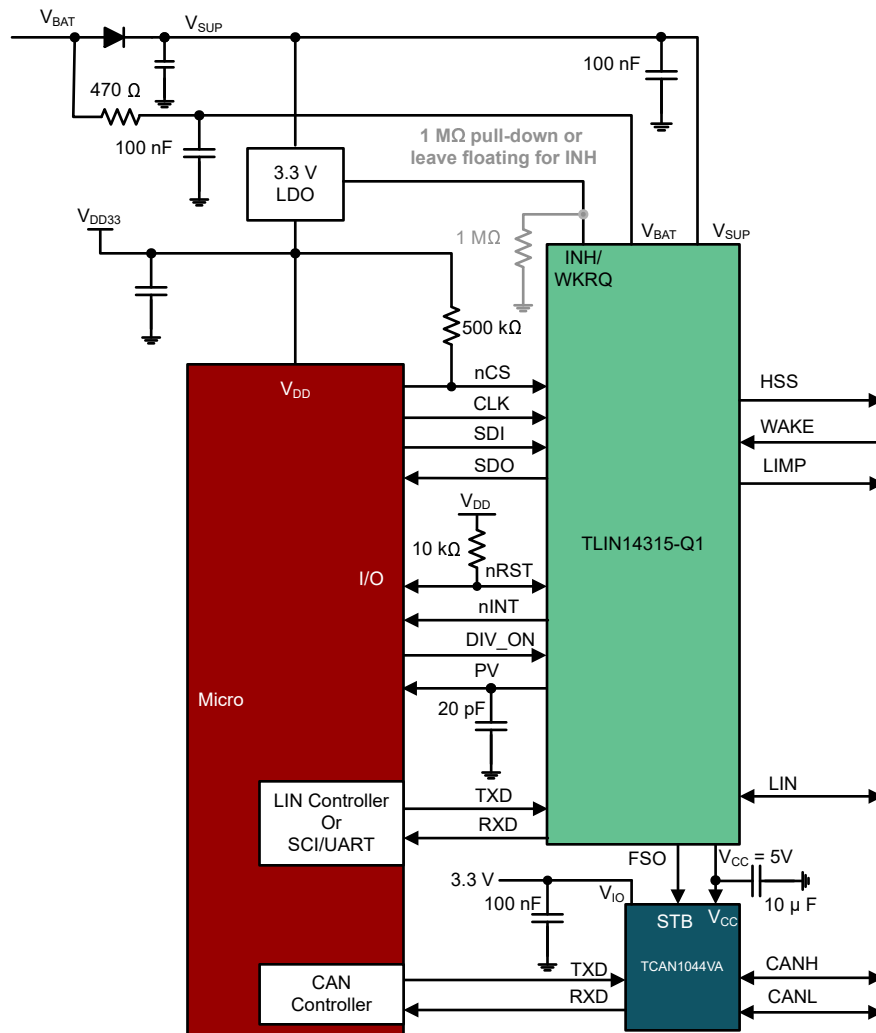
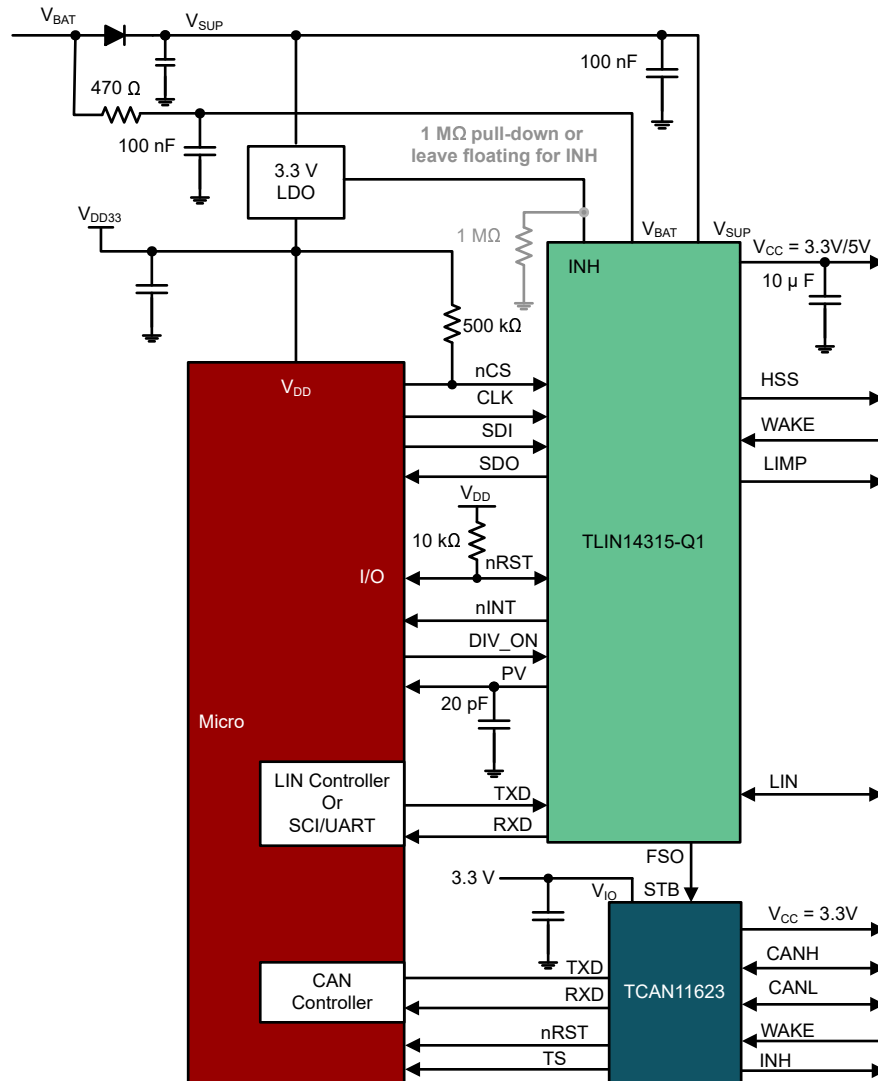


Figure 8-22. Channel Expansion: CAN Transceiver



**Figure 8-23. Channel Expansion: CAN SBC**

## 8.4 Device Functional Modes

The TLIN1431x-Q1 has multiple functional modes of operation, Init, pin/SPI Init, normal, standby, sleep, restart and fail-safe. The next sections describe these modes as well as how the device moves between the different modes. Figure 8-24 and Figure 8-25 graphically shows the relationship while Table 8-4 and tables show the state of pins in each control mode. Upon power up, and once  $V_{CC} \geq UV_{CC}$  prior to  $t_{INACT\_FS}$  timing out the device enters an initialization mode (INIT). While in this mode,  $V_{CC}$  is ramping,  $nRST$  ramps with  $V_{CC}$ , all other pins are off except for monitoring the state of the Pin/ $nCS$  pin to determine which control method is being implemented. Once the control method is determined, the device follows the pin control or SPI control path of the state diagram.

**Table 8-4. Operating PIN Mode**

| Function             | Restart Mode         | Sleep Mode           | Standby Mode                                           | Normal Mode     | Fail-safe Mode       | Fast Mode       |
|----------------------|----------------------|----------------------|--------------------------------------------------------|-----------------|----------------------|-----------------|
| EN                   | NA                   | Low                  | Low                                                    | High            | NA                   | Pulse then high |
| RXD                  | High                 | Floating             | Low for a wake event and power up event otherwise high | Mirrors LIN bus | Floating             | Mirrors LIN bus |
| LIN BUS Termination  | Weak current pull-up | Weak current pull-up | 45 kΩ (typical)                                        | 45 kΩ (typical) | Weak current pull-up | 45 kΩ (typical) |
| Vbat Voltage Divider | Off                  | Off                  | On                                                     | On              | Fault dependent      | On              |

**Table 8-4. Operating PIN Mode (continued)**

| Function        | Restart Mode                                                                                                                                                          | Sleep Mode                                                                | Standby Mode                                            | Normal Mode                                                  | Fail-safe Mode                                                | Fast Mode                                                  |
|-----------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------|---------------------------------------------------------|--------------------------------------------------------------|---------------------------------------------------------------|------------------------------------------------------------|
| Transmitter     | Off                                                                                                                                                                   | Off                                                                       | Off                                                     | On                                                           | Off                                                           | On (Slope control off)                                     |
| Watchdog        | Off                                                                                                                                                                   | Off                                                                       | On with long first pulse                                | On                                                           | Off                                                           | On but only sets flag                                      |
| nRST Pin        | Low                                                                                                                                                                   | Low                                                                       | High                                                    | High                                                         | LDO state dependent                                           | High                                                       |
| WAKE Pin        | Off                                                                                                                                                                   | On                                                                        | On                                                      | Off                                                          | On                                                            | Off                                                        |
| WKRQ/INH        | On                                                                                                                                                                    | Off                                                                       | On                                                      | On                                                           | INH - On; WKRQ - Fault dependent                              | On                                                         |
| LIMP            | <ul style="list-style-type: none"> <li>Same as previous state when due to a WD fault</li> <li>Turns off when exiting fail-safe mode due to any other fault</li> </ul> | Off                                                                       | Previous state prior to entering STBY due to WD fault   | Previous state prior to entering normal mode due to WD fault | On                                                            | Previous state prior to entering fast mode due to WD fault |
| HSS             | Off                                                                                                                                                                   | Off                                                                       | On and controlled by HSSC pin                           | On and controlled by HSSC pin                                | Off                                                           | On and controlled by HSSC pin                              |
| V <sub>CC</sub> | Ramping                                                                                                                                                               | Off                                                                       | On                                                      | On                                                           | Fault dependent                                               | On                                                         |
| Comment         |                                                                                                                                                                       | nRST is internally connected to the LDO output which in sleep mode is off | Wake up event detected, waiting on processors to set EN | LIN transmission up to 20 kbps                               | LDO off for TSD, V <sub>CCSC</sub> or OV <sub>CC</sub> events | LIN transmission up to 200 kbps                            |

**Note**

LDO state for fault dependent in fail-safe mode is as follows:

- Watchdog error - On
- Thermal shut down - Off
- UV<sub>CC</sub> - On
- OV<sub>CC</sub> over-voltage - Off
- V<sub>CCSC</sub> - Off
- Restart counter exceeded - On
- SWE timer expiration - On

If TXD is held dominant when device enters normal or fast modes, the LIN transmitter does not turn on until the TXD pin goes recessive.

If V<sub>SUP</sub> is ≤ UV<sub>SUP</sub> WKRQ/INH is off.

WKRQ depends upon the LDO being on, so any event that causes the LDO to be turned off will turn off WKRQ.

Any WD failure in Fast Mode will only set interrupt and not take any other action (will not set LIMP, transition to Fail-safe or Restart or take any WD fail action)

- nRST depends upon the LDO state. When LDO is on, nRST reflects the LDO value.
  - When LDO is on, nRST reflects the LDO or I/O voltage value except for a UV<sub>CC</sub> event where nRST is low.
  - When LDO is off, nRST is low.

**Table 8-5. Operating SPI Mode**

| Function             | Restart Mode         | Sleep Mode           | Standby Mode                                           | Normal Mode     | Fail-safe Mode       | Fast Mode              |
|----------------------|----------------------|----------------------|--------------------------------------------------------|-----------------|----------------------|------------------------|
| RXD                  | High                 | Floating             | Low for a wake event and power up event otherwise high | Mirrors LIN bus | Fault dependent      | Mirrors LIN bus        |
| LIN BUS Termination  | Weak current pull-up | Weak current pull-up | 45 kΩ (typical)                                        | 45 kΩ (typical) | Weak current pull-up | 45 kΩ (typical)        |
| Vbat Voltage Divider | Off                  | Off                  | On                                                     | On              | Fault dependent      | On                     |
| Transmitter          | Off                  | Off                  | Off                                                    | On              | Off                  | On (Slope control off) |

**Table 8-5. Operating SPI Mode (continued)**

| Function        | Restart Mode                                                                                                                                                                                                            | Sleep Mode                                                                | Standby Mode                                           | Normal Mode                                                                                          | Fail-safe Mode                                                | Fast Mode                                                  |
|-----------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------|--------------------------------------------------------|------------------------------------------------------------------------------------------------------|---------------------------------------------------------------|------------------------------------------------------------|
| Watchdog        | Off                                                                                                                                                                                                                     | Off                                                                       | Default on with long first window but programmable off | On<br>If programmed off in standby mode when entering normal mode a long first window is implemented | Off                                                           | On but only sets flag                                      |
| SPI pins        | Off                                                                                                                                                                                                                     | Off                                                                       | On                                                     | On                                                                                                   | Fault dependent                                               | On                                                         |
| nINT pin        | Off                                                                                                                                                                                                                     | Off                                                                       | On                                                     | On                                                                                                   | Fault dependent                                               | On                                                         |
| nRST pin        | Low                                                                                                                                                                                                                     | Low                                                                       | High                                                   | High                                                                                                 | LDO state dependent                                           | High                                                       |
| WAKE Pin        | Off                                                                                                                                                                                                                     | On                                                                        | On                                                     | Off                                                                                                  | On                                                            | Off                                                        |
| WKRQ/INH        | On                                                                                                                                                                                                                      | Off                                                                       | On                                                     | On                                                                                                   | INH - On; WKRQ - Fault dependent                              | On                                                         |
| LIMP            | <ul style="list-style-type: none"> <li>Same as previous state when due to a WD fault</li> <li>When exiting fail-safe mode due to any other fault how 8'h1A[3:2] is programmed determines how LIMP is cleared</li> </ul> | Off                                                                       | Previous state prior to entering STBY due to WD fault  | Previous state prior to entering normal mode due to WD fault                                         | On                                                            | Previous state prior to entering fast mode due to WD fault |
| HSS             | Off                                                                                                                                                                                                                     | Off unless cyclic sensing enabled                                         | On                                                     | On                                                                                                   | Off                                                           | On                                                         |
| V <sub>CC</sub> | Ramping                                                                                                                                                                                                                 | Off                                                                       | On                                                     | On                                                                                                   | Fault dependent                                               | On                                                         |
| Comment         |                                                                                                                                                                                                                         | nRST is internally connected to the LDO output which in sleep mode is off | Wake up event detected, waiting on processors          | LIN transmission up to 20 kbps                                                                       | LDO off for TSD, V <sub>CCSC</sub> or OV <sub>CC</sub> events | LIN transmission up to 200 kbps                            |

### Note

Function status when in fail-safe mode that states fault dependent are defined in [Table 8-6](#)

If TXD is held dominant when device enters normal or fast modes, the LIN transmitter does not turn on until the TXD pin goes recessive.

If  $V_{SUP}$  is  $\leq UV_{SUP}$  WKRQ/INH is off.

WKRQ depends upon the LDO being on, so any event that causes the LDO to be turned off will turn off WKRQ.

Any WD failure in Fast Mode will only set interrupt and not take any other action (will not set LIMP, transition to Fail-safe or Restart or take any WD fail action)

**Table 8-6. Fault Dependent States In Fail-safe Mode**

| Function           | Watchdog Error | Thermal Shutdown | UV <sub>CC</sub> | V <sub>CC</sub> Over Voltage | V <sub>CCSC</sub> | Restart Counter Exceeded |
|--------------------|----------------|------------------|------------------|------------------------------|-------------------|--------------------------|
| LDO <sup>(2)</sup> | On             | Off              | On               | Off                          | Off               | On <sup>(1)</sup>        |
| INH                | Programmed     | On               | On               | On                           | On                | On                       |
| WKRQ               | Programmed     | Off              | Off              | Off                          | Off               | On                       |
| SPI                | On             | Off              | On               | Off                          | Off               | On                       |

(1) LDO is on in fail-safe mode if the restart counter causes the change when fail-safe mode is enabled.

(2) LDO is on in fail-safe mode if the SWE timer times out causing the device to enter fail-safe mode if enabled.

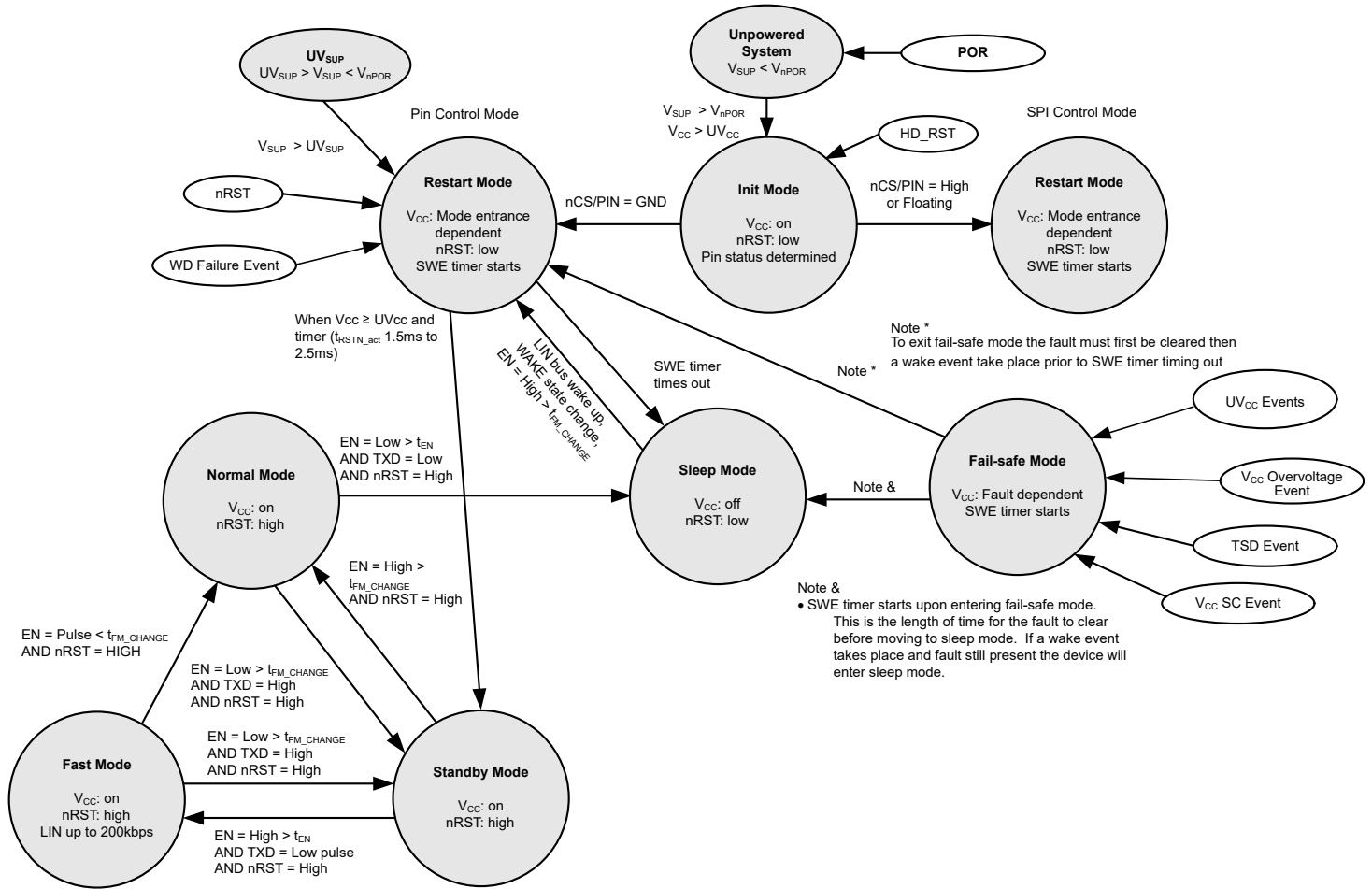
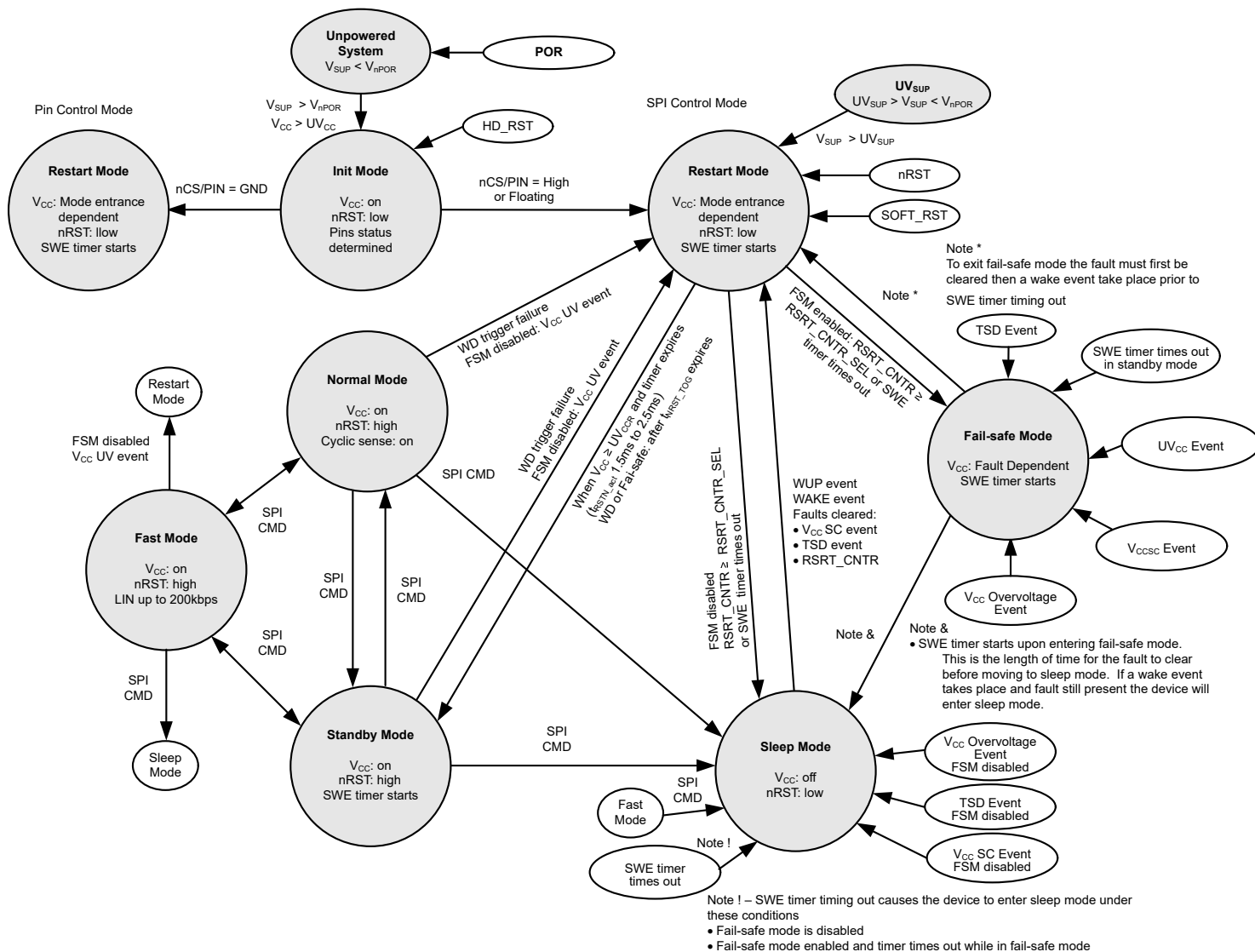


Figure 8-24. Pin control state diagram

**Note**

Normal mode can be entered from Fast mode with TXD in either state:

- TXD = high, EN = pulse  $< t_{FM\_CHANGE}$  and  $nRST = \text{high}$
- TXD = low,  $nRST = \text{high}$  and  $\overline{EN}$  pulse can be any width



**Figure 8-25. SPI control state diagram**

### 8.4.1 Init Mode

This is the initial mode of operation upon powering up. This is a transitional mode that is entered once  $V_{CC} \geq UV_{CC}$ . The device is in this mode for  $\leq 350 \mu s$  as it determines the states of pin 7, PIN/nCS and pin 16, WKRQ/INH; see Figure 8-5 and Figure 8-6. The  $V_{CC}$  fault monitoring will be active to determine if there is a TSD,  $OV_{CC}$  or  $V_{CCSC}$  faults which takes approximately 2.5 ms. If one of these faults are detected, the device will perform as described in Section 8.3.22.5 and Section 8.3.22.9.1. If  $V_{CC} < UV_{CC}$ , The device will remain in Init mode until  $V_{CC} > UV_{CC}$ . If a fault takes place that keeps the device from determining the state of the pins, the device will default to pin control.

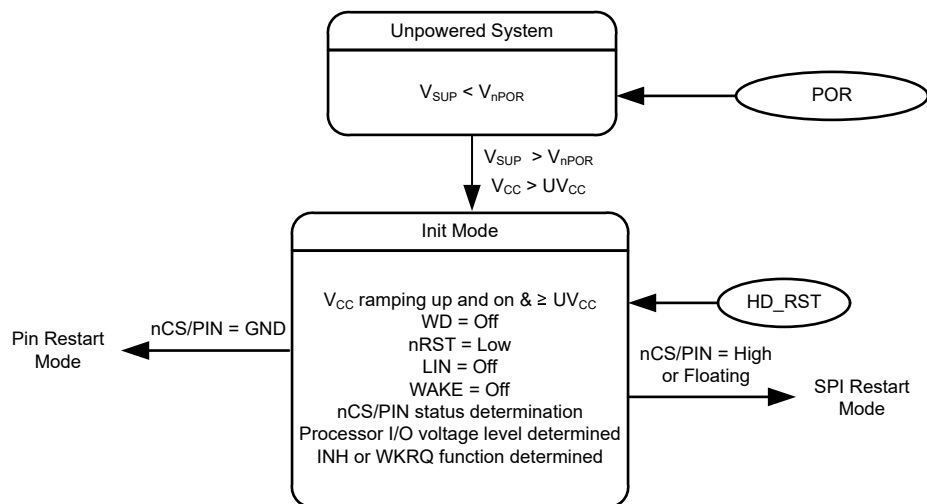


Figure 8-26. Init Mode

### 8.4.2 Normal Mode

In normal operational mode, the receiver and transmitter are active and the LIN transmission up to the LIN specified maximum of 20 kbps is supported. The receiver detects the data stream on the LIN bus and outputs it on RXD for the LIN controller. A recessive signal on the LIN bus is a digital high and a dominant signal on the LIN bus is a digital low. The driver transmits input data from TXD to the LIN bus. When entering normal mode, it takes  $t_{MODE\_CHANGE}$  before data on RXD pin reflects the LIN bus. Normal mode can be entered from Fast mode and standby mode. See Figure 8-24 for the conditions necessary to enter normal mode when in pin control.

In SPI control mode, Normal mode is entered by SPI commands at register 8'h1D[7:6] = 10b. See Figure 8-25 for the conditions necessary to enter normal mode when in pin control.

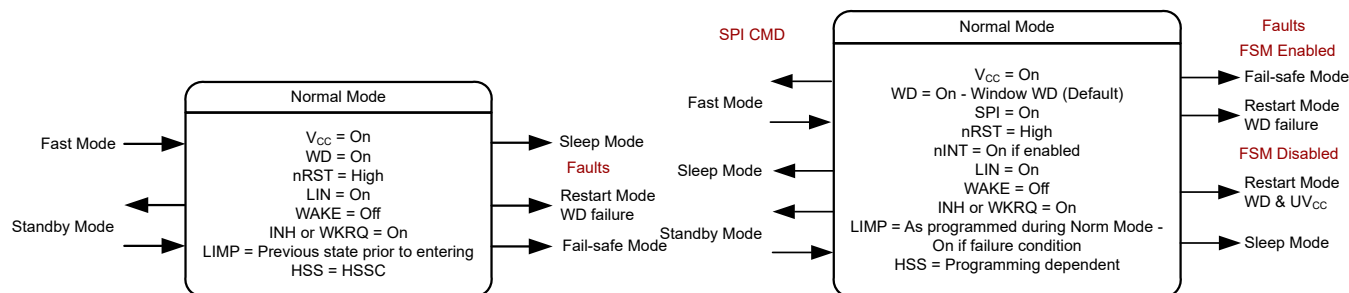


Figure 8-27. Normal Mode Pin Control

Figure 8-28. Normal Mode SPI Control

### 8.4.3 Fast Mode

Fast mode removes the slope control for the LIN transmitter allowing the LIN bus to support data rates up to 200 kbps. Fast mode is also the system software programming mode and debug mode. The watchdog is active but only indicates a WD failure and does not cause any resets or mode changes. Fast mode can be entered in either SPI or pin control modes. In SPI mode it is entered from normal or standby modes. In pin mode, it can be entered from standby mode. To enter fast mode from standby, the EN pin must be high with a high-low-high pulse on the TXD pin of duration  $t_{FMTXD}$  takes place prior to  $t_{FM\_CHANGE}$  timing out, see Figure 8-31. In pin control mode, to leave fast mode the enable pin and TXD pins are used. If TXD pin is high and the EN pin is pulsed from high too low too high for  $t_{FM\_CHANGE}$ , the device enters standby mode, see Figure 8-32. If the EN pin is pulsed high too low too high with the pulse being  $< t_{FM\_CHANGE}$ , the device enters normal mode, see Figure 8-33.

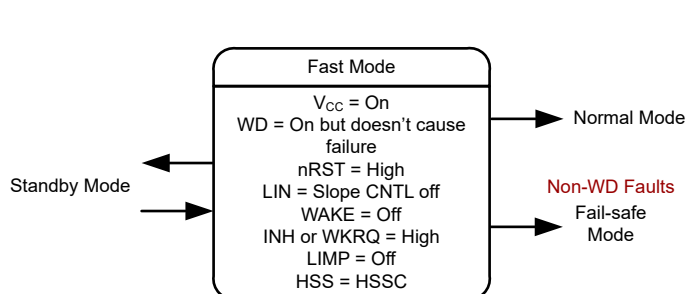


Figure 8-29. Fast Mode Pin Control

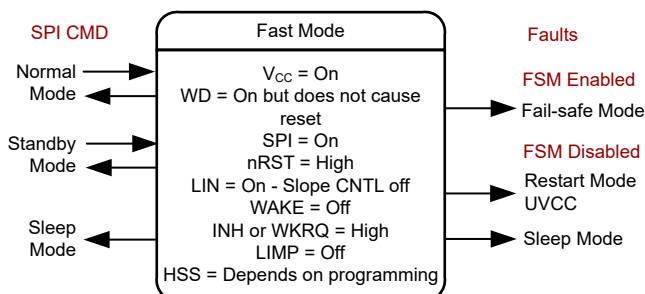


Figure 8-30. Fast Mode SPI Control

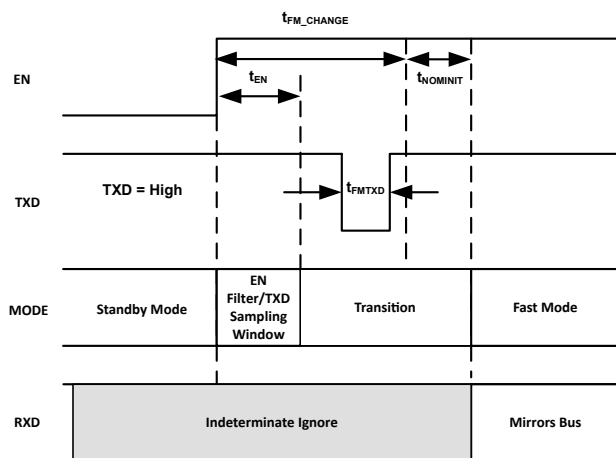


Figure 8-31. Entering Fast Mode from Standby Mode

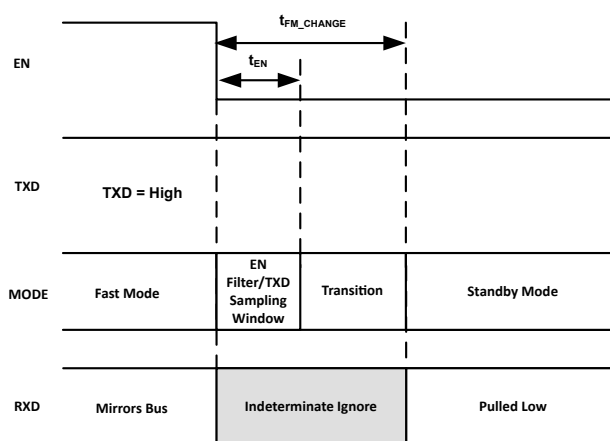


Figure 8-32. Exiting Fast Mode to Standby Mode

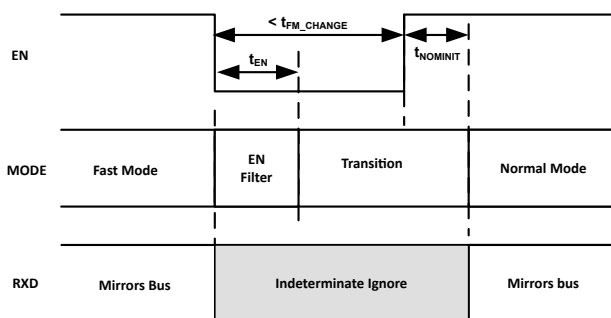


Figure 8-33. Exiting Fast Mode to Normal Mode

### 8.4.4 Sleep Mode

Sleep Mode is the power saving mode for the TLIN1431x-Q1. Even with extremely low current consumption in this mode, the device can still wake up from the LIN bus through a wake up signal or local wake via WAKE pin. Upon a wake event the SWE timer,  $t_{\text{INACT\_FS}}$ , starts and the device enters restart mode. If  $UV_{CC}$  is still present after this time, the device re-enters sleep mode. The LIN bus is filtered to prevent false wake up events. The wake-up events must be active for the respective time periods ( $t_{\text{LINBUS}}$ ).

In pin control mode, sleep mode is entered by setting EN low for longer than  $t_{\text{EN}}$  and TXD pin is low when entered from normal mode.

In SPI control mode, setting register 8'h1D[7:6] = 01b transitions the device into sleep mode. If the reset counter exceeds three, the device enters sleep mode from restart mode. The reset counter increments on an  $UV_{CC}$  event, or a watchdog error event that causes the device to enter restart mode when fail-safe mode is disabled. The reset counter must be cleared through a SPI command.

While the device is in sleep mode, the following conditions exist.

- The LIN bus driver is disabled and the internal LIN bus termination is switched off (to minimize power loss if LIN is short circuited to ground). However, the weak current pull-up is active to prevent false wake up events in case an external connection to the LIN bus is lost.
- The normal receiver is disabled.
- LIN wake up receiver is active.
- WAKE pin is active.

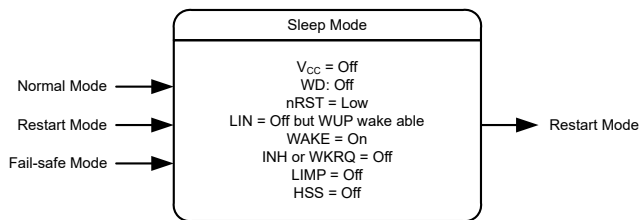


Figure 8-34. Sleep Mode Pin Control

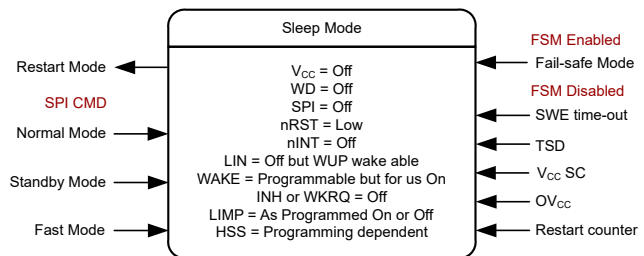


Figure 8-35. Sleep Mode SPI Control

### 8.4.5 Standby Mode

This mode is entered from various other modes based upon which control method is implemented, the pin control [Figure 8-24](#) or SPI control [Figure 8-25](#). The LIN bus responder node termination circuit is turned on when standby mode is entered. Standby mode is signaled through a low level on RXD. See [Standby Mode Application Note](#) for more application information.

When EN (in Pin Control Mode) is set high for longer than  $t_{\text{FM\_CHANGE}}$  while the device is in standby mode the device returns to normal mode and the normal transmission paths from TXD to LIN bus and LIN bus to RXD are enabled.

During power up, the device automatically enters standby mode from restart mode. EN has an internal pull-down resistor ensuring EN is pulled low if the pin is left floating in the system.

In both pin and SPI modes, the watchdog is default on in standby mode. There is a long timeout initial window that is  $t_{\text{INITWD}}$  that a WD trigger event must take place. In SPI mode, watchdog can be disabled when entering standby mode except for cases that the device has had a POR event.

The device automatically enters standby mode from restart mode when  $V_{CC} \geq UV_{CC}$  and  $t_{\text{RSTN\_act}}$  time has expired. When in SPI communication mode, the TLIN1431x-Q1 can enter standby mode by writing a 00 to register 8'h1D[7:6] from normal or fast modes. The watchdog function is default on in standby mode. When using SPI to configure the device, the watchdog function can be configured.

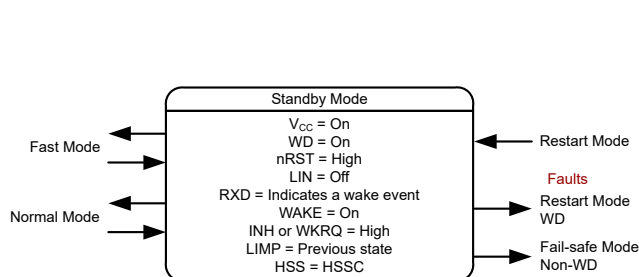


Figure 8-36. Standby Mode Pin Control

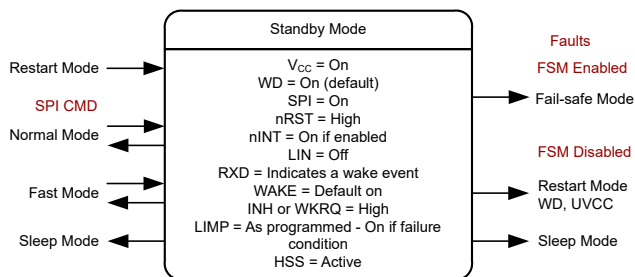


Figure 8-37. Standby Mode SPI Control

### 8.4.6 Restart Mode

Restart mode is a transitional mode. This mode can be entered from any of the other modes depending upon whether fail-safe mode is disabled. In this mode, the LDO is ramping when coming from sleep mode or fail-safe mode where the LDO was turned off, like a TSD event. Once  $V_{CC} \geq UV_{CC}$  for  $t_{RSTN\_act}$  (~2 ms), the device enters standby mode. While in restart mode, the nRST pin is latched low. Each time restart mode is entered the restart mode counter is incremented.

#### Note

The SWE timer starts when the device enters restart mode. If the SWE timer times out, the device enters fail-safe mode. If fail-safe mode is disabled, the device enters sleep mode.

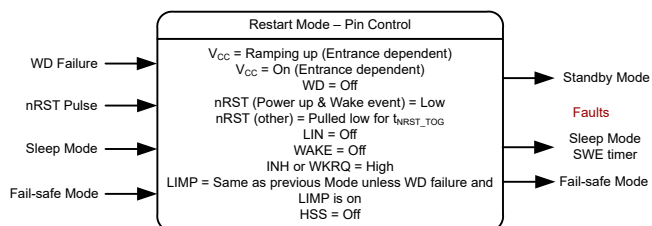


Figure 8-38. Restart Mode Pin Control

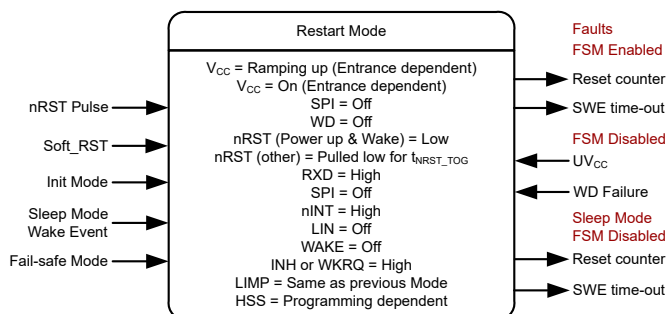
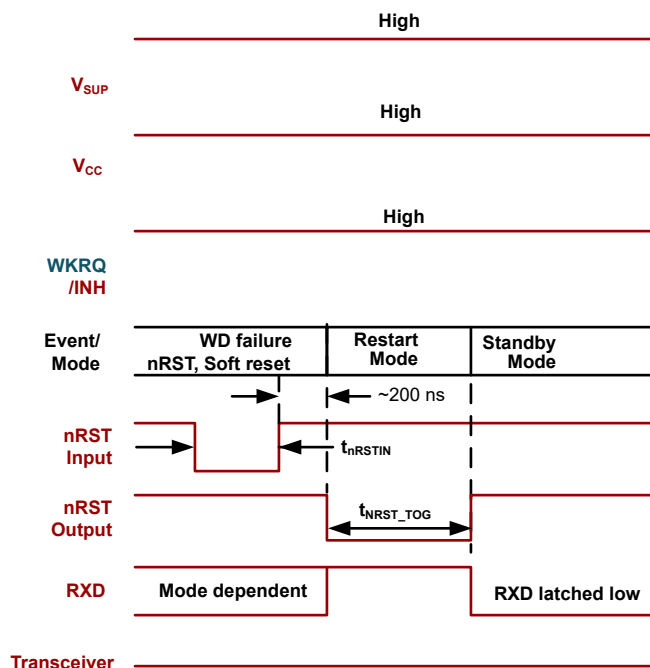


Figure 8-39. Restart Mode SPI Control



#### Note

- A watchdog failure, soft reset or nRST event resets  $t_{nRST\_TOG}$  to default value of typically 2 ms
- The typical time between the release of a nRST input pulse for device to enter restart mode is ~ 200 ns

**Figure 8-40. Entering Restart Mode**

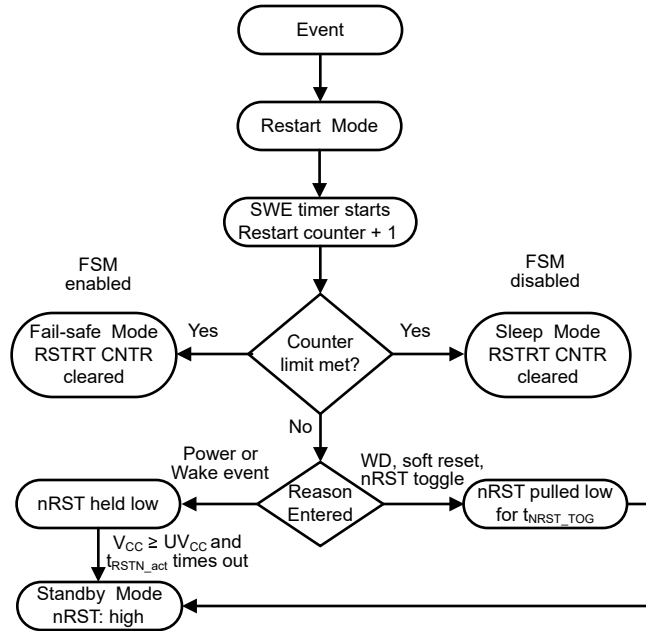
#### 8.4.6.1 Restart Counter

This counter is programmed by register 8'h28[7:4] which sets the number of times restart can be entered before transitioning to sleep or fail-safe mode, up to 14 times but should be programmed for greater than 1 to avoid possible loops. The default value is 4. Register 8'h28[3:0] is the counter. To prevent the transition to sleep or fail-safe mode, the counter should be cleared periodically. Entering sleep mode or fail-safe mode due to a meeting the restart counter automatically clears the restart counter.

#### 8.4.6.2 nRST Behavior in Restart Mode

The nRST output pin behavior depends upon the reason the device entered restart mode. When entered from other modes due to a watchdog failure, soft reset or an external nRST toggle, the nRST pin is pulled low for  $t_{nRST\_TOG}$  which is a default pulse width of 2 ms. This pulse width can be configured to 15 ms by changing register 8'h29[5] = 1b. In pin control, the pulse width on nRST is always nominally 15 ms for a watchdog failure. Once the timer expires, the device enters standby mode. From power up, sleep and certain fail-safe modes, the nRST behaves like the  $UV_{CC}$  event, pulling nRST low until  $V_{CC} > UV_{CC}$  and  $t_{RSTN\_act}$  times out. See [Figure 8-41](#) on how the nRST pin behaves when entering restart mode.

The nRST pin is also a TLIN1431x-Q1 reset input which transitions the device into restart mode when the pin is pulled low for  $t_{nRSTIN}$ .

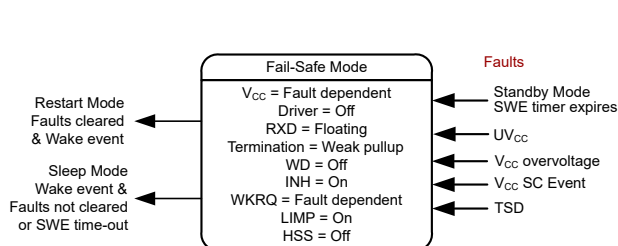


- Note:
1. Wake event means entered from sleep or fail-safe modes
  2. If SWE timer times out device will enter sleep or fail-safe mode
  3. nRST toggle reason is an external toggle of nRST pin to reset device
  4. A soft reset or external nRST toggle will reset  $t_{NRST\_TOG}$  to default value, typically 2 ms

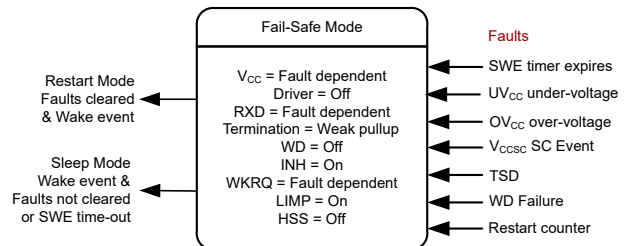
**Figure 8-41. nRST Behavior in Restart Mode**

### 8.4.7 Fail-safe Mode

When the TLIN1431x-Q1 has certain fault conditions, the device enters a fail-safe mode (FSM). This feature can be disabled in SPI control mode, but is always on in pin control mode. This mode turns on LIMP and brings all other function into lower power mode states. Fault conditions are over-voltage on  $V_{CC}$ , thermal shutdown,  $V_{CC}$  under-voltage events and reaching restart counter limit in SPI control mode. When entering FSM, a fail-safe mode counter is incremented. The counter limit is set at register 8'h18[7:4], FSM\_CNTR\_SET and should be set to greater than 1. To avoid unwanted actions the counter should be cleared by writing 0h to 8'h18[3:0]. If the limit is reached a programmed action will be executed, register 8'h17[7:4], FSM\_CNTR\_ACT. Once the fault conditions are cleared, the device can be put back into restart mode from a wake event. If a fault condition is still in effect after the wake event the device enters sleep. If no wake event takes place, the device enters sleep mode after the programmed SWE timer,  $t_{INACT\_FS}$ , times out.



**Figure 8-42. Fail-safe Mode Pin Control**



**Figure 8-43. Fail-safe Mode SPI Control**

### Note

When the device enters fail-safe mode, the SWE timer automatically starts.

- If SWE timer times out, the device enters sleep mode
- If a wake event takes place prior to the SWE timer timing out, the device determines if fault is still present.
  - If fault is present, the device enters sleep mode.
  - If fault has cleared, the device enters restart mode.

When fail-safe mode is entered due to a thermal shutdown (TSD),  $V_{CC}$  over-voltage ( $OV_{CC}$ ) or a  $V_{CC}$  short circuit ( $V_{CCSC}$ ) event the following takes place:

- LDO is turned off
- If the device receives a wake event, the LDO is turned on for  $t_{LDOON}$  to determine if the TSD,  $OV_{CC}$  or  $V_{CCSC}$  event is still present.
  - During this window, if a TSD or  $OV_{CC}$  is detected the device immediately enters sleep mode.
  - At the end of  $t_{LDOON}$  window, if a  $V_{CCSC}$  is detected the device enters sleep mode.
- If fault is cleared, the device enters restart mode.

If the device enters fail-safe mode and  $V_{CC}$  is on, the  $t_{LDOON}$  timer is started and expires before the device transitions to restart mode.

## 8.4.8 Wake Up Events

There are three ways to wake-up from sleep mode depending upon control mode, pin or SPI:

1. Remote wake up initiated by the falling edge of a recessive (high) to dominant (low) state transition on the LIN bus where the dominant state is held for  $t_{LINBUS}$  filter time. After this  $t_{LINBUS}$  filter time has been met and a rising edge on the LIN bus going from dominant state to recessive state initiates a remote wake-up event eliminating false wake ups from disturbances on the LIN bus or if the bus is shorted to ground. Active for both pin and SPI control modes.
2. Local wake up through EN being set high for longer than  $t_{MODE\_CHANGE}$ . Active for pin control mode.
3. Local wake up through WAKE pin
  - Being set high or low for longer than  $t_{MODE\_CHANGE}$ . Active for both pin and SPI mode.
  - Only active during on-time cyclic sense period. Active for SPI mode.

### Note

- Remote and local wake up are also valid wake events when the device enters fail-safe mode. The EN pin will not wake the device if it has entered fail-safe mode.
- When a wake event takes place and INH is selected, it is turned on with in  $t_{INH\_SLP}$ .
- When WKRQ is used, a wake event requires the LDO to be on and the voltage level to exceed 2 V. Once this happens, the WKRQ pin ramps with  $V_{CC}$  until it expected voltage level.

### 8.4.8.1 Wake Up Request (RXD)

When the TLIN1431x-Q1 encounters a wake up event from the LIN bus the device transitions to restart mode. In restart mode, the LDO is turned on and ramps until  $V_{CC} > UV_{CC}$  at which time the device enters either Normal mode, Fast mode or Standby mode depending upon the device control method. In Restart mode, RXD is pulled high. After  $V_{CC}$  has exceeded  $UV_{CC}$  for  $t_{RSTN\_act}$ , the device transitions to standby mode and RXD is latched low. Once the device enters normal mode, the RXD pin releases the wake up request signal and the RXD pin then reflects the receiver output from the LIN bus. RXD can be programmed to toggle low or high when in standby mode from a wake event.

### 8.4.8.2 Local Wake Up (LWU) via WAKE Terminal

The WAKE terminal is a ground referenced input terminal supporting high voltage wake inputs used for local wake up (LWU) request via a voltage transition. The terminal triggers an LWU event on either a low to high or high to low transition as it has bi-directional input thresholds. This terminal may be used with a switch to VSUP

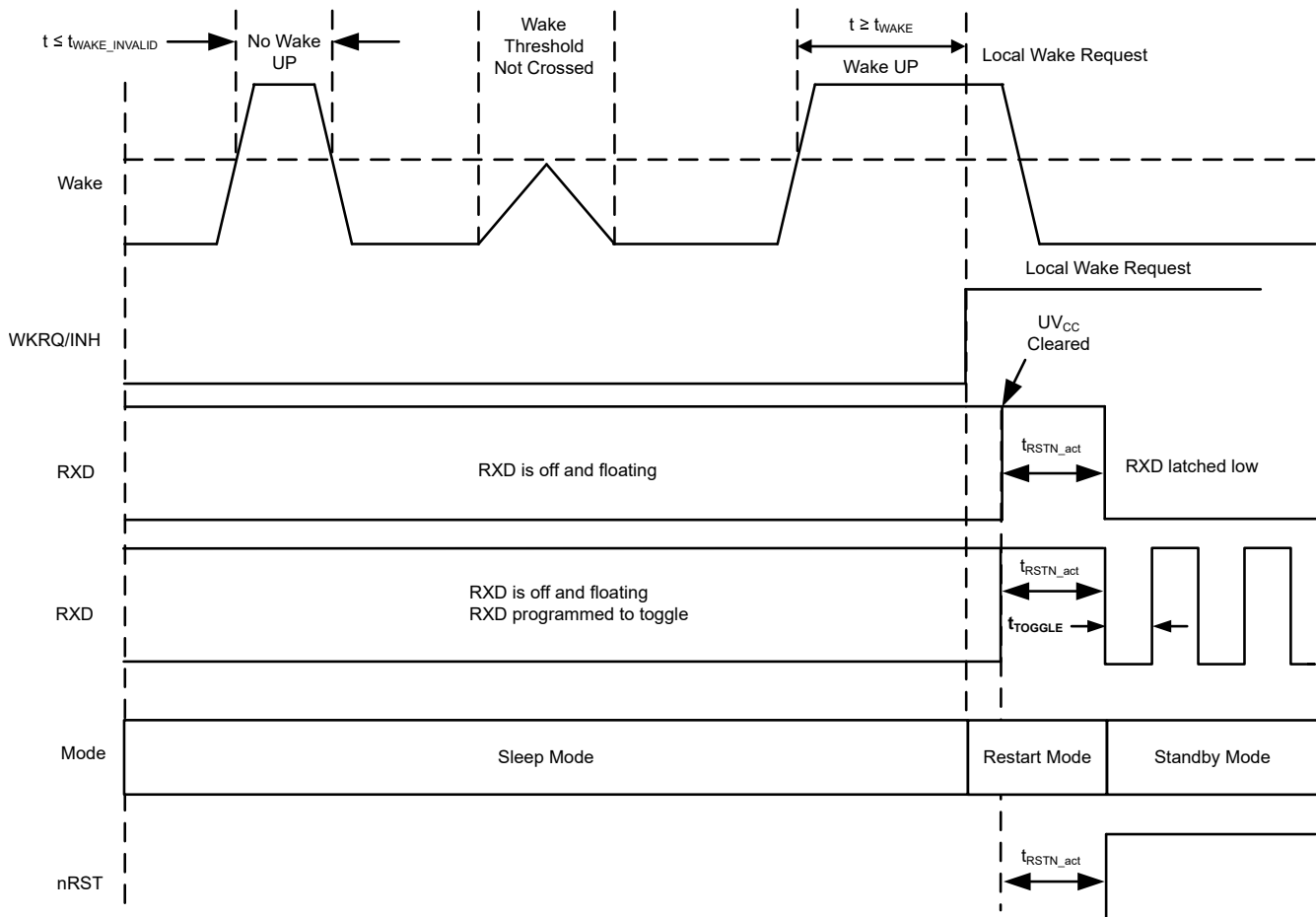
or ground. If the terminal is not used it should be pulled to ground to avoid unwanted parasitic wake up events. There are two methods for using the WAKE pin:

1. Static wake
2. Cyclic sensing wake

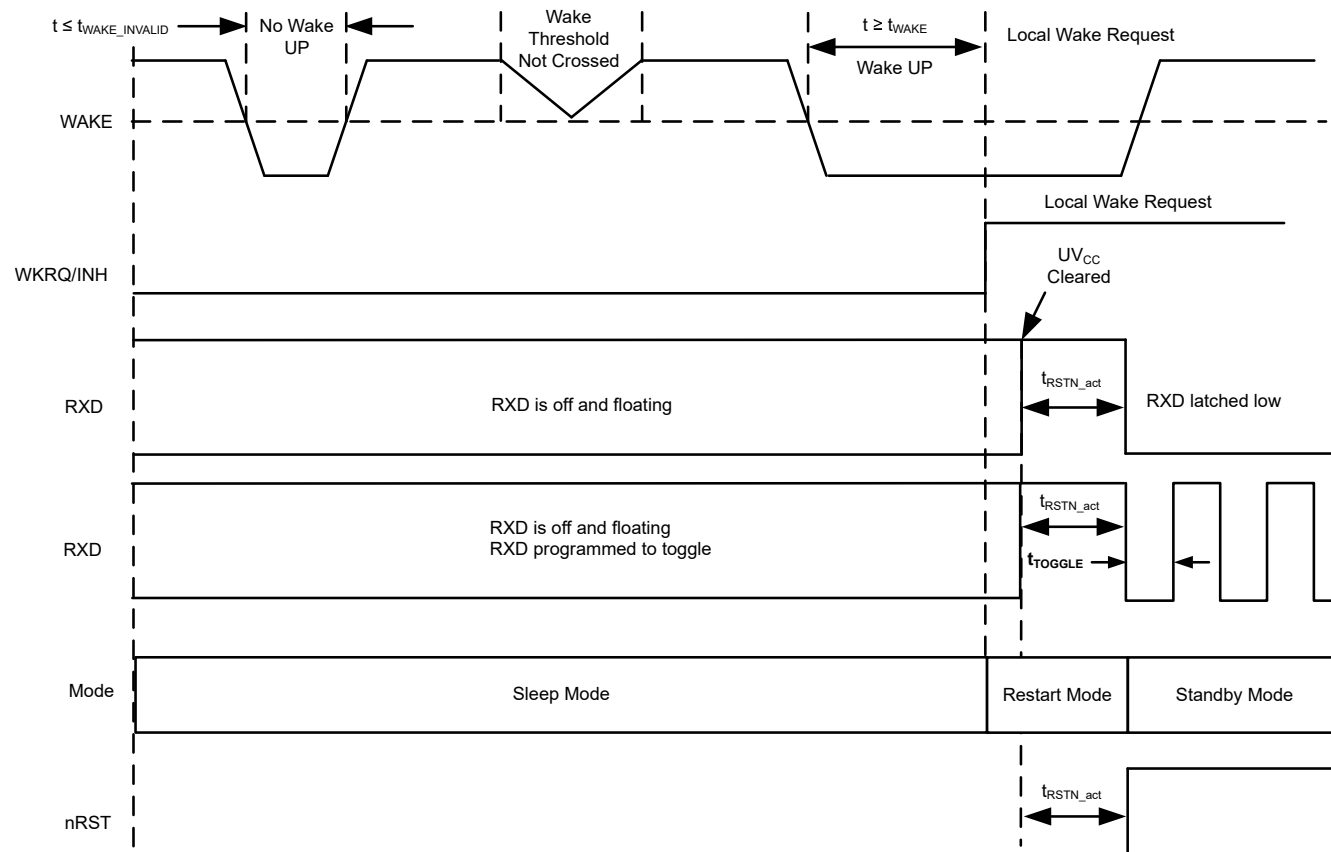
#### 8.4.8.2.1 Static WAKE

The WAKE terminal defaults to bi-directional input but can be configured for rising edge and falling edge transitions by using register 8'h11[7:6] WAKE\_CONFIG (see Figure 8-44 and Figure 8-45). Once the device enters sleep mode the WAKE terminal voltage level needs to be at either a low state or high state for  $t_{WAKE}$  before a state transition for a WAKE input can be determined. A pulse width less than  $t_{WAKE\_INVALID}$  is filtered out.

The LWU circuitry is active in sleep mode, standby and fail-safe modes. If a valid LWU event occurs, the device transitions to restart mode. The LWU circuitry is not active in normal, fast and restart modes. To minimize system level current consumption, the internal bias voltages of the terminal follows the state on the terminal with a delay of  $t_{WAKE}$ . A constant low level on WAKE has an internal pull-down to ground. On power up, this may look like a LWU event and could be flagged as such. The device provides a WAKE pin status change update using register 8'h11[5:4]. The status change will lock in a change in the WAKE pin and needs to be cleared.



**Figure 8-44. Local Wake Up (LWU) - Rising Edge**



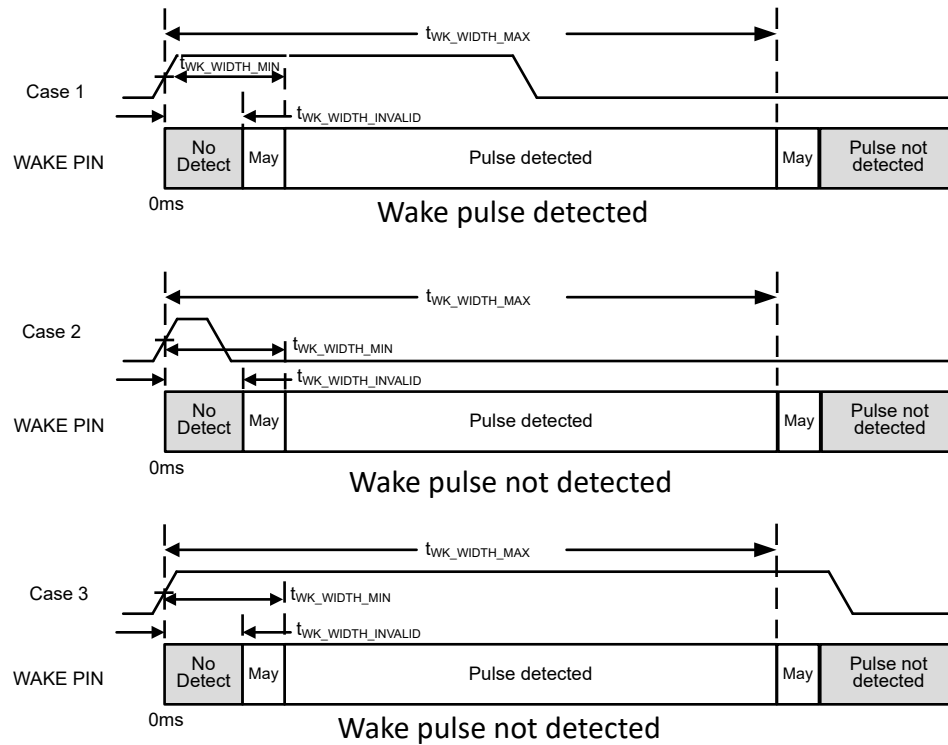
**Figure 8-45. Local Wake Up (LWU) - Falling Edge**

#### Note

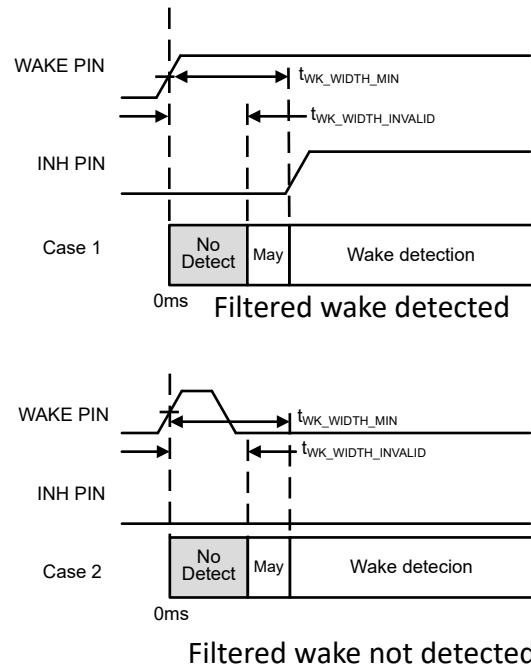
These figures show the state of the RXD pin after a WAKE pin event. The transition to standby mode is shown in the state diagrams but is based upon the following:

- PIN Mode: All must take place
  - WAKE pin event recognized
  - $V_{CC}$  goes above  $UV_{CC}$  for  $> t_{RSTN\_act}$
  - EN pin is High for  $> t_{EN}$
- SPI Mode: All must take place
  - WAKE pin event recognized
  - $V_{CC}$  goes above  $UV_{CC}$  for  $> t_{RSTN\_act}$

The WAKE terminal can be configured for a pulse, see [Figure 8-46](#), by using WAKE\_CONFIG register 11h[7:6]. The terminal can be configured to work off a pulse only. The pulse must be between  $t_{WK\_WIDTH\_MIN}$  and  $t_{WK\_WIDTH\_MAX}$ , see [Figure 8-46](#). This figure provides three examples of pulses and whether the device will wake or not wake.  $t_{WK\_WIDTH\_MIN}$  is determined by the value for  $t_{WK\_WIDTH\_INVALID}$  is set to in register 8'h11[3:2]. There are two regions where a pulse may or may not be detected. By using register 8'h1B[1], WAKE\_WIDTH\_MAX\_DIS, the pulse mode can be configured as a filtered wake input. Writing a 1b to this bit disables  $t_{WK\_WIDTH\_MAX}$ , and the WAKE input is based upon the configuration of register 8'h11[3:2] which selects a  $t_{WK\_WIDTH\_INVALID}$  and  $t_{WK\_WIDTH\_MIN}$  value. A WAKE input of less than  $t_{WK\_WIDTH\_INVALID}$  is filtered out, and if longer than  $t_{WK\_WIDTH\_MIN}$  INH turns on and device enters standby mode. The region between the two may or may not be counted, see [Figure 8-47](#). Register 8'h12[7] determines the direction of the pulse or filter edge that is recognized. The status of the WAKE pin can be determined from register 8'h11[5:4]. When a WAKE pin change takes place, the device registers the change as a rising edge or falling edge. This is latched until a 00b is written to the bits.



**Figure 8-46. WAKE Pin Pulse Behavior**



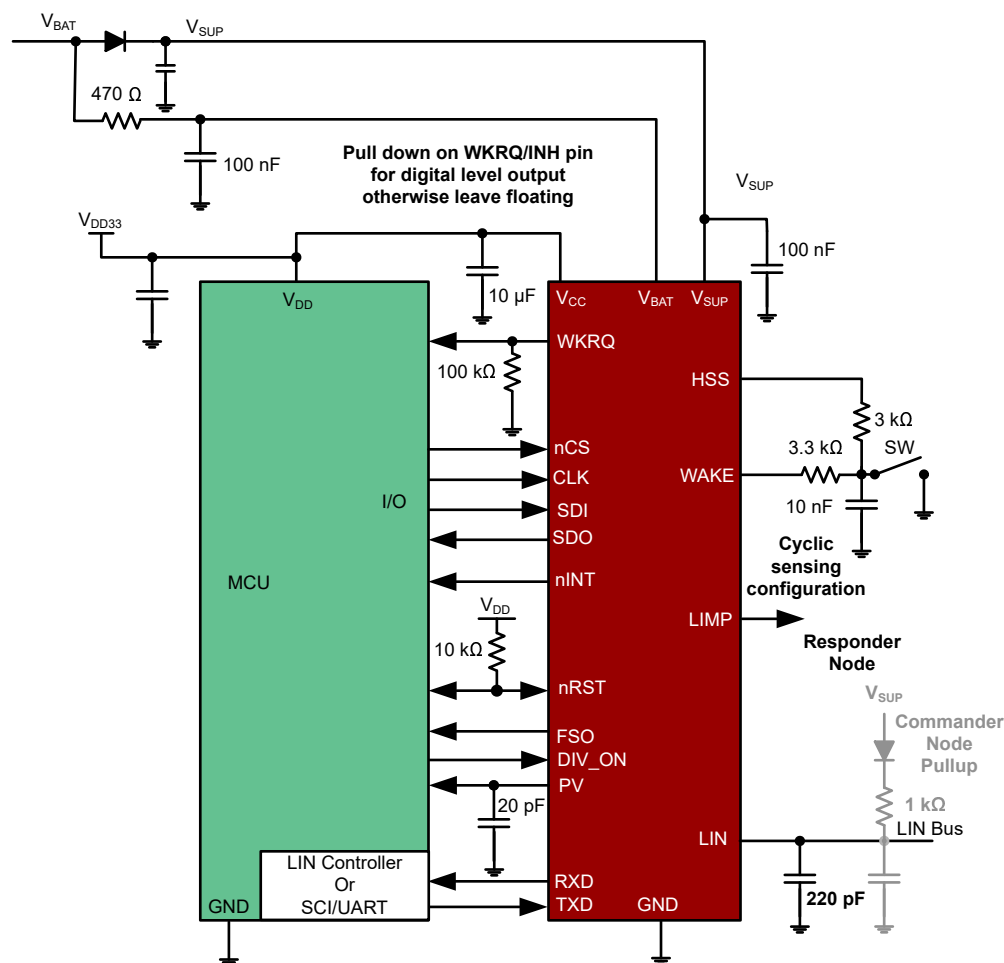
**Figure 8-47. WAKE Pin Filtered Behavior**

#### 8.4.8.2.2 Cyclic Sense Wake

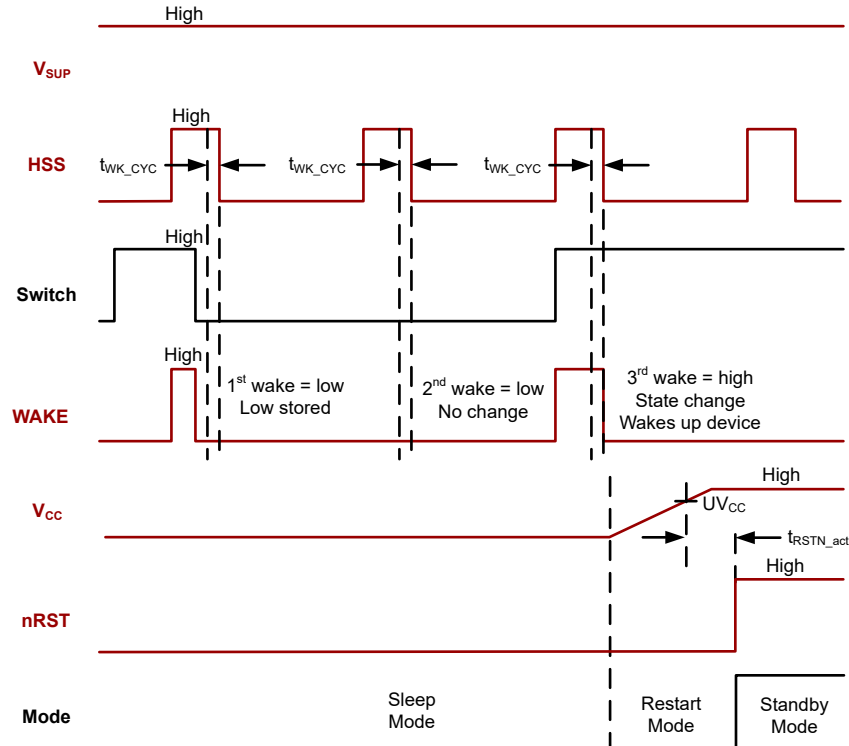
Cyclic sense wake is a method using the high-side switch with the WAKE input pin to periodically check for a WAKE pin state change in standby and sleep modes. In sleep mode, cyclic sense wake reduces the quiescent current of the device by reducing the WAKE circuitry to be active only during the on time of the HSS pin, see [Figure 8-48](#) as an example for this. Periodically, the HSS pin turns on applying  $V_{SUP}$  to the external local wake circuitry and the device samples the state of the WAKE pin. Each time the WAKE pin is sampled, the current

state is compared to the previous state. If there has been a state change, the device wakes up and transitions to restart mode; otherwise, it remains in sleep mode. See [Figure 8-49](#) for the timing diagram. In standby mode, the same process is followed for determining a state change on the WAKE pin. A state change on the WAKE pin causes the device to initiate an interrupt and the RXD pin is latched low. When entering standby or sleep mode, this process is reset with the first HSS on time being the initial WAKE pin state and does not cause a wake event.

The wake time is based upon  $t_{WK\_CYC}$ , which is the sampling window, as shown in [Static WAKE](#). This HSS period and on time are determined by setting timer1 register, 8'h25[7:0] or timer 2 register 8'h26[7:0]. The sampling window,  $t_{WK\_CYC}$ , is determined by register 8'h12[5].



**Figure 8-48. Application Cyclic Sense Configuration**



**Figure 8-49. Cyclic Sensing Timing**

**Note**

When the device enters fail-safe mode and turns off the HSS pin, the WAKE pin reverts to static mode, and must be reprogrammed for cyclic sensing when the device enters standby or normal mode.

### 8.4.9 Mode Transitions

When the device is transitioning between modes, the device needs the time  $t_{\text{MODE\_CHANGE}}$  and  $t_{\text{NOMINIT}}$  to allow the change to fully propagate from the EN pin through the device into the new state.

## 8.5 Programming

The TLIN1431x-Q1 is 7-bit address access SPI communication port.

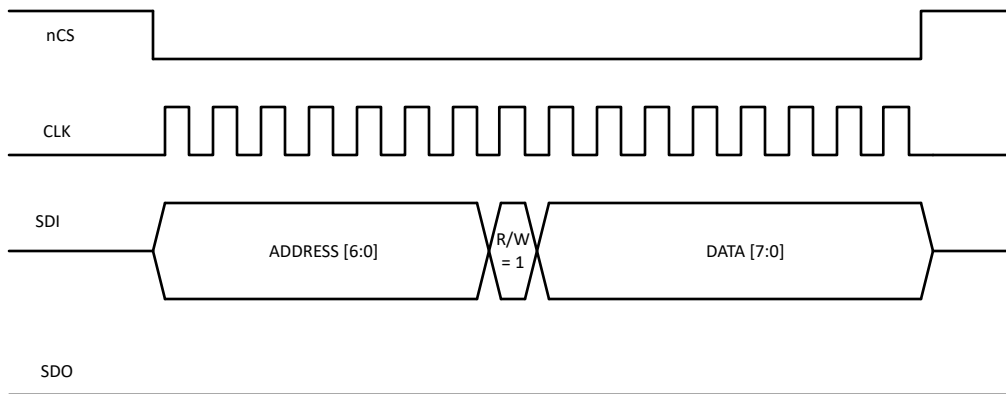
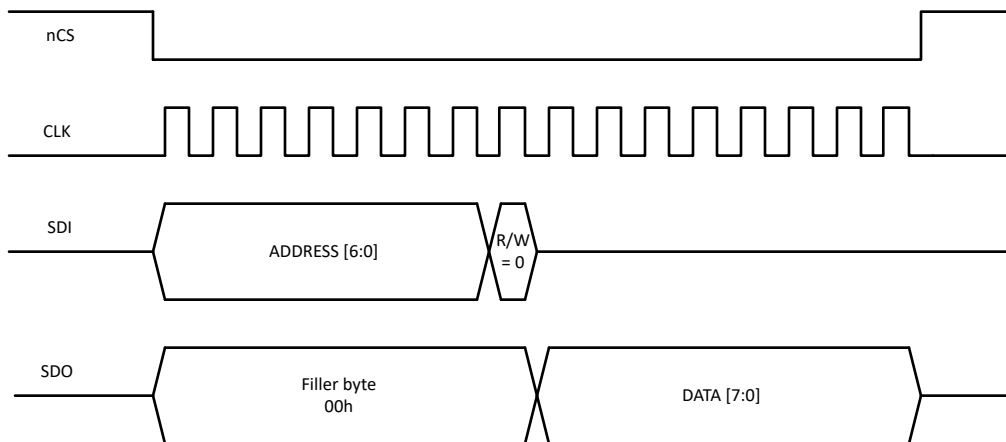
Table 8-9 shows a list of the registers in the device along with their respective addresses.

### 8.5.1 SPI Communication

The SPI communication uses a standard SPI interface. Physically the digital interface pins are nCS (Chip Select Not), SDI (SPI Data In), SDO (SPI Data Out) and CLK (SPI Clock). Each SPI transaction is initiated by a seven bit address with a R/W bit.

The SPI data input data on SDI is sampled on the low to high edge of CLK. The SPI output data on SDO is changed on the high to low edge of CLK.

See Figure 8-50 and Figure 8-51 for read and write method.

**Figure 8-50. SPI Write****Figure 8-51. SPI Read**

### 8.5.1.1 Cyclic Redundancy Check

The TLIN1431x supports cyclic redundancy check (CRC) for SPI transactions and is default disabled. Register 8'h0A[0] can be used to enable this feature. The default polynomial supports AutoSAR CRC8H2F,  $X^8 + X^5 + X^3 + X^2 + X + 1$ , see [Table 8-7](#). CRC8 according to SAE J1850 is also supported and can be selected at register 8'h0B[0].

When CRC is enabled, a filler byte of 00h is used to calculate the CRC value during a read/write operation, see [Figure 8-52](#) and [Figure 8-53](#).

**Table 8-7. CRC8H27**

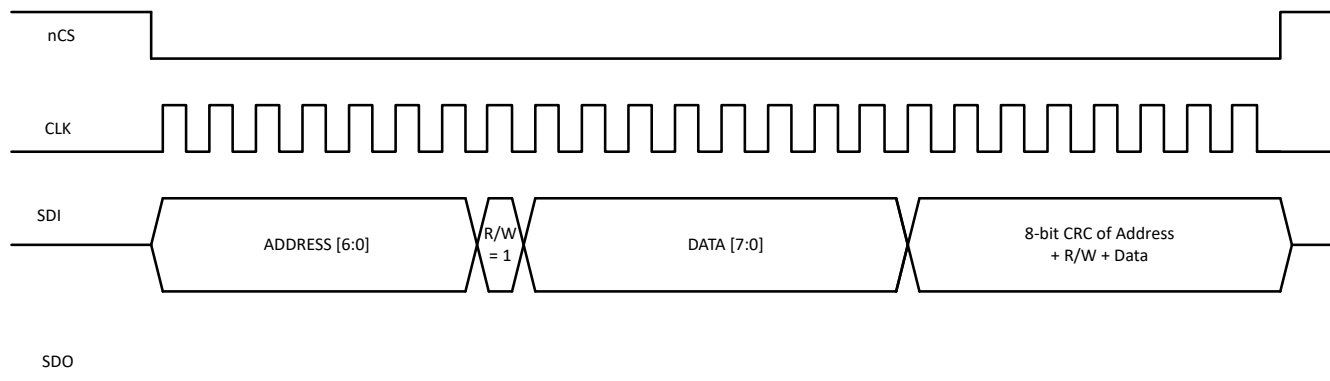
| SPI Transactions      |        |
|-----------------------|--------|
| CRC result width      | 8 bits |
| Polynomial            | 2Fh    |
| Initial value         | FFh    |
| Input data reflected  | No     |
| Result data reflected | No     |
| XOR value             | FFh    |
| Check                 | DFh    |
| Magic Check           | 42h    |

**Table 8-8. CRC8 SAE J1850**

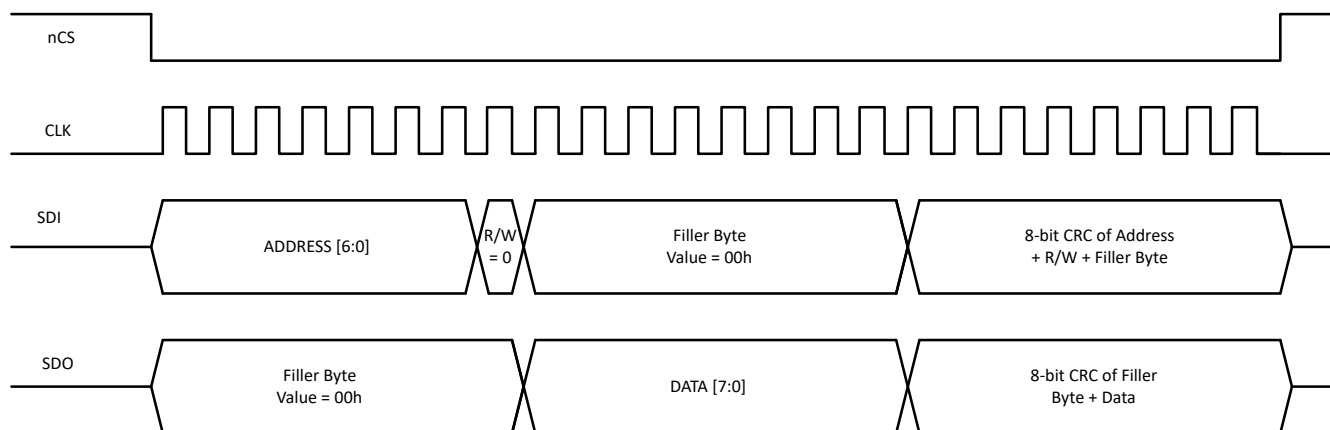
| SPI Transactions |        |
|------------------|--------|
| CRC result width | 8 bits |

**Table 8-8. CRC8 SAE J1850 (continued)**

| SPI Transactions      |     |
|-----------------------|-----|
| Polynomial            | 1Dh |
| Initial value         | FFh |
| Input data reflected  | No  |
| Result data reflected | No  |
| XOR value             | FFh |
| Check                 | 4Bh |
| Magic Check           | C4h |



**Figure 8-52. CRC SPI Write**



**Figure 8-53. CRC SPI Read**

### 8.5.1.2 Chip Select Not (**nCS**)

This input pin is used to select the device for a SPI transaction. The pin is active low, so while **nCS** is high the SPI Data Output (**SDO**) pin of the device is high impedance allowing an SPI bus to be designed. When **nCS** is low, the **SDO** driver is activated and communication may be started. The **nCS** pin is held low for a SPI transaction.

### 8.5.1.3 Serial Clock Input (**CLK**)

This input pin is used to input the clock for the SPI to synchronize the input and output serial data bit streams. The SPI Data Input is sampled on the rising edge of **CLK** and the SPI Data Output is changed on the falling edge of the **CLK**. See [Figure 8-54](#).

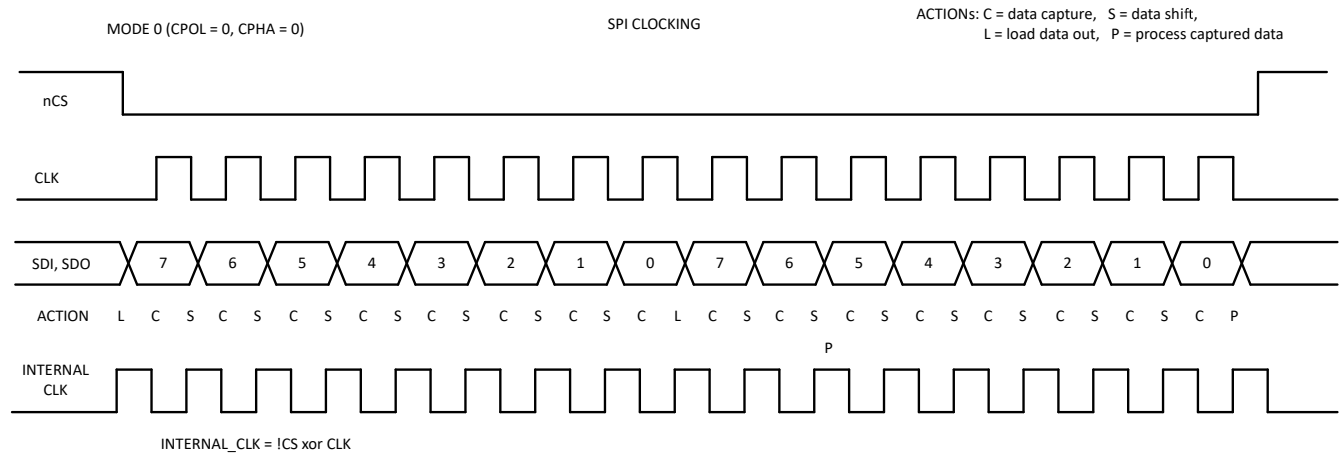


Figure 8-54. SPI Clocking

#### 8.5.1.4 Serial Data Input (SDI)

This input pin is used to shift data into the device. Once the SPI is enabled by a low on nCS, the SDI samples the input shifted data on each rising edge of the SPI clock (SCK). The data is shifted into an 8-bit shift register. After eight (8) clock cycles and shifts, the addressed register is read giving the data to be shifted out on SDO. After eight clock cycles, the shift register is full and the SPI transaction is complete. If the command code is a write, the new data is written into the addressed register. When nCS has a falling edge, there will be 16-bits (CRC disabled) or 24-bits (CRC enabled) shifted in by CLK, at which time the nCS has a rising edge to deselect the device. 16 Clock cycles are required to shift 16-bits (CRC disabled) and 24 clock cycles for 24-bits (CRC enabled) during one SPI transaction (nCS is low). If more or less clock cycles than these are used, the SPIERR flag will be set. If CRC was enabled the CRCERR flag will be set. When writing to the device, any transaction other than 16 or 24 clock cycles could result in behavior that is outside of the specification.

#### 8.5.1.5 Serial Data Output (SDO)

This pin is high impedance until the SPI output is enabled via nCS. Once the SPI is enabled by a low on nCS and a read command given, on the first falling edge of CLK, the shifting out of the data with each falling edge on CLK until all 8 bits have been shifted out the shift register.

## 8.6 Registers

The following tables contain the registers that the device use during SPI communication.

[Table 8-9](#) lists the memory-mapped registers for the Device registers. All register offset addresses not listed in [Table 8-9](#) should be considered as reserved locations and the register contents should not be modified.

**Table 8-9. Device Registers**

| Address      | Acronym          | Register Name                                      | Section            |
|--------------|------------------|----------------------------------------------------|--------------------|
| 0h + formula | DEVICE_ID_y      | Device Part Number                                 | <a href="#">Go</a> |
| 8h           | REV_ID_MAJOR     | Major Revision                                     | <a href="#">Go</a> |
| 9h           | REV_ID_MINOR     | Minor Revision                                     | <a href="#">Go</a> |
| Ah           | CRC_CNTL         | SPI CRC control                                    | <a href="#">Go</a> |
| Bh           | CRC_POLY_SET     | Sets SPI CRC polynomial                            | <a href="#">Go</a> |
| Fh           | Scratch_Pad_SPI  | Read and Write Test Register SPI                   | <a href="#">Go</a> |
| 11h          | WAKE_PIN_CONFIG1 | WAKE pin configuration 1                           | <a href="#">Go</a> |
| 12h          | WAKE_PIN_CONFIG2 | WAKE pin configuration 2                           | <a href="#">Go</a> |
| 13h          | WD_CONFIG_1      | Watchdog configuration 1                           | <a href="#">Go</a> |
| 14h          | WD_CONFIG_2      | Watchdog configuration 2                           | <a href="#">Go</a> |
| 15h          | WD_INPUT_TRIG    | Watchdog input trigger                             | <a href="#">Go</a> |
| 16h          | WD_RST_PULSE     | Watchdog output pulse width                        | <a href="#">Go</a> |
| 17h          | FSM_CONFIG       | Fail safe mode configuration                       | <a href="#">Go</a> |
| 18h          | FSM_CNTR         | Fail safe mode counter                             | <a href="#">Go</a> |
| 19h          | DEVICE_RST       | Device reset                                       | <a href="#">Go</a> |
| 1Ah          | DEVICE_CONFIG1   | Device configuration 1                             | <a href="#">Go</a> |
| 1Bh          | DEVICE_CONFIG2   | Device configuration 2                             | <a href="#">Go</a> |
| 1Ch          | SWE_TIMER        | Sleep wake error timer configuration               | <a href="#">Go</a> |
| 1Dh          | LIN_CNTL         | LIN transceiver control                            | <a href="#">Go</a> |
| 1Eh          | HSS_CNTL         | High side switch 1 and 2 control                   | <a href="#">Go</a> |
| 1Fh          | PWM1_CNTL1       | Pulse width modulation frequency select            | <a href="#">Go</a> |
| 20h          | PWM1_CNTL2       | Pulse width modulation duty cycle two MSB select   | <a href="#">Go</a> |
| 21h          | PWM1_CNTL3       | Pulse width modulation duty cycle eight LSB select | <a href="#">Go</a> |
| 22h          | PWM2_CNTL1       | Pulse width modulation frequency select            | <a href="#">Go</a> |
| 23h          | PWM2_CNTL2       | Pulse width modulation duty cycle two MSB select   | <a href="#">Go</a> |
| 24h          | PWM2_CNTL3       | Pulse width modulation duty cycle eight LSB select | <a href="#">Go</a> |
| 25h          | TIMER1_CONFIG    | High side switch timer 1 configuration             | <a href="#">Go</a> |
| 26h          | TIMER2_CONFIG    | High side switch timer 2 configuration             | <a href="#">Go</a> |
| 28h          | RSRT_CNTR        | Restart counter configuration                      | <a href="#">Go</a> |
| 29h          | nRST_CNTL        | nRST and FSO pin control                           | <a href="#">Go</a> |
| 50h          | INT_GLOBAL       | Global Interrupts                                  | <a href="#">Go</a> |
| 51h          | INT_1            | Interrupts                                         | <a href="#">Go</a> |
| 52h          | INT_2            | Interrupts                                         | <a href="#">Go</a> |
| 53h          | INT_3            | Interrupts                                         | <a href="#">Go</a> |
| 56h          | INT_EN_1         | Interrupt enable for INT_1                         | <a href="#">Go</a> |
| 57h          | INT_EN_2         | Interrupt enable for INT_2                         | <a href="#">Go</a> |
| 58h          | INT_EN_3         | Interrupt enable for INT_3                         | <a href="#">Go</a> |
| 5Ah          | INT_4            | Interrupts                                         | <a href="#">Go</a> |
| 5Eh          | INT_EN_4         | Interrupt enable for INT_4                         | <a href="#">Go</a> |

Complex bit access types are encoded to fit into small table cells. [Table 8-10](#) shows the codes that are used for access types in this section.

**Table 8-10. Device Access Type Codes**

| Access Type              | Code    | Description                                                                                                                                                                                                                                                                          |
|--------------------------|---------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Read Type                |         |                                                                                                                                                                                                                                                                                      |
| R                        | R       | Read                                                                                                                                                                                                                                                                                 |
| RH                       | H<br>R  | Set or cleared by hardware<br>Read                                                                                                                                                                                                                                                   |
| Write Type               |         |                                                                                                                                                                                                                                                                                      |
| H                        | H       | Set or cleared by hardware                                                                                                                                                                                                                                                           |
| W                        | W       | Write                                                                                                                                                                                                                                                                                |
| W1C                      | 1C<br>W | 1 to clear<br>Write                                                                                                                                                                                                                                                                  |
| Reset or Default Value   |         |                                                                                                                                                                                                                                                                                      |
| -n                       |         | Value after reset or the default value                                                                                                                                                                                                                                               |
| Register Array Variables |         |                                                                                                                                                                                                                                                                                      |
| i,j,k,l,m,n              |         | When these variables are used in a register name, an offset, or an address, they refer to the value of a register array where the register is part of a group of repeating registers. The register groups form a hierarchical structure and the array is represented with a formula. |
| y                        |         | When this variable is used in a register name, an offset, or an address it refers to the value of a register array.                                                                                                                                                                  |

### 8.6.1 DEVICE\_ID\_y Register (Address = 0h + formula) [reset = 0h]

DEVICE\_ID\_y is shown in [Figure 8-55](#) and described in [Table 8-11](#).

Return to [Summary Table](#).

Device Part Number

Offset = 0h + y; where y = 0h to 7h

**Figure 8-55. DEVICE\_ID\_y Register**

|           |   |   |   |   |   |   |   |
|-----------|---|---|---|---|---|---|---|
| 7         | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| DEVICE_ID |   |   |   |   |   |   |   |
| R-0b      |   |   |   |   |   |   |   |

**Table 8-11. DEVICE\_ID\_y Register Field Descriptions**

| Bit | Field     | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|-----|-----------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-0 | DEVICE_ID | R    | 0b    | The DEVICE_ID[1:8] registers determine the part number of the device.<br>The reset values and value of each DEVICE_ID register are listed for the corresponding register address<br>Address 00h = 54h = T<br>Address 01h = 4Ch = L<br>Address 02h = 49h = I<br>Address 03h = 31h = 1<br>Address 04h = 34h = 4<br>Address 05h = 33h = 3<br>Address 06h = 31h = 1<br>Address 07h = 33h = 3 for 3.3 V LDO<br>Address 07h = 35h = 5 for 5 V LDO |

### 8.6.2 REV\_ID\_MAJOR Register (Address = 8h) [reset = 01h]

REV\_ID\_MAJOR is shown in [Figure 8-56](#) and described in [Table 8-12](#).

Return to [Summary Table](#).

Major Revision

**Figure 8-56. REV\_ID\_MAJOR Register**

|                |   |   |   |   |   |   |   |
|----------------|---|---|---|---|---|---|---|
| 7              | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Major_Revision |   |   |   |   |   |   |   |
| R-01h          |   |   |   |   |   |   |   |

**Table 8-12. REV\_ID\_MAJOR Register Field Descriptions**

| Bit | Field          | Type | Reset | Description        |
|-----|----------------|------|-------|--------------------|
| 7-0 | Major_Revision | R    | 01h   | Major die revision |

### 8.6.3 REV\_ID\_MINOR Register (Address = 9h) [reset = 0h]

REV\_ID\_MINOR is shown in [Figure 8-57](#) and described in [Table 8-13](#).

Return to [Summary Table](#).

Minor Revision

**Figure 8-57. REV\_ID\_MINOR Register**

|                |   |   |   |   |   |   |   |
|----------------|---|---|---|---|---|---|---|
| 7              | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Minor_Revision |   |   |   |   |   |   |   |
| R-0b           |   |   |   |   |   |   |   |

**Table 8-13. REV\_ID\_MINOR Register Field Descriptions**

| Bit | Field          | Type | Reset | Description        |
|-----|----------------|------|-------|--------------------|
| 7-0 | Minor_Revision | R    | 0b    | Minor die revision |

### 8.6.4 CRC\_CNTL Register (Address = Ah) [reset = 0h]

CRC\_CNTL is shown in [Figure 8-58](#) and described in [Table 8-14](#).

Return to [Summary Table](#).

SPI CRC register controls the CRC function. CRC\_DIS bit can disable the CRC function.

**Figure 8-58. CRC\_CNTL Register**

|               |   |   |   |   |   |   |        |
|---------------|---|---|---|---|---|---|--------|
| 7             | 6 | 5 | 4 | 3 | 2 | 1 | 0      |
| CRC_CNTL_RSVD |   |   |   |   |   |   | CRC_EN |

**Figure 8-58. CRC\_CNTL Register (continued)**

|      |        |
|------|--------|
| R-0b | R/W-0b |
|------|--------|

**Table 8-14. CRC\_CNTL Register Field Descriptions**

| Bit | Field         | Type | Reset | Description                               |
|-----|---------------|------|-------|-------------------------------------------|
| 7-1 | CRC_CNTL_RSVD | R    | 0b    | CRC control reserved bits                 |
| 0   | CRC_EN        | R/W  | 0b    | CRC enable<br>0b = Disable<br>1b = Enable |

**8.6.5 CRC\_POLY\_SET (Address = Bh) [reset = 00h]**

CRC\_POLY\_SET is shown [Figure 8-59](#) and described in [Table 8-15](#).

Return to [Summary Table](#).

This register will set which polynomial will be set for CRC. Defaults to AutoSAR 8-bit 0x2F.

**Figure 8-59. CRC\_POLY\_SET Register**

|      |   |   |   |   |   |   |            |
|------|---|---|---|---|---|---|------------|
| 7    | 6 | 5 | 4 | 3 | 2 | 1 | 0          |
| RSVD |   |   |   |   |   |   | POLY_8_SET |
| R    |   |   |   |   |   |   | R/W-0b     |

**Table 8-15. CRC\_POLY\_SET Register Field Description**

| Bit | Field      | Type | Reset | Description                                                                                                               |
|-----|------------|------|-------|---------------------------------------------------------------------------------------------------------------------------|
| 7-1 | RSVD       | R    | 00h   | Reserved                                                                                                                  |
| 0   | POLY_8_SET | R/W  | 0b    | CRC polynomial select<br>0b = $X^8 + X^5 + X^3 + X^2 + X + 1$ (0x2F)<br>1b = $X^8 + X^4 + X^3 + X^2 + 1$ (0x1D SAE J1850) |

**8.6.6 Scratch\_Pad\_SPI Register (Address = Fh) [reset = 0h]**

Scratch\_Pad\_SPI is shown in [Figure 8-60](#) and described in [Table 8-16](#).

Return to [Summary Table](#).

Read and Write Test Register SPI

**Figure 8-60. Scratch\_Pad\_SPI Register**

|             |   |   |   |   |   |   |   |
|-------------|---|---|---|---|---|---|---|
| 7           | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Scratch_Pad |   |   |   |   |   |   |   |
| R/W-0b      |   |   |   |   |   |   |   |

**Table 8-16. Scratch\_Pad\_SPI Register Field Descriptions**

| Bit | Field       | Type | Reset | Description                      |
|-----|-------------|------|-------|----------------------------------|
| 7-0 | Scratch_Pad | R/W  | 0b    | Read and Write Test Register SPI |

**8.6.7 WAKE\_PIN\_CONFIG1 Register (Address = 11h) [reset = 04h]**

WAKE\_PIN\_CONFIG1 is shown in [Figure 8-61](#) and described in [Table 8-17](#).

Return to [Summary Table](#).

Register to configure the behavior of the WAKE pin.

**Figure 8-61. WAKE\_PIN\_CONFIG1 Register**

|             |   |             |   |                    |   |                |   |
|-------------|---|-------------|---|--------------------|---|----------------|---|
| 7           | 6 | 5           | 4 | 3                  | 2 | 1              | 0 |
| WAKE_CONFIG |   | WAKE_STAT   |   | WAKE_WIDTH_INVALID |   | WAKE_WIDTH_MAX |   |
| R/W-00b     |   | R/W0C/H-00b |   | R/W-01b            |   | R/W-00b        |   |

**Table 8-17. WAKE\_PIN\_CONFIG1 Register Field Descriptions**

| Bit | Field              | Type    | Reset | Description                                                                                                                                                                                                                                                                                     |
|-----|--------------------|---------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-6 | WAKE_CONFIG        | R/W     | 00b   | Wake pin configuration: Note: Pulse requires more programming<br>00b = Bi-directional - either edge<br>01b = Rising edge<br>10b = Falling edge<br>11b = Pulse                                                                                                                                   |
| 5-4 | WAKE_STAT          | R/W0C/H | 00b   | Wake pin status<br>00b = No change<br>01b = Rising edge<br>10b = Falling edge<br>11b = Pulse                                                                                                                                                                                                    |
| 3-2 | WAKE_WIDTH_INVALID | R/W     | 01b   | Pulses less than or equal to these pulses are considered invalid<br>00b = 5 ms and sets $t_{WAKE\_WIDTH\_MIN}$ to 10 ms<br>01b = 10 ms and sets $t_{WAKE\_WIDTH\_MIN}$ to 20 ms<br>10b = 20 ms and sets $t_{WAKE\_WIDTH\_MIN}$ to 40 ms<br>11b = 40 ms and sets $t_{WAKE\_WIDTH\_MIN}$ to 80 ms |
| 1-0 | WAKE_WIDTH_MAX     | R/W     | 00b   | Maximum WAKE pin input pulse width to be considered valid.<br>00b = 750 ms<br>01b = 1000 ms<br>10b = 1500 ms<br>11b = 2000 ms                                                                                                                                                                   |

### 8.6.8 WAKE\_PIN\_CONFIG2 Register (Address = 12h) [reset = 2h]

WAKE\_PIN\_CONFIG2 is shown in [Figure 8-62](#) and described in [Table 8-18](#).

Return to [Summary Table](#).

Device wake configuration register

**Figure 8-62. WAKE\_PIN\_CONFIG2 Register**

| 7                 | 6          | 5               | 4        | 3 | 2                 | 1          | 0 |
|-------------------|------------|-----------------|----------|---|-------------------|------------|---|
| WAKE_PULSE_CONFIG | WAKE_SENSE | TWK_CYC_SE<br>T | nINT_SEL |   | RXD_WK_CON<br>FIG | WAKE_LEVEL |   |
| R/W-0b            | R/W/H-0b   | R/W-0b          | R/W-0b   |   | R/W-0b            | R/W-10b    |   |

**Table 8-18. WAKE\_PIN\_CONFIG2 Register Field Descriptions**

| Bit | Field             | Type  | Reset | Description                                                                                                                                                                                                                                                                                                                                 |
|-----|-------------------|-------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | WAKE_PULSE_CONFIG | R/W   | 0b    | Set WAKE pin expected pulse direction<br>0b = Low → High → Low<br>1b = High → Low → High                                                                                                                                                                                                                                                    |
| 6   | WAKE_SENSE        | R/W/H | 0b    | WAKE pin configured for static or cyclic sensing wake<br>0b = Static<br>1b = Cyclic<br><br><div style="text-align: center;"><b>Note</b></div> <div>When Cyclic sensing is selected and the device goes to fail-safe mode it will automatically change to static sensing. If cyclic sensing is needed it will have to be reprogrammed.</div> |

**Table 8-18. WAKE\_PIN\_CONFIG2 Register Field Descriptions (continued)**

| Bit | Field         | Type | Reset | Description                                                                                                                                                                                                                                                                                   |
|-----|---------------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 5   | TWK_CYC_SET   | R/W  | 0b    | Sets the $t_{WK\_CYC}$ time ( $\mu s$ ) for sampling the WAKE pin status (used for cyclic sensing)<br>0b = 30<br>1b = 75<br><br><b>Note</b><br>NOTE: $t_{WK\_CYC\_SET}$ works with timer1 and timer2. When using 75 $\mu s$ $t_{WK\_CYC}$ , 100 $\mu s$ $TIMER1/2\_ON\_WIDTH$ cannot be used. |
| 4-3 | nINT_SEL      | R/W  | 00b   | nINT configuration selection: active low<br>00b = Global interrupt<br>01b = Watchdog failure output<br>10b = Reserved<br>11b = Wake request                                                                                                                                                   |
| 2   | RXD_WK_CONFIG | R/W  | 0b    | Configures RXD pin behavior from a wake event<br>0b = Pulled low<br>1b = Toggle                                                                                                                                                                                                               |
| 1-0 | WAKE_LEVEL    | R/W  | 10b   | WAKE pin threshold level; Mid-point value in 2 V window.<br>00b = 2.5 V<br>01b = 2.8 V<br>10b = 3 V<br>11b = 3.3 V                                                                                                                                                                            |

**8.6.9 WD\_CONFIG\_1 Register (Address = 13h) [reset = 90h]**

WD\_CONFIG\_1 is shown in [Figure 8-63](#) and described in [Table 8-19](#).

Return to [Summary Table](#).

Watchdog configuration register.

**Figure 8-63. WD\_CONFIG\_1 Register**

|           |   |         |   |         |   |   |   |
|-----------|---|---------|---|---------|---|---|---|
| 7         | 6 | 5       | 4 | 3       | 2 | 1 | 0 |
| WD_CONFIG |   | WD_PRE  |   | RSVD    |   |   |   |
| R/W-10b   |   | R/W-01b |   | R-0000b |   |   |   |

**Table 8-19. WD\_CONFIG\_1 Register Field Descriptions**

| Bit | Field     | Type | Reset | Description                                                                                 |
|-----|-----------|------|-------|---------------------------------------------------------------------------------------------|
| 7-6 | WD_CONFIG | R/W  | 10b   | Watchdog configuration<br>00b = Disabled<br>01b = Timeout<br>10b = Window<br>11b = Reserved |
| 5-4 | WD_PRE    | R/W  | 01b   | Watchdog prescaler<br>00b = Factor 1<br>01b = Factor 2<br>10b = Factor 3<br>11b = Factor 4  |
| 3-0 | RSVD      | R    | 0000b | Reserved                                                                                    |

**8.6.10 WD\_CONFIG\_2 Register (Address = 14h) [reset = 02h]**

WD\_CONFIG\_2 is shown in [Figure 8-64](#) and described in [Table 8-20](#).

Return to [Summary Table](#).

Watchdog timer and error counter register.

**Figure 8-64. WD\_CONFIG\_2 Register**

| 7        | 6 | 5 | 4          | 3 | 2 | 1           | 0 |
|----------|---|---|------------|---|---|-------------|---|
| WD_TIMER |   |   | WD_ERR_CNT |   |   | WD_STBY_DIS |   |
| R/W-000b |   |   | RH-0001b   |   |   | R/W-0b      |   |

**Table 8-20. WD\_CONFIG\_2 Register Field Descriptions**

| Bit | Field       | Type | Reset | Description                                                                      |
|-----|-------------|------|-------|----------------------------------------------------------------------------------|
| 7-5 | WD_TIMER    | R/W  | 000b  | Sets window or timeout times based upon the WD_PRE setting<br>See WD_TIMER table |
| 4-1 | WD_ERR_CNT  | RH   | 0001b | Watchdog error counter<br>Running count of errors up to 15 errors                |
| 0   | WD_STBY_DIS | R/W  | 0b    | Watchdog disable in standby mode<br>0b = Enabled<br>1b = Disabled                |

#### 8.6.11 WD\_INPUT\_TRIG Register (Address = 15h) [reset = 0h]

WD\_INPUT\_TRIG is shown in [Figure 8-65](#) and described in [Table 8-21](#).

Return to [Summary Table](#).

Writing FFh resets WD timer if accomplished at appropriate time.

**Figure 8-65. WD\_INPUT\_TRIG Register**

| 7         | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-----------|---|---|---|---|---|---|---|
| WD_INPUT  |   |   |   |   |   |   |   |
| R/W1C-00h |   |   |   |   |   |   |   |

**Table 8-21. WD\_INPUT\_TRIG Register Field Descriptions**

| Bit | Field    | Type  | Reset | Description             |
|-----|----------|-------|-------|-------------------------|
| 7-0 | WD_INPUT | R/W1C | 00h   | Write FFh to trigger WD |

#### 8.6.12 WD\_RST\_PULSE Register (Address = 16h) [reset = 40h]

WD\_RST\_PULSE is shown in [Figure 8-66](#) and described in [Table 8-22](#).

Return to [Summary Table](#).

Sets the watchdog error counter value.

**Figure 8-66. WD\_RST\_PULSE Register**

| 7              | 6 | 5         | 4 | 3 | 2 | 1 | 0 |
|----------------|---|-----------|---|---|---|---|---|
| WD_ERR_CNT_SET |   | RSVD      |   |   |   |   |   |
| R/W-01b        |   | R-000000b |   |   |   |   |   |

**Table 8-22. WD\_RST\_PULSE Register Field Descriptions**

| Bit | Field          | Type | Reset   | Description                                                                                                                                                                                                                                                                      |
|-----|----------------|------|---------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-6 | WD_ERR_CNT_SET | R/W  | 01b     | Sets the watchdog event error counter that upon reaching the count value, will cause the watchdog action.<br>00b = Immediate trigger on each WD fail<br>01b = Triggers when counter reaches 5<br>10b = Triggers when counter reaches 9<br>11b = Triggers when counter reaches 15 |
| 5-0 | RSVD           | R    | 000000b | Reserved                                                                                                                                                                                                                                                                         |

#### 8.6.13 FSM\_CONFIG Register (Address = 17h) [reset = 0h]

FSM\_CONFIG is shown in [Figure 8-67](#) and described in [Table 8-23](#).

Return to [Summary Table](#).

Configures the fail-safe mode

**Figure 8-67. FSM\_CONFIG Register**

| 7           | 6 | 5 | 4 | 3       | 2 | 1 | 0       |
|-------------|---|---|---|---------|---|---|---------|
| FS_CNTR_ACT |   |   |   | FS_STAT |   |   | FSM_DIS |
| R/W-0000b   |   |   |   | RH-000b |   |   | R/W-0b  |

**Table 8-23. FSM\_CONFIG Register Field Descriptions**

| Bit | Field        | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
|-----|--------------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-4 | FSM_CNTR_ACT | R/W  | 0000b | <p>Action if fail safe counter exceeds programmed value</p> <p>000b = Disabled</p> <p>0001b = Pull WKRQ/INH low for 1 s</p> <p>0010b = Perform soft reset</p> <p>0011b = Perform hard reset - POR</p> <p>0100b = Stop responding to wake events and go to sleep until power cycle reset</p> <p>0101b = Reserved</p> <p>0110b = Reserved</p> <p>0111b = Reserved</p> <p>1001b = Turn off VCC for 300 ms and set interrupt</p> <hr/> <p style="text-align: center;"><b>Note</b></p> <ul style="list-style-type: none"> <li>If LIMP is configured as INH then 0001b will impact cause the LIMP pin to go low for 1 s.</li> <li>All other values reserved</li> </ul> <hr/> |
| 3-1 | FSM_STAT     | RH   | 000b  | <p>Reason for entering failsafe mode</p> <p>000b = Not in FS mode</p> <p>001b = Thermal shut down event</p> <p>010b = Reserved</p> <p>011b = UV<sub>CC</sub></p> <p>100b = OV<sub>CC</sub></p> <p>101b = V<sub>CCSC</sub></p> <p>110b = Watchdog failure</p> <p>111b = Restart counter exceeded</p> <p>These values are held until cleared by writing 0h to FSM_CNTR_STAT</p>                                                                                                                                                                                                                                                                                          |
| 0   | FSM_DIS      | R/W  | 0b    | <p>Fail safe mode disable: Excludes power up fail safe</p> <p>0b = Enabled</p> <p>1b = Disabled</p>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |

#### 8.6.14 FSM\_CNTR Register (Address = 18h) [reset = 0h]

FSM\_CNTR is shown in [Figure 8-68](#) and described in [Table 8-24](#).

Return to [Summary Table](#).

Set fail safe counter and status

**Figure 8-68. FSM\_CNTR Register**

| 7            | 6 | 5 | 4 | 3             | 2 | 1 | 0 |
|--------------|---|---|---|---------------|---|---|---|
| FSM_CNTR_SET |   |   |   | FSM_CNTR_STAT |   |   |   |
| R/W-0h       |   |   |   | RH-0h         |   |   |   |

**Table 8-24. FSM\_CNTR Register Field Descriptions**

| Bit | Field        | Type | Reset | Description                                                                                                                                                                                        |
|-----|--------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-4 | FSM_CNTR_SET | R/W  | 0h    | <p>Sets the number of times FS mode enters before action taken. Value is one less than the number of times FS mode is entered. Range is 0-15, representing entering fail-safe mode 1-16 times.</p> |

**Table 8-24. FSM\_CNTR Register Field Descriptions (continued)**

| Bit | Field         | Type | Reset | Description                                                                                         |
|-----|---------------|------|-------|-----------------------------------------------------------------------------------------------------|
| 3-0 | FSM_CNTR_STAT | RH   | 0h    | Reads back the number of time FSM has been entered in a row up to 15. Can be cleared by writing 0h. |

#### 8.6.15 DEVICE\_RST Register (Address = 19h) [reset = 0h]

DEVICE\_RST is shown in [Figure 8-69](#) and described in [Table 8-25](#).

Return to [Summary Table](#).

Forces a soft or hard reset.

**Figure 8-69. DEVICE\_RST Register**

|          |   |   |   |   |   |          |          |
|----------|---|---|---|---|---|----------|----------|
| 7        | 6 | 5 | 4 | 3 | 2 | 1        | 0        |
| RESERVED |   |   |   |   |   | SF_RST   | HD_RST   |
| R-00h    |   |   |   |   |   | R/W1C-0b | R/W1C-0b |

**Table 8-25. DEVICE\_RST Register Field Descriptions**

| Bit | Field    | Type  | Reset | Description                                                                                                               |
|-----|----------|-------|-------|---------------------------------------------------------------------------------------------------------------------------|
| 7-2 | RESERVED | R     | 00h   | Reserved                                                                                                                  |
| 1   | SF_RST   | R/W1C | 0b    | Soft Reset: Writing a 1 causes a soft reset. Device registers return to default values while keeping INH on.              |
| 0   | HD_RST   | R/W1C | 0b    | Hard Reset: Forces a power on reset when writing a 1.<br><br><b>Note</b><br>NOTE: This will set the PWRON interrupt flag. |

#### 8.6.16 DEVICE\_CONFIG (Address = 1Ah) [reset = 80h]

DEVICE\_CONFIG is shown in [Figure 8-70](#) and described in [Table 8-26](#)

Return to [Summary Table](#).

Enables SPI to work in sleep mode if V<sub>IO</sub> is available.

WKRQ/INH and LIMP pin configuration.

**Figure 8-70. DEVICE\_CONFIG Register**

|              |              |              |          |                |   |            |        |
|--------------|--------------|--------------|----------|----------------|---|------------|--------|
| 7            | 6            | 5            | 4        | 3              | 2 | 1          | 0      |
| WKRQ_POL_SEL | WKRQ_INH_DIS | INH_LIMP_SEL | LIMP_DIS | LIMP_SEL_RESET |   | LIMP_RESET | RSVD   |
| R/W-1b       | R/W-0b       | R/W - 0b     | R/W - 0b | R/W - 00b      |   | R/W1C - 0b | R - 0b |

**Table 8-26. DEVICE\_CONFIG Register Field Descriptions**

| Bit | Field        | Type | Reset | Description                                                                                                                                                                                      |
|-----|--------------|------|-------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | WKRQ_POL_SEL | R/W  | 1b    | Selects the polarity for the WKRQ pin<br>0b = Low<br>1b = High                                                                                                                                   |
| 6   | WKRQ_INH_DIS | R/W  | 0b    | WKRQ/INH pin disable<br>0b = Enabled<br>1b = Disabled                                                                                                                                            |
| 5   | INH_LIMP_SEL | R/W  | 0b    | Pin function select function of INH pin<br>0b = INH<br>1b = LIMP<br>Note: This only works if WKRQ/INH pin is configured for INH at power-up. If pin is WKRQ writing to this bit will be ignored. |

**Table 8-26. DEVICE\_CONFIG Register Field Descriptions (continued)**

| Bit | Field          | Type  | Reset | Description                                                                                                                                                                                                      |
|-----|----------------|-------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 4   | LIMP_DIS       | R/W   | 0b    | LIMP pin disable<br>0b = Enabled<br>1b = Disabled                                                                                                                                                                |
| 3-2 | LIMP_SEL_RESET | R/W   | 0b    | Selects the method to reset/turnoff the LIMP pin<br>00b = On third successful input trigger the error counter receives<br>01b = First correct input trigger<br>10b = SPI write to 8'h1A[1] = 1<br>11b = Reserved |
| 1   | LIMP_RESET     | R/W1C | 0b    | LIMP reset<br>Writing a one to this location resets the LIMP pin to off state and bit automatically clears                                                                                                       |
| 0   | RSVD           | R     | 0b    | Reserved                                                                                                                                                                                                         |

**8.6.17 DEVICE\_CONFIG2 (Address = 1Bh) [reset = 0h]**

DEVICE\_CONFIG2 is shown in [Figure 8-71](#) and described in [Table 8-27](#)

Return to [Summary Table](#).

LIMP pin configuration and control.

**Figure 8-71. DEVICE\_CONFIG2 Register**

| 7            | 6 | 5             | 4 | 3 | 2           | 1                  | 0    |
|--------------|---|---------------|---|---|-------------|--------------------|------|
| LIMP_HSS_SEL |   | LIMP_HSS_CNTL |   |   | LIMP_HSS_ON | WAKE_WIDTH_MAX_DIS | RSVD |
| R/W-00b      |   | R/W-000b      |   |   | R/W-0b      | R/W-0b             | R-0b |

**Table 8-27. DEVICE\_CONFIG2 Register Field Descriptions**

| Bit | Field              | Type | Reset | Description                                                                                                                                                                                     |
|-----|--------------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-6 | LIMP_HSS_SEL       | R/W  | 00b   | Selects LIMP pin function<br>00b = LIMP<br>01b = High side switch<br>10b = INH<br>11b = Reserved                                                                                                |
| 5-3 | LIMP_HSS_CNTL      | R/W  | 000b  | Selects the method of control for the LIMP pin when configured as a high side switch<br>000b = On/Off<br>001b = PWM1<br>010b = PWM2<br>011b = Timer1<br>100b = Timer2<br>101b - 111b = Reserved |
| 2   | LIMP_HSS_ON        | R/W  | 0b    | When LIMP is configured as HSS and control is On/Off this bit turns on or off the LIMP pin.<br>0b = Off<br>1b = On                                                                              |
| 1   | WAKE_WIDTH_MAX_DIS | R/W  | 0b    | Disables the Max limit, $t_{WK\_PULSE\_WIDTH\_MAX}$ detection when pulse is selected for WAKE pin wake up.<br>0b = Enabled<br>1b = Disabled                                                     |
| 0   | RSVD               | R    | 0b    | Reserved                                                                                                                                                                                        |

**8.6.18 SWE\_TIMER (Address = 1Ch) [reset = 30h]**

SWE\_TIMER is shown in [Figure 8-72](#) and described in [Table 8-28](#)

Return to [Summary Table](#).

Sleep wake error timer configuration. Power up always sets to default value.

**Figure 8-72. SWE\_TIMER Register**

| 7       | 6             | 5 | 4 | 3 | 2    | 1 | 0 |
|---------|---------------|---|---|---|------|---|---|
| SWE_DIS | SWE_TIMER_SET |   |   |   | RSVD |   |   |
| R/W-0b  | R/W-0110b     |   |   |   | R    |   |   |

**Table 8-28. SWE\_TIMER Register Field Descriptions**

| Bit | Field         | Type | Reset | Description                                                                                                                                                                                                                                                                   |
|-----|---------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | SWE_DIS       | R/W  | 0b    | Sleep wake error disable: NOTE: This disables the device from starting the $t_{INACT\_FS}$ timer. If enabled, a SPI read or write must take place within this window or the device will go back to sleep.<br>0b = Enabled<br>1b = Disabled                                    |
| 6-3 | SWE_TIMER_SET | R/W  | 0110b | Sets the timer used for $t_{INACT\_FS}$ (minutes)<br>0000b = 2<br>0001b = 2.5<br>0010b = 3<br>0011b = 3.5<br>0100b = 4<br>0101b = 4.5<br>0110b = 5 (default)<br>0111b = 5.5<br>1000b = 6<br>1001b = 6.5<br>1010b = 8<br>1011b = 8.5<br>1100b = 10<br>1101b = 0.5<br>1111b = 1 |
| 2-0 | RSVD          | R    | 0b    | Reserved                                                                                                                                                                                                                                                                      |

#### 8.6.19 LIN\_CNTL (Address = 1Dh) [reset = 00h]

LIN\_CNTL is shown in [Figure 8-73](#) and described in [Table 8-29](#)

Return to [Summary Table](#).

LIN transceiver mode and DTO control. Port 1 is the TLIN1431x-Q1 LIN control.

**Figure 8-73. LIN\_CNTL Register**

| 7         | 6 | 5           | 4          | 3 | 2 | 1 | 0 |
|-----------|---|-------------|------------|---|---|---|---|
| LIN_MODE  |   | LIN.DTO_DIS | LIN_RSVD   |   |   |   |   |
| R/W/H-00b |   | R/W - 0b    | R - 00000b |   |   |   |   |

**Table 8-29. LIN\_CNTL Register Field Descriptions**

| Bit | Field       | Type  | Reset  | Description                                                                                               |
|-----|-------------|-------|--------|-----------------------------------------------------------------------------------------------------------|
| 7-6 | LIN_MODE    | R/W/H | 00b    | Port 1 LIN mode control<br>00b = Standby mode<br>01b = Sleep Mode<br>10b = Normal Mode<br>11b = Fast Mode |
| 5   | LIN.DTO_DIS | R/W   | 0b     | Port 1 LIN dominant state timeout disable<br>0b = Enabled<br>1b = Disabled                                |
| 4-0 | LIN_RSVD    | R     | 00000b | Reserved                                                                                                  |

### 8.6.20 HSS\_CNTL (Address = 1Eh) [reset = 0h]

HSS\_CNTL is shown in [Figure 8-74](#) and described in [Table 8-30](#)

Return to [Summary Table](#).

HSS high side switch control.

**Figure 8-74. HSS\_CNTL Register**

| 7      | 6        | 5 | 4 | 3        | 2 | 1 | 0 |
|--------|----------|---|---|----------|---|---|---|
| HSS_EN | HSS_CNTL |   |   | HSS_RSVD |   |   |   |
| R/W-0b | R/W-000b |   |   | R-0000b  |   |   |   |

**Table 8-30. HSS\_CNTL Register Field Descriptions**

| Bit | Field    | Type | Reset | Description                                                                                                                                                                                              |
|-----|----------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | HSS_EN   | R/W  | 0b    | High side switch, HSS, enable<br>0b = Disabled<br>1b = Enabled                                                                                                                                           |
| 6-4 | HSS_CNTL | R/W  | 000b  | Control for HSS<br>000b = On/Off<br>001b = PWM1<br>010b = PWM2<br>011b = Timer1<br>100b = Timer2<br>101b = HSSC<br>110b - 111b = Reserved<br>Note: selecting HSSC control disables FSO output capability |
| 3-0 | HSS_RSVD | R/W  | 0000b | Reserved                                                                                                                                                                                                 |

### 8.6.21 PWM1\_CNTL1 (Address = 1Fh) [reset = 0h]

PWM1\_CNTL1 is shown in [Figure 8-75](#) and described in [Table 8-31](#)

Return to [Summary Table](#).

Sets the pulse width modulation frequency, PWM1.

**Figure 8-75. PWM1\_CNTL1 Register**

| 7         | 6              | 5 | 4 | 3 | 2 | 1 | 0 |
|-----------|----------------|---|---|---|---|---|---|
| PWM1_FREQ | PWM1_FREQ_RSVD |   |   |   |   |   |   |
| R/W-0b    | R-0b           |   |   |   |   |   |   |

**Table 8-31. PWM1\_CNTL1 Register Field Descriptions**

| Bit | Field          | Type | Reset | Description                                       |
|-----|----------------|------|-------|---------------------------------------------------|
| 7   | PWM1_FREQ      | R/W  | 0b    | PWM frequency select (Hz)<br>0b = 200<br>1b = 400 |
| 6-0 | PWM1_FREQ_RSVD | R    | 0b    | Reserved                                          |

### 8.6.22 PWM1\_CNTL2 (Address = 20h) [reset = 0h]

PWM1\_CNTL2 is shown in [Figure 8-76](#) and described in [Table 8-32](#)

Return to [Summary Table](#).

Set the two most significant bit for the 10-bit PWM1. These work with register h'21 PWM1\_CNTL3.

**Figure 8-76. PWM1\_CNTL2 Register**

| 7         | 6 | 5 | 4 | 3 | 2 | 1           | 0 |
|-----------|---|---|---|---|---|-------------|---|
| PWM1_RSVD |   |   |   |   |   | PWM1_DC_MSB |   |

**Figure 8-76. PWM1\_CNTL2 Register (continued)**

|      |         |
|------|---------|
| R-0b | R/W-00b |
|------|---------|

**Table 8-32. PWM1\_CNTL2L Register Field Descriptions**

| Bit | Field       | Type | Reset | Description                                                                                                                                                                                                                                                             |
|-----|-------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-2 | PWM1_RSVD   | R    | 0b    | Reserved                                                                                                                                                                                                                                                                |
| 1-0 | PWM1_DC_MSB | R/W  | 00b   | Most significant two bits for 10-bit PWM1 duty cycle select. Works with 'h21[7:0]<br>00b = 100% off when used with 'h21[7:0] and it is 00h<br>xxb = on time with an increase of ~ 0.1% when used with 'h21[7:0]<br>11b = 100% of when used with 'h21[7:0] and it is FFh |

**Note**

Minimum on-time during PWM is limited to the on and off-time of the high side switch. This will make certain PWM values unusable like 00 0000 0001.

### 8.6.23 PWM1\_CNTL3 (Address = 21h) [reset = 00h]

PWM1\_CNTL3 is shown in [Figure 8-77](#) and described in [Table 8-33](#)

Return to [Summary Table](#).

Bits 0 - 7 of the 10-bit PWM1. Used with register h'20[1:0] PWM1\_CNTL2.

**Figure 8-77. PWM1\_CNTL3 Register**

|         |   |   |   |   |   |   |   |
|---------|---|---|---|---|---|---|---|
| 7       | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| PWM1_DC |   |   |   |   |   |   |   |
| R/W-00h |   |   |   |   |   |   |   |

**Table 8-33. PWM1\_CNTL3 Register Field Descriptions**

| Bit | Field   | Type | Reset | Description                                                                                                                                                                                         |
|-----|---------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | PWM1_DC | R/W  | 00h   | Bits 0 - 7 of the 10-bit PWM1<br>00h = 100% off when used with 'h20[1:0] = 00b<br>xxh = On time with an increase of ~ 0.1% when used with 'h20[1:0]<br>FFh = 100% on when used with 'h20[1:0] = 11b |

### 8.6.24 PWM2\_CNTL1 (Address = 22h) [reset = 0h]

PWM2\_CNTL1 is shown in [Figure 8-78](#) and described in [Table 8-34](#)

Return to [Summary Table](#).

Sets the pulse width modulation frequency, PWM2.

**Figure 8-78. PWM2\_CNTL1 Register**

|           |                |   |   |   |   |   |   |
|-----------|----------------|---|---|---|---|---|---|
| 7         | 6              | 5 | 4 | 3 | 2 | 1 | 0 |
| PWM2_FREQ | PWM2_FREQ_RSVD |   |   |   |   |   |   |
| R/W-0b    | R-0b           |   |   |   |   |   |   |

**Table 8-34. PWM2\_CNTL1 Register Field Descriptions**

| Bit | Field          | Type | Reset | Description                                       |
|-----|----------------|------|-------|---------------------------------------------------|
| 7   | PWM2_FREQ      | R/W  | 0b    | PWM frequency select (Hz)<br>0b = 200<br>1b = 400 |
| 6-0 | PWM2_FREQ_RSVD | R    | 0b    | Reserved                                          |

### 8.6.25 PWM2\_CNTL2 (Address = 23h) [reset = 0h]

PWM2\_CNTL2 is shown in [Figure 8-79](#) and described in [Table 8-35](#)

Return to [Summary Table](#).

Set the two most significant bit for the 10-bit PWM2. These work with register h'24 PWM2\_CNTL3.

**Figure 8-79. PWM2\_CNTL2 Register**

|           |   |   |   |   |   |             |   |
|-----------|---|---|---|---|---|-------------|---|
| 7         | 6 | 5 | 4 | 3 | 2 | 1           | 0 |
| PWM2_RSVD |   |   |   |   |   | PWM2_DC_MSB |   |
| R-0b      |   |   |   |   |   | R/W-00b     |   |

**Table 8-35. PWM2\_CNTL2 Register Field Descriptions**

| Bit | Field       | Type | Reset | Description                                                                                                                                                                                                                                                             |
|-----|-------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-2 | PWM2_RSVD   | R    | 0b    | Reserved                                                                                                                                                                                                                                                                |
| 1-0 | PWM2_DC_MSB | R/W  | 00b   | Most significant two bits for 10-bit PWM2 duty cycle select. Works with 'h24[7:0]<br>00b = 100% off when used with 'h24[7:0] and it is 00h<br>xxb = on time with an increase of ~ 0.1% when used with 'h24[7:0]<br>11b = 100% of when used with 'h24[7:0] and it is FFh |

### 8.6.26 PWM2\_CNTL3 (Address = 24h) [reset = 0h]

PWM2\_CNTL3 is shown in [Figure 8-80](#) and described in [Table 8-36](#)

Return to [Summary Table](#).

Bits 0 - 7 of the 10-bit PWM2. Used with register h'23[1:0] PWM2\_CNTL2.

**Figure 8-80. PWM2\_CNTL3 Register**

|         |   |   |   |   |   |   |   |
|---------|---|---|---|---|---|---|---|
| 7       | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| PWM2_DC |   |   |   |   |   |   |   |
| R/W-00h |   |   |   |   |   |   |   |

**Table 8-36. PWM2\_CNTL3 Register Field Descriptions**

| Bit | Field   | Type | Reset | Description                                                                                                                                                                                         |
|-----|---------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-0 | PWM2_DC | R/W  | 00h   | Bits 0 - 7 of the 10-bit PWM2<br>00h = 100% off when used with 'h23[1:0] = 00b<br>xxh = On time with an increase of ~ 0.1% when used with 'h23[1:0]<br>FFh = 100% on when used with 'h23[1:0] = 11b |

#### Note

Minimum on-time during PWM is limited to the on and off-time of the high side switch. This will make certain PWM values unusable like 00 0000 0001.

### 8.6.27 TIMER1\_CONFIG (Address = 25h) [reset = 00h]

TIMER1\_CONFIG is shown in [Figure 8-81](#) and described in [Table 8-37](#)

Return to [Summary Table](#).

Sets timer 1 period and on time. Careful selection is important as selecting a 200ms on width and a 10ms period is not possible.

**Figure 8-81. TIMER1\_CONFIG Register**

|                 |   |   |   |             |               |   |   |
|-----------------|---|---|---|-------------|---------------|---|---|
| 7               | 6 | 5 | 4 | 3           | 2             | 1 | 0 |
| TIMER1_ON_WIDTH |   |   |   | TIMER1_RSVD | TIMER1_PERIOD |   |   |

**Figure 8-81. TIMER1\_CONFIG Register (continued)**

|        |      |          |
|--------|------|----------|
| R/W-0h | R-0b | R/W-000b |
|--------|------|----------|

**Table 8-37. TIMER1\_CONFIG Register Field Descriptions**

| Bit | Field           | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
|-----|-----------------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-4 | TIMER1_ON_WIDTH | R/W  | 0b    | <p>Sets the high side switch on time (ms) for timer 1</p> <p>0000b = Off (HSS is high impedance)</p> <p>0001b = 0.1</p> <p>0010b = 0.3</p> <p>0011b = 0.5</p> <p>0100b = 1</p> <p>0101b = 10</p> <p>0110b = 20</p> <p>0111b = 30</p> <p>1000b = 40</p> <p>1001b = 50</p> <p>1010b = 60</p> <p>1011b = 80</p> <p>1100b = 100</p> <p>1101b = 150</p> <p>1110b = 200</p> <p>1111b = On (HSS is on 100%)</p> <div style="border: 1px solid black; padding: 5px; margin-top: 10px;"> <p style="text-align: center;"><b>Note</b></p> <p>NOTE: <math>t_{WK\_CYC}</math> which is set by <math>t_{WK\_CYC\_SET}</math> works with these times to determine if a state change has taken place on the WAKE pin. When <math>t_{WK\_CYC}</math> is set at 65 <math>\mu s</math> the 100 <math>\mu s</math> on width time cannot be used.</p> </div> |
| 3   | TIMER1_RSVD     | R    | 0b    | Reserved                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| 2-0 | TIMER1_PERIOD   | R/W  | 0b    | <p>Sets the timer period (ms) for timer 1</p> <p>000b = 10</p> <p>001b = 20</p> <p>010b = 50</p> <p>011b = 100</p> <p>100b = 200</p> <p>101b = 500</p> <p>110b = 1000</p> <p>111b = 2000</p>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |

#### 8.6.28 TIMER2\_CONFIG (Address = 26h) [reset = 00h]

TIMER2\_CONFIG is shown in [Figure 8-82](#) and described in [Table 8-38](#)

Return to [Summary Table](#).

Sets timer 2 period and on time. Careful selection is important as selecting a 200ms on width and a 10ms period is not possible.

**Figure 8-82. TIMER2\_CONFIG Register**

|                 |   |   |   |             |               |   |   |
|-----------------|---|---|---|-------------|---------------|---|---|
| 7               | 6 | 5 | 4 | 3           | 2             | 1 | 0 |
| TIMER2_ON_WIDTH |   |   |   | TIMER2_RSVD | TIMER2_PERIOD |   |   |
| R/W-0h          |   |   |   | R-0b        | R/W-000b      |   |   |

**Table 8-38. TIMER2\_CONFIG Register Field Descriptions**

| Bit | Field           | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
|-----|-----------------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-4 | TIMER2_ON_WIDTH | R/W  | 0b    | Sets the high side switch on time (ms) for timer 2<br>0000b = Off (HSS is high impedance)<br>0001b = 0.1<br>0010b = 0.3<br>0011b = 0.5<br>0100b = 1<br>0101b = 10<br>0110b = 20<br>0111b = 30<br>1000b = 40<br>1001b = 50<br>1010b = 60<br>1011b = 80<br>1100b = 100<br>1101b = 150<br>1110b = 200<br>1111b = On (HSS is on 100%)<br><br><div style="text-align: center;"> <b>Note</b><br/>           NOTE: <math>t_{WK\_CYC}</math> which is set by <math>t_{WK\_CYC\_SET}</math> works with these times to determine if a state change has taken place on the WAKE pin. When <math>t_{WK\_CYC}</math> is set at 65 <math>\mu s</math> the 100 <math>\mu s</math> on width time cannot be used.         </div> |
| 3   | TIMER2_RSVD     | R    | 0b    | Reserved                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| 2-0 | TIMER2_PERIOD   | R/W  | 0b    | Sets the timer period (ms) for timer 2<br>000b = 10<br>001b = 20<br>010b = 50<br>011b = 100<br>100b = 200<br>101b = 500<br>110b = 1000<br>111b = 2000                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |

**8.6.29 RSRT\_CNTR (Address = 28h) [reset = 40h]**

RSRT\_CNTR is shown in [Figure 8-83](#) and described in [Table 8-39](#)

Return to [Summary Table](#).

Restart mode counter set and counter. Determines the number of times the device has entered restart mode and when it will transition to sleep mode once programmed counter value has been reached. Counter should be reset often to avoid this transition.

**Figure 8-83. RSRT\_CNTR Register**

|               |   |   |   |           |   |   |   |
|---------------|---|---|---|-----------|---|---|---|
| 7             | 6 | 5 | 4 | 3         | 2 | 1 | 0 |
| RSRT_CNTR_SEL |   |   |   | RSRT_CNTR |   |   |   |
| R/W-4h        |   |   |   | R/W1C-0h  |   |   |   |

**Table 8-39. RSRT\_CNTR Register Field Descriptions**

| Bit | Field         | Type  | Reset | Description                                                                                                                                                      |
|-----|---------------|-------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-4 | RSRT_CNTR_SEL | R/W   | 4h    | Selects the number of times the device can enter restart mode prior to device entering sleep mode. Range is 0-15, representing entering restart mode 1-16 times. |
| 3-0 | RSRT_CNTR     | R/W1C | 0h    | Provides the number of times the device has entered restart mode and should be cleared prior to reaching the RSRT_CNTR_SEL value                                 |

### 8.6.30 nRST\_CNTL (Address = 29h) [reset = 00h]

nRST\_CNTL is shown in [Figure 8-84](#) and described in [Table 8-40](#)

Return to [Summary Table](#).

Configures nRST pin and FSO pin.

**Figure 8-84. nRST\_CNTL Register**

| 7     | 6 | 5                | 4           | 3          | 2 | 1 | 0    |
|-------|---|------------------|-------------|------------|---|---|------|
| RSVD  |   | nRST_PULSE_WIDTH | FSO_POL_SEL | FSO_SEL    |   |   | RSVD |
| R-00b |   | R/W-0b           | R/W-0b      | R/W/H-000b |   |   | R-0b |

**Table 8-40. nRST\_CNTL Register Field Descriptions**

| Bit | Field            | Type  | Reset | Description                                                                                                                                                                                                                                                                                                                                                                      |
|-----|------------------|-------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-6 | RSVD             | R     | 00b   | Reserved                                                                                                                                                                                                                                                                                                                                                                         |
| 5   | nRST_PULSE_WIDTH | R/W   | 0b    | Sets the pulse width for toggling nRST from high-->low-->high when device enters restart mode (ms)<br>0b = 2<br>1b = 15                                                                                                                                                                                                                                                          |
| 4   | FSO_POL_SEL      | R/W   | 0b    | Selects the polarity for the FSO pin<br>0b = Active low<br>1b = Active high<br><br><b>Note</b><br>Selects the output level when register 8'h29[3:1] = 110b making the pin a general-purpose output pin; 0 = Low and 1 = High                                                                                                                                                     |
| 3-1 | FSO_SEL          | R/W/H | 000b  | Selects the information that will cause this pin to be pulled to the state selected by 'h29[4]<br>000b = V <sub>CC</sub> Interrupt (overvoltage, undervoltage or short)<br>001b = WD interrupt event<br>010b = Reserved<br>011b = Local wake request (LWU)<br>100b = Bus wake request (WUP)<br>101b = Fail-safe mode entered<br>110b = General purpose output<br>111b = Reserved |
| 0   | RSVD             | R     | 0b    | Reserved                                                                                                                                                                                                                                                                                                                                                                         |

### 8.6.31 INT\_GLOBAL Register (Address = 50h) [reset = A0h]

INT\_GLOBAL is shown in [Figure 8-85](#) and described in [Table 8-41](#).

Return to [Summary Table](#).

Logical OR of all to certain interrupts.

**Figure 8-85. INT\_GLOBAL Register**

| 7         | 6     | 5     | 4     | 3     | 2     | 1    | 0    |
|-----------|-------|-------|-------|-------|-------|------|------|
| GLOBALERR | INT_1 | INT_2 | INT_3 | RSVD  | INT_4 | RSVD | RSVD |
| RH-1b     | RH-0b | RH-1b | RH-0b | RH-0b | RH-0b | R-0b | R-0b |

**Table 8-41. INT\_GLOBAL Register Field Descriptions**

| Bit | Field     | Type | Reset | Description                  |
|-----|-----------|------|-------|------------------------------|
| 7   | GLOBALERR | RH   | 1b    | Logical OR of all interrupts |
| 6   | INT_1     | RH   | 0b    | Logical OR of INT_1 register |
| 5   | INT_2     | RH   | 1b    | Logical OR of INT_2 register |

**Table 8-41. INT\_GLOBAL Register Field Descriptions (continued)**

| Bit | Field | Type | Reset | Description                  |
|-----|-------|------|-------|------------------------------|
| 4   | INT_3 | RH   | 0b    | Logical OR of INT_3 register |
| 3   | RSVD  | RH   | 0b    | Reserved                     |
| 2   | INT_4 | RH   | 0b    | Logical OR of INT_4 register |
| 1   | RSVD  | RH   | 0b    | Reserved                     |
| 0   | RSVD  | RH   | 0b    | Reserved                     |

**8.6.32 INT\_1 Register (Address = 51h) [reset = 0h]**

INT\_1 is shown in [Figure 8-86](#) and described in [Table 8-42](#).

Return to [Summary Table](#).

**Figure 8-86. INT\_1 Register**

| 7        | 6    | 5        | 4        | 3    | 2 | 1 | 0 |
|----------|------|----------|----------|------|---|---|---|
| WD       | RSVD | LWU      | WKERR    | RSVD |   |   |   |
| R/W1C-0b | R-0b | R/W1C-0b | R/W1C-0b | R-0b |   |   |   |

**Table 8-42. INT\_1 Register Field Descriptions**

| Bit | Field | Type  | Reset | Description                                                                                                                                        |
|-----|-------|-------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | WD    | R/W1C | 0b    | Watchdog event interrupt.<br>NOTE: This interrupt bit will be set for every watchdog error event and does not rely upon the Watchdog error counter |
| 6   | RSVD  | R     | 0b    | Reserved                                                                                                                                           |
| 5   | LWU   | R/W1C | 0b    | Local wake up                                                                                                                                      |
| 4   | WKERR | R/W1C | 0b    | Wake error bit is set when the SWE timer has expired and the state machine has returned to Sleep mode                                              |
| 3-0 | RSVD  | R     | 0b    | Reserved                                                                                                                                           |

**8.6.33 INT\_2 Register (Address = 52h) [reset = 40h]**

INT\_2 is shown in [Figure 8-87](#) and described in [Table 8-43](#).

Return to [Summary Table](#).

**Figure 8-87. INT\_2 Register**

| 7        | 6        | 5        | 4        | 3    | 2        | 1           | 0            |
|----------|----------|----------|----------|------|----------|-------------|--------------|
| SMS      | PWRON    | OVCC     | UVSUP    | RSVD | UVCC     | TSD_VCC_LIN | TSD_HSS_LIMP |
| R/W1C-0b | R/W1C-1b | R/W1C-0b | R/W1C-0b | R-0b | R/W1C-0b | R/W1C-0b    | R/W1C-0b     |

**Table 8-43. INT\_2 Register Field Descriptions**

| Bit | Field        | Type  | Reset | Description                                                             |
|-----|--------------|-------|-------|-------------------------------------------------------------------------|
| 7   | SMS          | R/W1C | 0b    | Sleep mode status flag. Only sets when sleep mode is entered by a fault |
| 6   | PWRON        | R/W1C | 1b    | Power on                                                                |
| 5   | OVCC         | R/W1C | 0b    | V <sub>CC</sub> overvoltage                                             |
| 4   | UVSUP        | R/W1C | 0b    | V <sub>SUP</sub> undervoltage                                           |
| 3   | RSVD         | R     | 0b    | Reserved                                                                |
| 2   | UVCC         | R/W1C | 0b    | V <sub>CC</sub> undervoltage                                            |
| 1   | TSD_VCC_LIN  | R/W1C | 0b    | Thermal Shutdown due to VCC or LIN                                      |
| 0   | TSD_HSS_LIMP | R/W1C | 0b    | Thermal Shutdown due to HSS or LIMP                                     |

### 8.6.34 INT\_3 Register (Address 53h) [reset = 0h]

INT\_3 is shown in [Figure 8-88](#) and described in [Table 8-44](#).

Return to [Summary Table](#).

**Figure 8-88. INT\_3 Register**

| 7        | 6    | 5        | 4          | 3          | 2          | 1    | 0 |
|----------|------|----------|------------|------------|------------|------|---|
| SPIERR   | RSVD | FSM      | CRCERR     | VCCSC      | RSRT_CNT   | RSVD |   |
| R/W1C-0b | R-0b | R/W1C-0b | R/W1C/U-0b | R/W1C/U-0b | R/W1C/U-0b | R-0b |   |

**Table 8-44. INT\_3 Register Field Descriptions**

| Bit | Field    | Type    | Reset | Description0b                                                  |
|-----|----------|---------|-------|----------------------------------------------------------------|
| 7   | SPIERR   | R/W1C   | 0b    | Sets when SPI status bit sets                                  |
| 6   | RSVD     | R       | 0b    | Reserved                                                       |
| 5   | FSM      | R/W1C   | 0b    | Entered fail-safe mode. Can be cleared while in failsafe mode. |
| 4   | CRCERR   | R/W1C/U | 0b    | SPI CRC error detected                                         |
| 3   | VCCSC    | R/W1C/U | 0b    | V <sub>CC</sub> short detected                                 |
| 2   | RSRT_CNT | R/W1C/U | 0b    | Restart counter exceeded programmed count                      |
| 1-0 | RSVD     | R       | 0b    | Reserved                                                       |

### 8.6.35 INT\_EN\_1 Register (Address = 56h) [reset = B0h]

INT\_EN\_1 is shown in [Figure 8-89](#) and described in [Table 8-45](#).

Return to [Summary Table](#).

Interrupt mask for INT\_1.

**Figure 8-89. INT\_EN\_1 Register**

| 7      | 6    | 5      | 4        | 3       | 2 | 1 | 0 |
|--------|------|--------|----------|---------|---|---|---|
| WD_EN  | RSVD | LWU_EN | WKERR_EN | RSVD    |   |   |   |
| R/W-1b | R-0b | R/W-1b | R/W-1b   | R-0000b |   |   |   |

**Table 8-45. INT\_EN\_1 Register Field Descriptions**

| Bit | Field    | Type | Reset | Description                     |
|-----|----------|------|-------|---------------------------------|
| 7   | WD_EN    | R/W  | 1b    | Watchdog event interrupt enable |
| 6   | RSVD     | R/W  | 0b    | Reserved                        |
| 5   | LWU_EN   | R/W  | 1b    | Local wake up enable            |
| 4   | WKERR_EN | R/W  | 1b    | Wake error enable               |
| 3-0 | RSVD     | R    | 0000b | Reserved                        |

### 8.6.36 INT\_EN\_2 Register (Address = 57h) [reset = 37h]

INT\_EN\_2 is shown in [Figure 8-90](#) and described in [Table 8-46](#).

Return to [Summary Table](#).

Interrupt mask for INT\_2.

**Figure 8-90. INT\_EN\_2 Register**

| 7    | 6 | 5       | 4        | 3    | 2       | 1              | 0                |
|------|---|---------|----------|------|---------|----------------|------------------|
| RSVD |   | OVCC_EN | UVSUP_EN | RSVD | UVCC_EN | TSD_VCC_LIN_EN | TSD_HSS_LMI_P_EN |
| R-0b |   | R/W-1b  | R/W-1b   | R-0b | R/W-1b  | R/W-1b         | R/W-1b           |

**Table 8-46. INT\_EN\_2 Register Field Descriptions**

| Bit | Field           | Type | Reset | Description                                |
|-----|-----------------|------|-------|--------------------------------------------|
| 7-6 | RSVD            | R    | 0b    | Reserved                                   |
| 5   | OVCC_EN         | R/W  | 1b    | V <sub>CC</sub> over voltage enable        |
| 4   | UVSUP_EN        | R/W  | 1b    | V <sub>SUP</sub> undervoltage enable       |
| 3   | RSVD            | R    | 0b    | Reserved                                   |
| 2   | UVCC_EN         | R/W  | 1b    | V <sub>CC</sub> undervoltage enable        |
| 1   | TSD_VCC_LIN_EN  | R/W  | 1b    | Thermal shutdown enable for VCC and LIN    |
| 0   | TSD_HSS_LIMP_EN | R/W  | 1b    | Thermal shutdown due to HSS or LIMP enable |

**8.6.37 INT\_EN\_3 Register (Address = 58h) [reset = BCh]**

INT\_EN\_3 is shown in [Figure 8-91](#) and described in [Table 8-47](#).

Return to [Summary Table](#).

Interrupt mask for INT\_3.

**Figure 8-91. INT\_EN\_3 Register**

| 7         | 6    | 5      | 4         | 3        | 2           | 1    | 0 |
|-----------|------|--------|-----------|----------|-------------|------|---|
| SPIERR_EN | RSVD | FSM_EN | CRCERR_EN | VCCSC_EN | RSRT_CNT_EN | RSVD |   |
| R/W-1b    | R-0b | R/W-1b | R/W-1b    | R/W-1b   | R/W-1b      | R-0b |   |

**Table 8-47. INT\_EN\_3 Register Field Descriptions**

| Bit | Field       | Type | Reset | Description                                           |
|-----|-------------|------|-------|-------------------------------------------------------|
| 7   | SPIERR_EN   | R/W  | 1b    | SPI error interrupt enable                            |
| 6   | RSVD        | R    | 0b    | Reserved                                              |
| 5   | FSM_EN      | R/W  | 1b    | Fail-safe mode interrupt enable                       |
| 4   | CRCERR_EN   | R/W  | 1b    | SPI CRC error interrupt enable                        |
| 3   | VCCSC_EN    | R/W  | 1b    | VCC short circuit interrupt enable                    |
| 2   | RSRT_CNT_EN | R/W  | 1b    | Exceeding programmed restart counter interrupt enable |
| 1-0 | RSVD        | R    | 0b    | Reserved                                              |

**8.6.38 INT\_4 Register (Address = 5Ah) [reset = 0h]**

INT\_4 is shown in [Figure 8-92](#) and described in [Table 8-48](#).

Return to [Summary Table](#).

Interrupt for LIN and high side switch.

**Figure 8-92. INT\_4 Register**

| 7        | 6        | 5     | 4 | 3        | 2        | 1     | 0 |
|----------|----------|-------|---|----------|----------|-------|---|
| LIN_WUP  | LIN_DTO  | RSVD  |   | HSSOC    | HSSOL    | RSVD  |   |
| R/W1C-0b | R/W1C-0b | R-00b |   | R/W1C-0b | R/W1C-0b | R-00b |   |

**Table 8-48. INT\_4 Register Field Descriptions**

| Bit | Field   | Type  | Reset | Description                   |
|-----|---------|-------|-------|-------------------------------|
| 7   | LIN_WUP | R/W1C | 0b    | LIN bus wake                  |
| 6   | LIN_DTO | R/W1C | 0b    | LIN dominant state timeout    |
| 5-4 | RSVD    | R     | 00b   | Reserved                      |
| 3   | HSSOC   | R/W1C | 0b    | High side switch over current |
| 2   | HSSOL   | R/W1C | 0b    | High side switch open load    |

**Table 8-48. INT\_4 Register Field Descriptions (continued)**

| Bit | Field | Type | Reset | Description |
|-----|-------|------|-------|-------------|
| 1-0 | RSVD  | R    | 00b   | Reserved    |

### 8.6.39 INT\_EN\_4 Register (Address = 5Eh) [reset = CCh]

INT\_EN\_4 is shown in [Figure 8-93](#) and described in [Table 8-49](#).

Return to [Summary Table](#).

Interrupt mask for INT\_4.

**Figure 8-93. INT\_EN\_4 Register**

| 7          | 6          | 5     | 4 | 3        | 2        | 1     | 0 |
|------------|------------|-------|---|----------|----------|-------|---|
| LIN_WUP_EN | LIN_DTO_EN | RSVD  |   | HSSOC_EN | HSSOL_EN | RSVD  |   |
| R/W-1b     | R/W-1b     | R-00b |   | R/W-1b   | R/W-1b   | R-00b |   |

**Table 8-49. INT\_EN\_4 Register Field Descriptions**

| Bit | Field      | Type | Reset | Description                                    |
|-----|------------|------|-------|------------------------------------------------|
| 7   | LIN_WUP_EN | R/W  | 1b    | LIN bus wake interrupt enable                  |
| 6   | LIN_DTO_EN | R/W  | 1b    | LIN dominant state timeout interrupt enable    |
| 5-4 | RSVD       | R    | 00b   | Reserved                                       |
| 3   | HSSOC_EN   | R/W  | 1b    | High side switch over current interrupt enable |
| 2   | HSSOL_EN   | R/W  | 1b    | High side switch open load interrupt enable    |
| 1-0 | RSVD       | R    | 00b   | Reserved                                       |

### 8.6.40 Reserved Registers

All other registers not provided up to 'h7F are reserved.

## 9 Application and Implementation

### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

The TLIN1431x-Q1 can be used in both responder node and commander node applications in a LIN network. The device comes with the ability to support remote wake up request and local wake up request. It can provide the power to the local processor as well as providing watchdog supervision for the processor.

#### 9.1.1 Device Brownout Information

During a brownout condition where  $V_{SUP}$  stays above  $V_{nPORF}$ , the device pin and mode behavior is as per Figure 9-1. When  $V_{SUP}$  falls below  $V_{nPORF}$ , the device enters power-on reset as per Figure 9-2

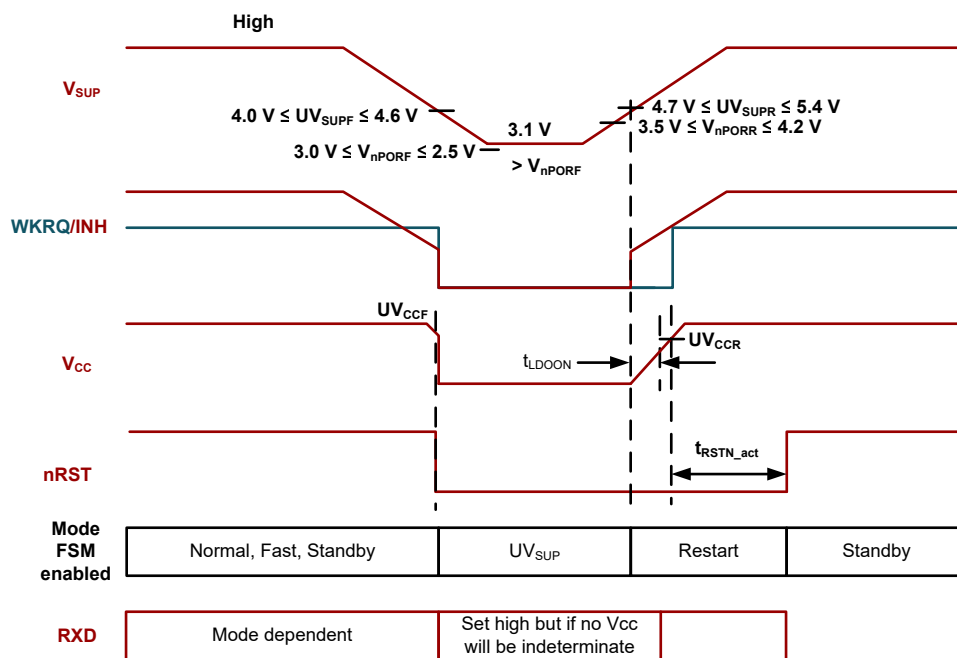
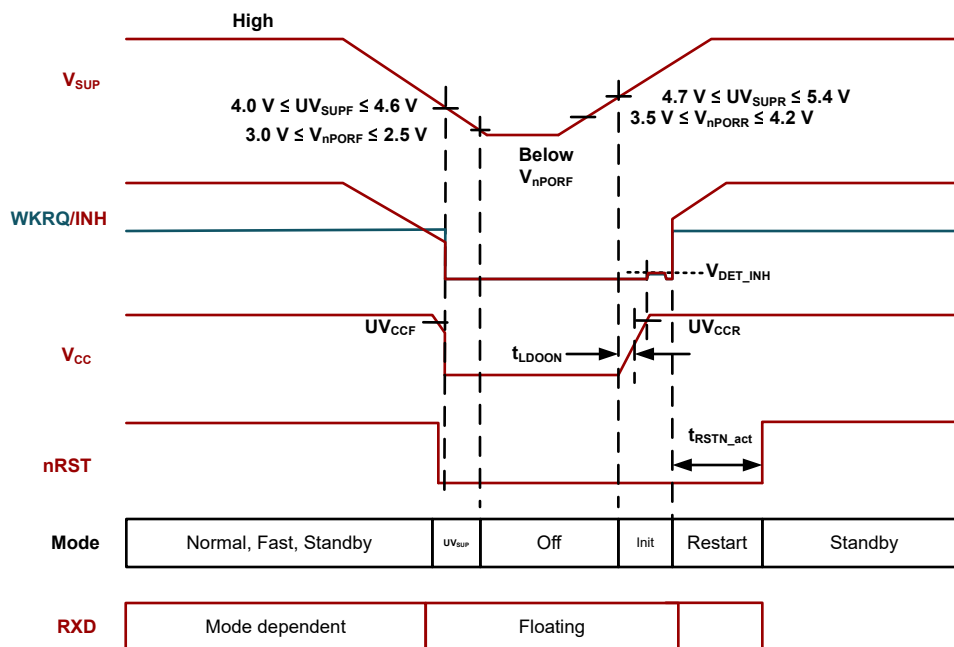


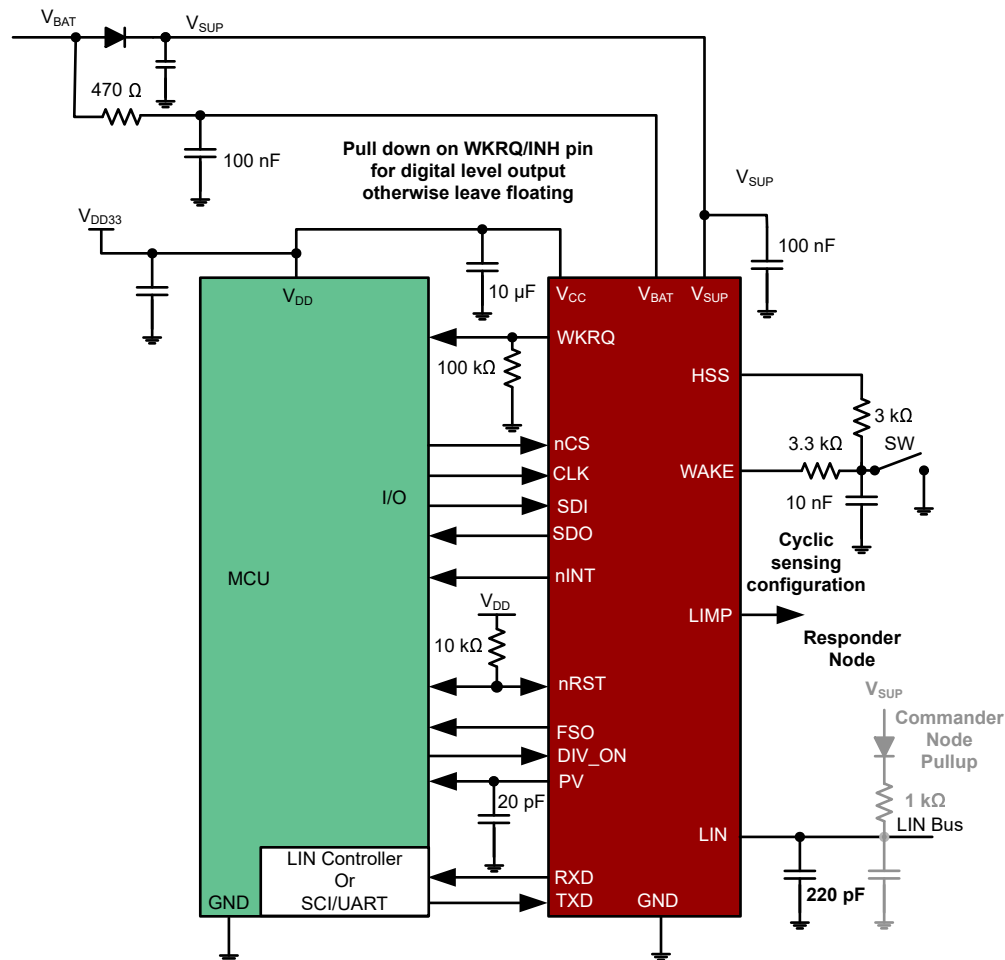
Figure 9-1. Brownout Above  $V_{nPORF}$



**Figure 9-2. Brownout Below  $V_{nPORF}$**

## 9.2 Typical Application

The device comes with an integrated 45 k $\Omega$  pull-up resistor and series diode for responder node applications. For commander node applications, an external 1 k $\Omega$  pull-up resistor with series blocking diode can be used. [Figure 9-3](#) shows the device in SPI control mode in a responder node application. [Figure 9-4](#) shows the device in pin control mode for a responder node application.



### Figure 9-3. Typical LIN Responder Node in SPI Control Mode

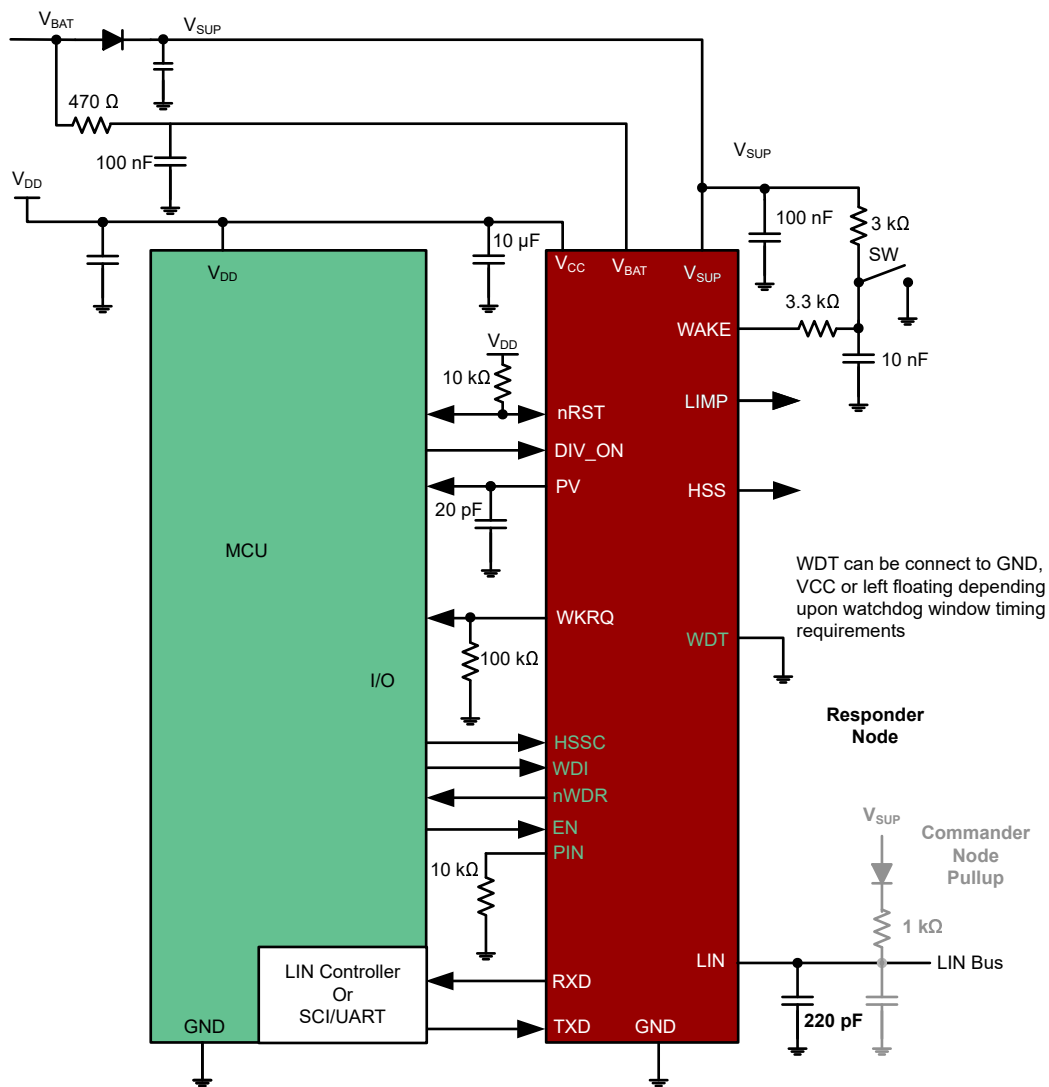


Figure 9-4. Typical LIN Responder Node in Pin Control Mode

## 9.2.1 Design Requirements

### 9.2.1.1 Normal Mode Application Note

When using the TLIN1431x-Q1 in systems which are monitoring the RXD pin for a wake-up request, special care should be taken during the mode transitions. The output of the RXD pin is indeterminate for the transition period between states as the receivers are switched. The application software should not look for an edge on the RXD pin indicating a wake-up request until  $t_{\text{MODE\_CHANGE}}$ . This is shown in [Figure 7-5](#). When transitioning to normal mode, there is an initialization period shown as  $t_{\text{NOMINIT}}$ .

### 9.2.1.2 Standby Mode Application Note

If the TLIN1431x-Q1 detects an under-voltage on  $V_{\text{SUP}}$ , the RXD pin transitions low, and signals to the software that the device is in standby mode and should be returned to sleep mode for the lowest power state.

### 9.2.1.3 TXD Dominant State Timeout Application Note

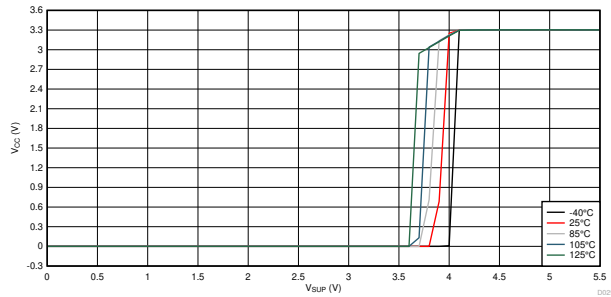
The minimum dominant TXD time allowed by the minimum  $t_{\text{TXD\_DTO}}$  limits the minimum possible data rate of the device. The LIN protocol has different constraints for commander and responder node applications. Thus, there are different maximum consecutive dominant bits for each application case and thus different minimum data rates.

## 9.2.2 Detailed Design Procedures

Commander node applications require an external 1 k $\Omega$  pull-up resistor and serial diode.

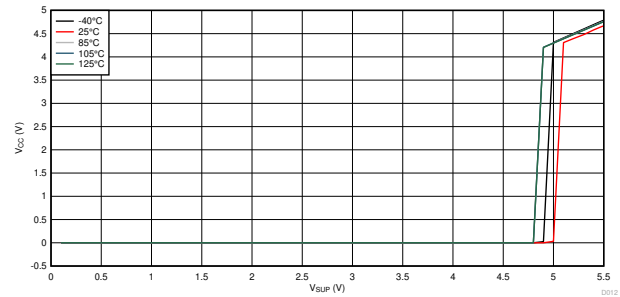
### 9.2.3 Application Curves

The characteristic curves show the LDO performance between 0 V and 5.5 V when ramping up and ramping down.



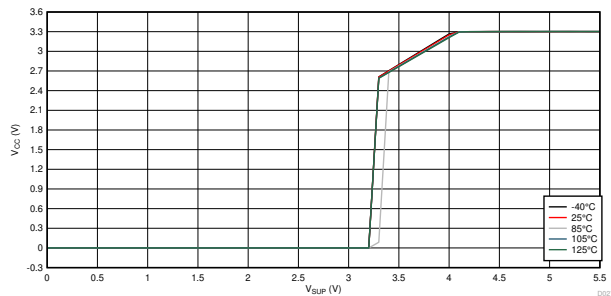
$V_{CC} = 3.3 \text{ V}$   $I_{CC} \text{ Load} = 125 \text{ mA}$  Ramp Up

**Figure 9-5.  $V_{CC}$  vs  $V_{SUP}$  Across Temperature**



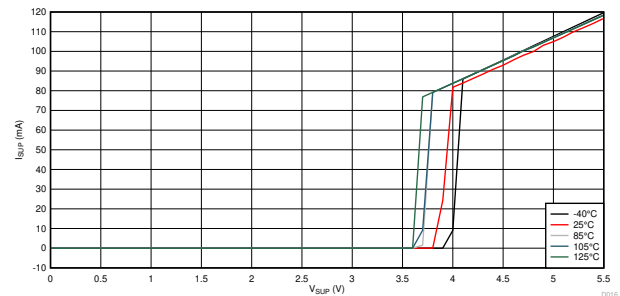
$V_{CC} = 5 \text{ V}$   $I_{CC} \text{ Load} = 125 \text{ mA}$  Ramp Down

**Figure 9-6.  $V_{CC}$  vs  $V_{SUP}$  Across Temperature**



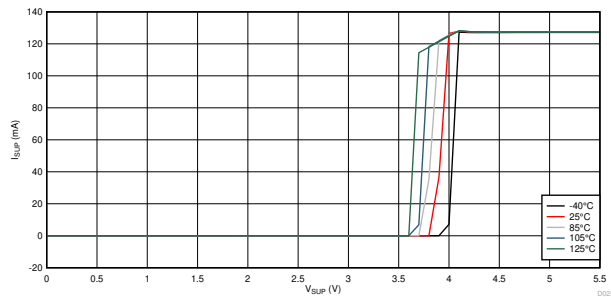
$V_{CC} = 3.3 \text{ V}$   $I_{CC} \text{ Load} = 125 \text{ mA}$  Ramp Down

**Figure 9-7.  $V_{CC}$  vs  $V_{SUP}$  Across Temperature**



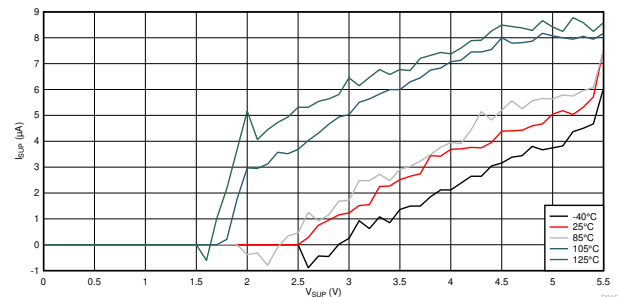
$V_{CC} = 5 \text{ V}$   $I_{CC} \text{ Load} = 125 \text{ mA}$  Ramp Up

**Figure 9-8.  $I_{SUP}$  vs  $V_{SUP}$  Across Temperature**



$V_{CC} = 3.3 \text{ V}$   $I_{CC} \text{ Load} = 125 \text{ mA}$  Ramp Up

**Figure 9-9.  $I_{SUP}$  vs  $V_{SUP}$  Across Temperature**



$V_{CC} = 5 \text{ V}$  Sleep Mode Ramp Down

**Figure 9-10.  $I_{SUP}$  vs  $V_{SUP}$  Across Temperature**

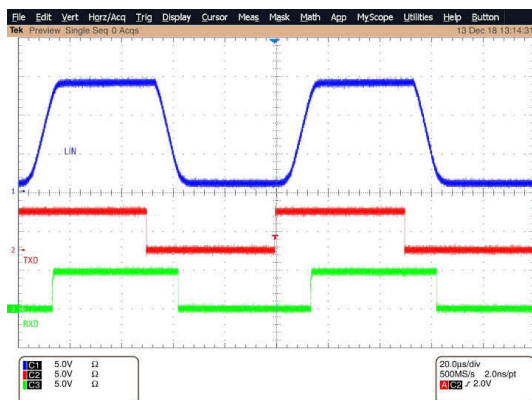


Figure 9-11. LIN Bus Performance



Figure 9-12. Recessive to Dominant Propagation Delay

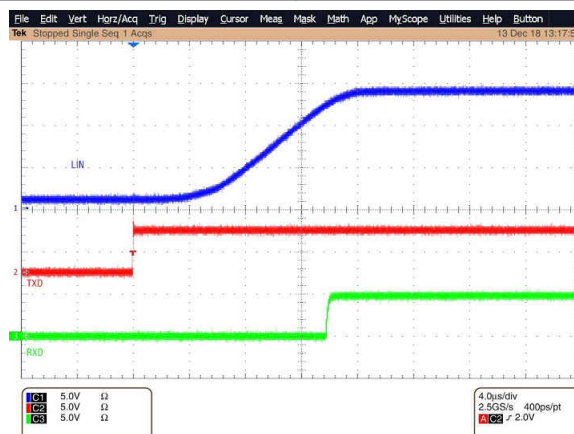


Figure 9-13. Dominant to Recessive Propagation Delay

### 9.3 Power Supply Recommendations

The TLIN1431x-Q1 was designed to operate directly off a car battery, or any other DC supply ranging from 5.5 V to 28 V. A 100 nF decoupling capacitor should be placed as close to the  $V_{SUP}$  pin of the device as possible.

## 9.4 Layout

PCB design should start with design of the protection and filtering circuitry because ESD and EFT have a wide frequency bandwidth from approximately 3 MHz to 3 GHz. High frequency layout techniques must be applied during PCB design. Placement at the connector also prevents these noisy events from propagating further into the PCB and system.

### 9.4.1 Layout Guidelines

The layout example and information below are for a responder node with the following configuration: See [Figure 9-14](#).

- Responder node
- SPI control
- WKRQ
- WAKE and High-side switch configured for cyclic sensing

The following are the layout guidelines based upon the provided configuration:

- **Pin 1 (V<sub>sup</sub>):** This is the supply pin for the device. A 100 nF decoupling capacitor (C1) should be placed as close to the device as possible. Other bulk decoupling capacitance should be considered.
- **Pin 2 (V<sub>cc</sub>):** Output source, either 3.3 V or 5 V depending upon the version of the device and has a 10  $\mu$ F decoupling capacitor (C2) to ground as close to the device as possible. This pin is connected to external circuitry for a limp home mode if the watchdog has timed out causing a reset
- **Pin 3 (nRST):** This pin connects to the processors and functions in one of two manners; as a reset pin for the TLIN1431x-Q1 or an indicator to the processor of an under-voltage and watchdog failure event. The pin has a 10 k $\Omega$  resistor (R1) pulled up to the processor I/O voltage rail.
- **Pin 4 (WDT/CLK):** In SPI control mode, this pin (CLK) is connected directly to the processor as the SPI CLK input to the TLIN1431x-Q1.
- **Pin 5 (nWDR/SDO):** In SPI control mode, this pin (SDO) is connected directly to the processor as the SPI serial data output from the TLIN1431x-Q1.
- **Pin 6 (WDI/SDI):** In SPI control mode, this pin (SDI) is connected directly to the processor as the SPI serial data input into the TLIN1431x-Q1.
- **Pin 7 (PIN/nCS):** For SPI control mode, this pin (nCS) should be connected directly to the processor as the SPI chip select to the TLIN1431x-Q1.
- **Pin 8 (EN/nINT):** In SPI control mode, this pin becomes an output interrupt pin that is provided to the processor.
- **Pin 9 (HSSC/FSO):** In SPI control mode, this pin (FSO) is connected directly to the processor, external transceiver or general purpose SBC as a selectable interrupt or control pin.
- **Pin 10 (PV):** This pin is connected directly to a processor ADC and has a 20 pF capacitor (C3) to GND.
- **Pin 11 (DIV\_ON):** The pin is connected to a processor which controls when the V<sub>BAT</sub> monitoring in the TLIN1431x-Q1 is enabled.
- **Pin 12 (TXD):** The TXD pin is the LIN transceiver input from the processors. A series resistor can be placed to limit the input current to the device in the event of an over-voltage on this pin. A capacitor to ground can be placed close to the input pin of the device to filter noise. These are system level dependent and not covered here as usually not needed.
- **Pin 13 (RXD):** The RXD is the LIN transceiver receive output to the processor. The pin is a push-pull output and can be connected directly to the processor without external pull-ups.
- **Pin 14 (GND):** This is the ground connection for the device. This pin should be tied to the ground plane through a short trace with the use of two vias to limit total return inductance.
- **Pin 15 (LIN):** This pin connects to the LIN bus. For responder nodes, a 220 pF capacitor (C4) to ground is implemented. For commander nodes, an additional series resistor and blocking diode should be placed between the LIN pin and the V<sub>sup</sub> pin.
- **Pin 16 (WKRQ/INH):** This pin can be the high-voltage inhibit output pin or the digital wake output pin. The example shows the pin configured as WKRQ which requires a 100 k $\Omega$  resistor (R2) to ground at power up.
- **Pin 17 (WAKE):** This pin connects to V<sub>sup</sub> through a resistor divider (R3 and R4) with the center tap connected to a switch to ground or V<sub>sup</sub> and is used as the local wake up pin. A 10 nF capacitor (C5) to

ground should be placed at this center tap as shown in the application drawings. In the layout example, the pin is configured to work with the HSS pin using the cyclic sensing wake capability of the device.

- **Pin 18 (HSS):** This pin is the high-side switch output
- **Pin 19 (LIMP):** This pin as a high-side switch that is used for a limp home function that provides  $V_{SUP}$  to an external circuit which is not shown.
- **Pin 20 (VBAT):** This pin is used for battery monitoring is comes from the battery prior to the blocking diode. It has a 470  $\Omega$  resistor (R5) in series and a 100 nF capacitor (C6) to GND.

#### Note

All ground and power connections should be made as short as possible and use at least two vias to minimize the total loop inductance.

### 9.4.2 Layout Example

This is a layout example for the TLIN1431x-Q1 configured for SPI control supporting following:

- Cyclic Sensing using the WAKE pin and HSS pin
- Digital wake output, WKRQ pin.

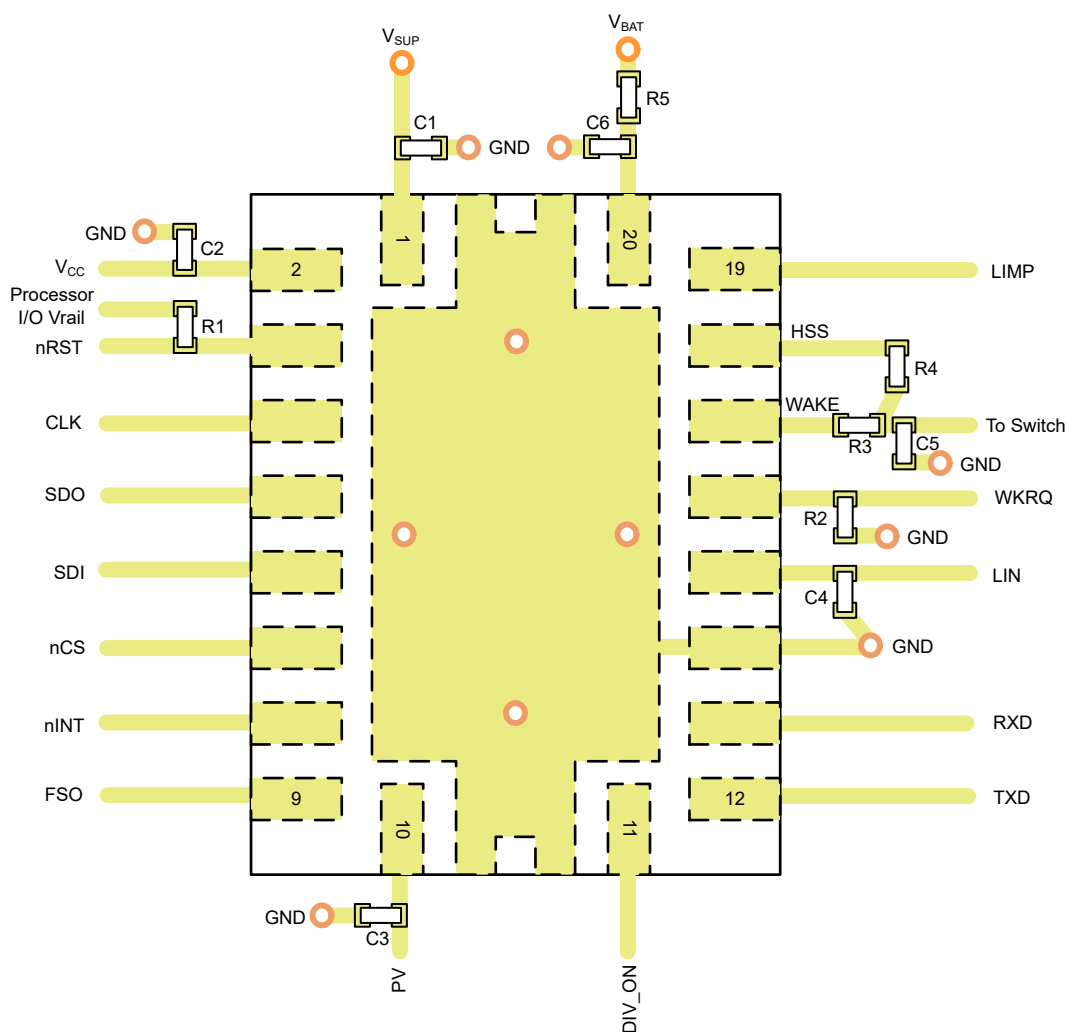


Figure 9-14. Layout Example

## 10 Device and Documentation Support

### 10.1 Documentation Support

#### 10.1.1 Related Documentation

For related documentation see the following:

- LIN Standards:
  - ISO 17987-1: Road vehicles -- Local Interconnect Network (LIN) -- Part 1: General information and use case definition
  - ISO 17987-4:2016: Road vehicles -- Local Interconnect Network (LIN) -- Part 4: Electrical Physical Layer (EPL) specification 12V/24V
  - SAEJ2602-1:2021: LIN Network for Vehicle Applications
  - LIN2.0, LIN2.1, LIN2.2 and LIN2.2A specification
- EMC requirements:
  - SAE J2962-2:
  - HW Requirements for CAN, LIN, FR V1.3: German OEM requirements for LIN
  - ISO 10605: Road vehicles - Test methods for electrical disturbances from electrostatic discharge
  - ISO 11452-4:2011: Road vehicles - Component test methods for electrical disturbances from narrowband radiated electromagnetic energy - Part 4: Harness excitation methods
  - ISO 7637-1:2015: Road vehicles - Electrical disturbances from conduction and coupling - Part 1: Definitions and general considerations
  - ISO 7637-3: Road vehicles - Electrical disturbances from conduction and coupling - Part 3: Electrical transient transmission by capacitive and inductive coupling via lines other than supply lines
  - IEC 62132-4:2006: Integrated circuits - Measurement of electromagnetic immunity 150 kHz to 1 GHz - Part 4: Direct RF power injection method
  - IEC 61000-4-2
  - IEC 61967-4
  - CISPR25
- Conformance Test requirements:
  - ISO 17987-7: Road vehicles -- Local Interconnect Network (LIN) -- Part 7: Electrical Physical Layer (EPL) conformance test specification
  - SAE J2602-2:2021: LIN Network for Vehicle Applications Conformance Test

Application Notes:

[TLINx441 LDO Performance, SLLA427](#)

### 10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](#). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 10.3 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 10.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

## 10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 10.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| TLIN14313RGYRQ1  | ACTIVE        | VQFN         | RGY                | 20   | 3000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | TL313                   | <a href="#">Samples</a> |
| TLIN14315RGYRQ1  | ACTIVE        | VQFN         | RGY                | 20   | 3000           | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | TL315                   | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

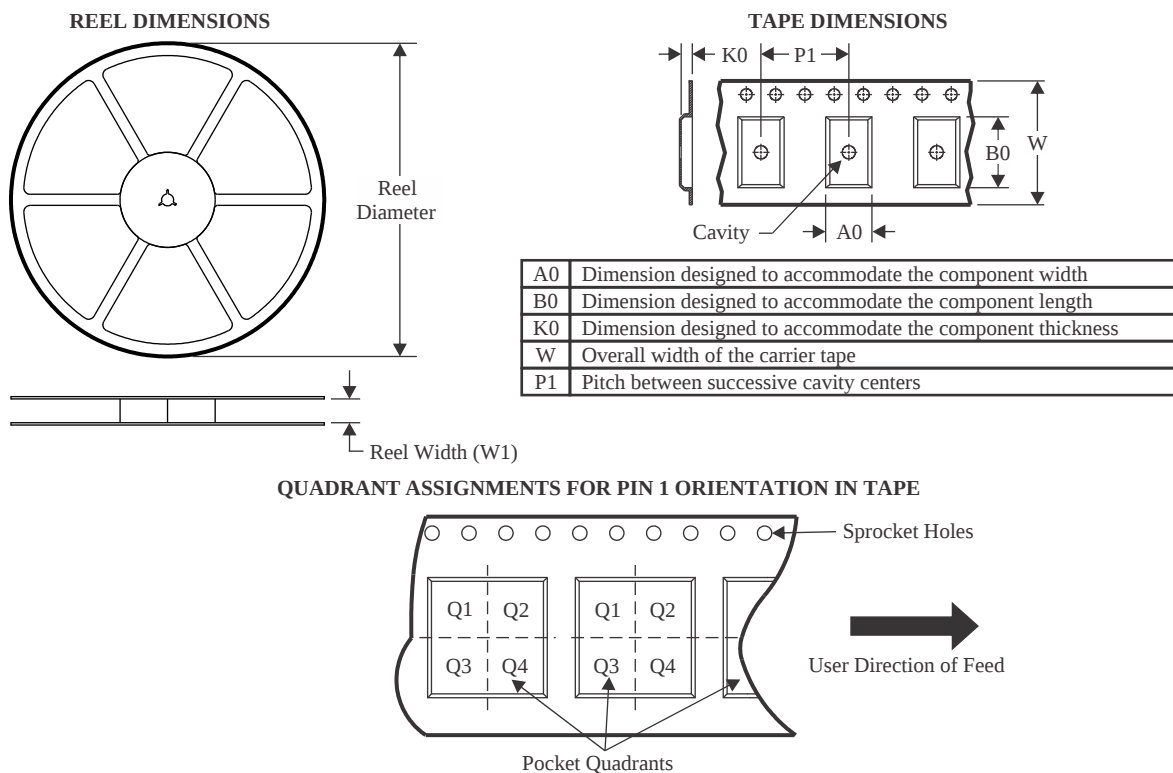
(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



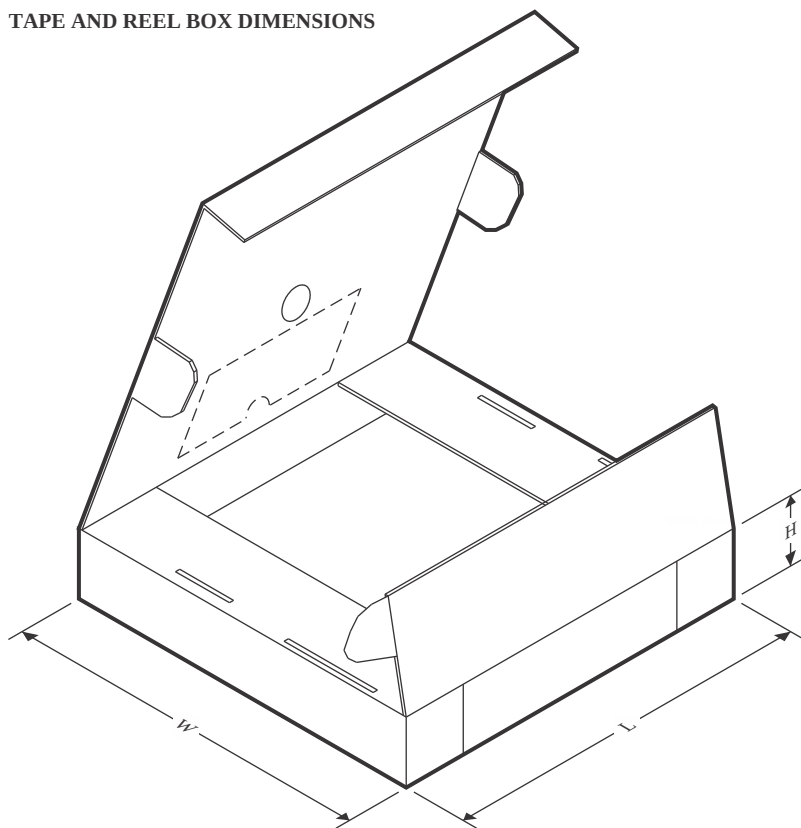
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device          | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TLIN14313RGYRQ1 | VQFN         | RGY             | 20   | 3000 | 330.0              | 12.4               | 3.71    | 4.71    | 1.1     | 8.0     | 12.0   | Q1            |
| TLIN14315RGYRQ1 | VQFN         | RGY             | 20   | 3000 | 330.0              | 12.4               | 3.71    | 4.71    | 1.1     | 8.0     | 12.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device          | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TLIN14313RGYRQ1 | VQFN         | RGY             | 20   | 3000 | 367.0       | 367.0      | 35.0        |
| TLIN14315RGYRQ1 | VQFN         | RGY             | 20   | 3000 | 367.0       | 367.0      | 35.0        |

## GENERIC PACKAGE VIEW

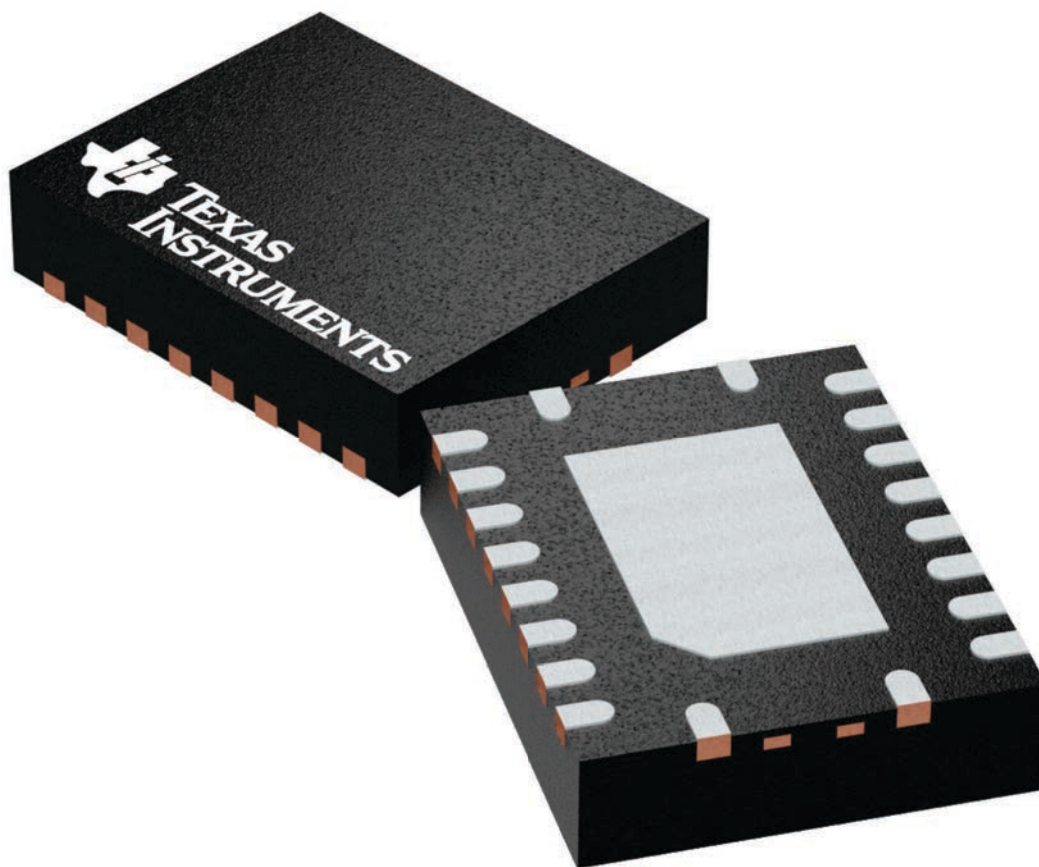
**RGY 20**

**VQFN - 1 mm max height**

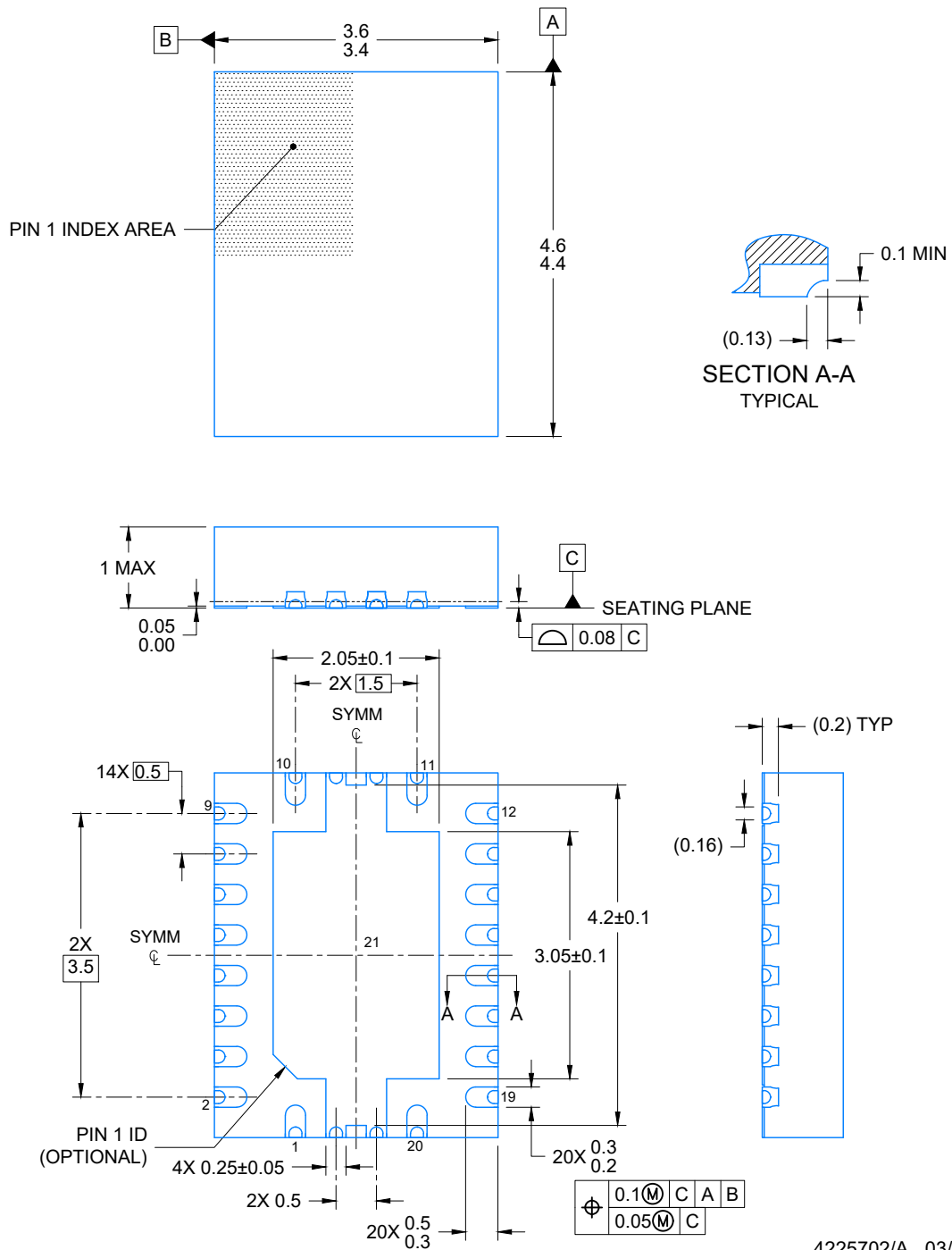
3.5 x 4.5, 0.5 mm pitch

PLASTIC QUAD FGLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



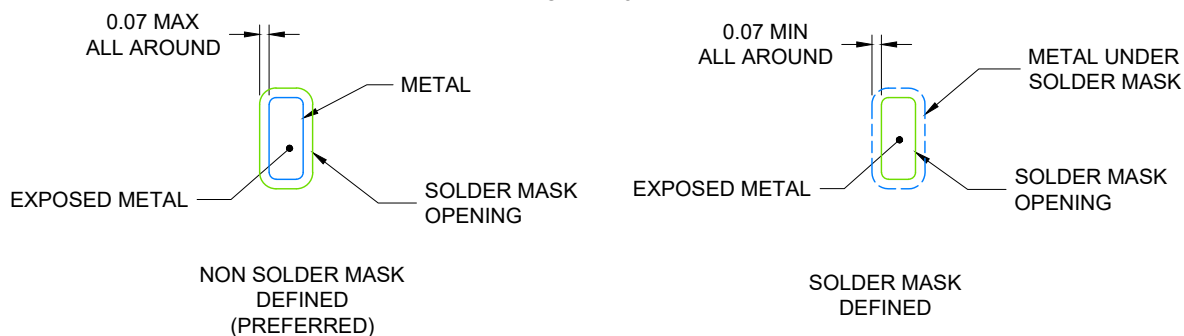
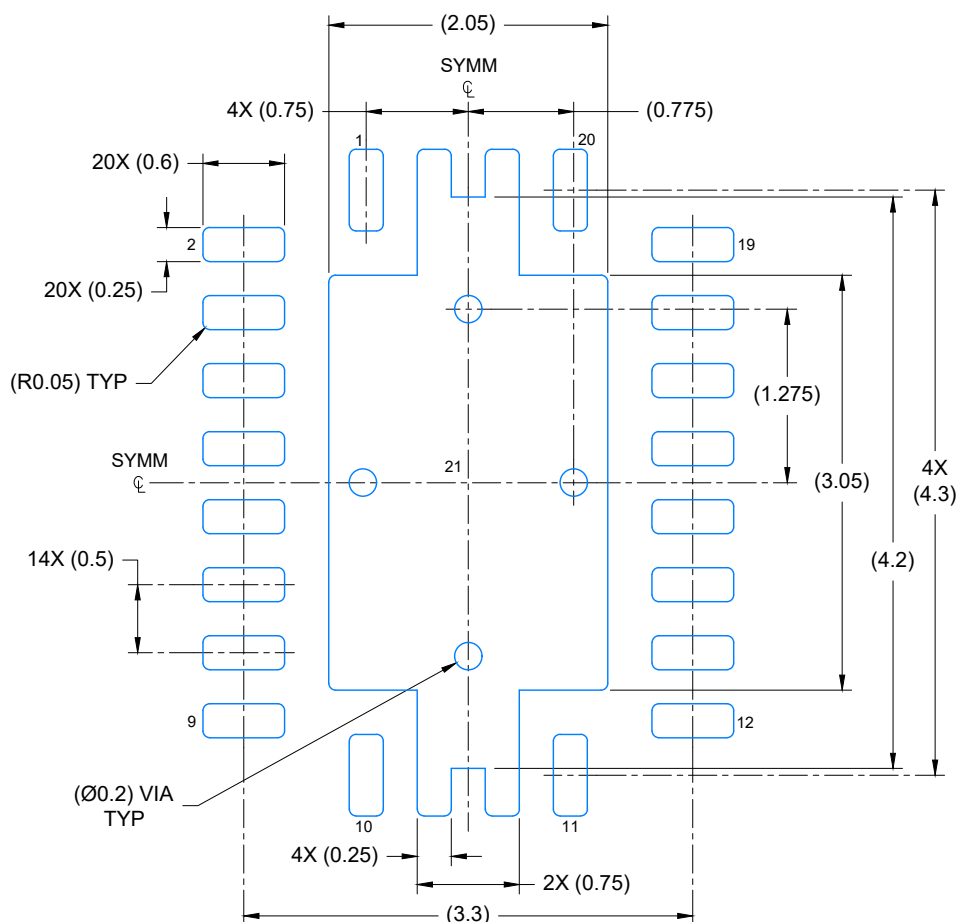
4225264/A



4225702/A 03/2020

## NOTES:

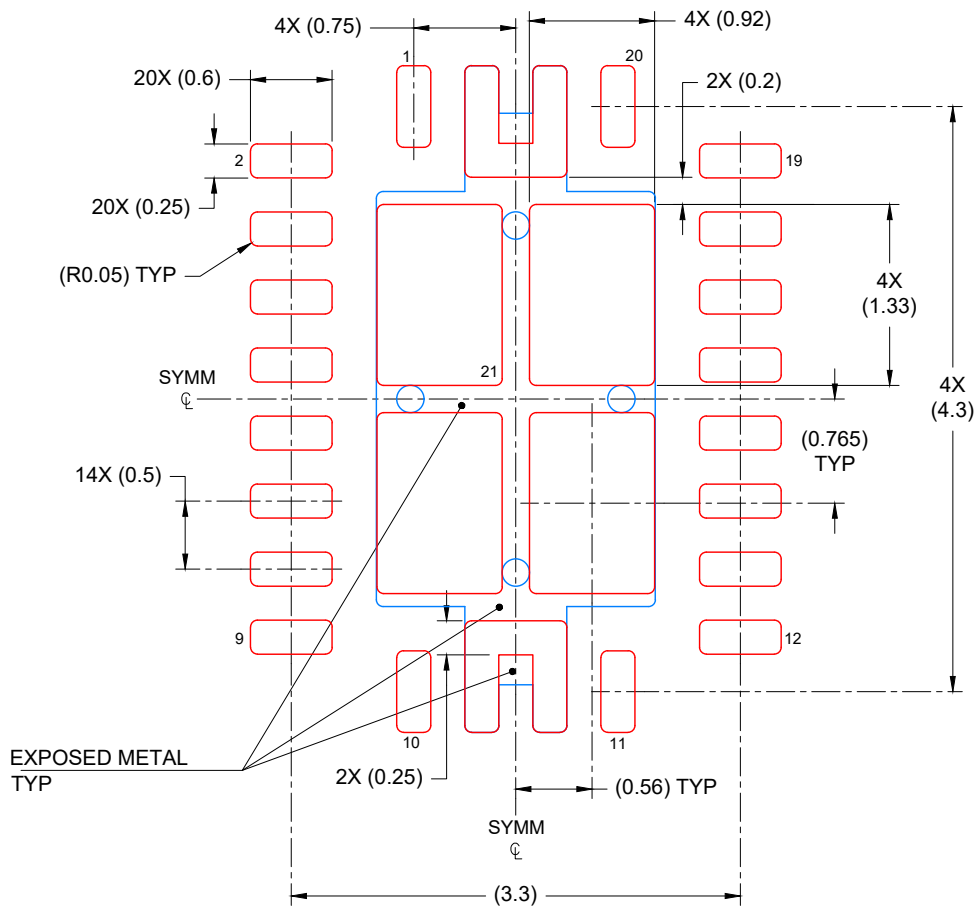
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



4225702/A 03/2020

## NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slue271](http://www.ti.com/lit/slue271)).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE  
 BASED ON 0.125mm THICK STENCIL

EXPOSED PAD 21  
 78% PRINTED COVERAGE BY AREA  
 SCALE: 18X

4225702/A 03/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#) or other applicable terms available either on [ti.com](#) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265  
Copyright © 2023, Texas Instruments Incorporated